



MEASUREMENT REPORT

FCC Part 22, 24, & 27 LTE

Applicant Name:

Samsung Electronics Co., Ltd.
129, Samsung-ro,
Yeongtong-gu, Suwon-si
Gyeonggi-do, 16677, Korea

Date of Testing:

2/15 - 2/26/2016

Test Site/Location:

PCTEST Lab., Columbia, MD, USA

Test Report Serial No.:

0Y1602150336.A3L

FCC ID :

A3LSMJ120P

APPLICANT:

SAMSUNG ELECTRONICS CO., LTD.

Application Type:

Certification

FCC Classification:

PCS Licensed Transmitter Held to Ear (PCE)

FCC Rule Part(s):

§2; §22; §24; §27

Test Procedure(s):

ANSI/TIA-603-C-2004, KDB 971168 D01 v02r02

EUT Type:

Portable Handset

Model(s):

SM-J120P

Test Device Serial No.:

identical prototype [S/N: 03820]

Mode	Tx Frequency (MHz)	Emission Designator	Modulation	ERP/EIRP	
				Max. Power (W)	Max. Power (dBm)
LTE Band 26	824.7 - 848.3	1M12G7D	QPSK	0.310	24.91
LTE Band 26	824.7 - 848.3	1M13W7D	16QAM	0.239	23.79
LTE Band 26	825.5 - 847.5	2M72G7D	QPSK	0.324	25.11
LTE Band 26	825.5 - 847.5	2M71W7D	16QAM	0.272	24.34
LTE Band 26	826.5 - 846.5	4M51G7D	QPSK	0.336	25.27
LTE Band 26	826.5 - 846.5	4M50W7D	16QAM	0.285	24.55
LTE Band 26	829 - 844	9M01G7D	QPSK	0.333	25.23
LTE Band 26	829 - 844	8M98W7D	16QAM	0.272	24.35
LTE Band 26	831.5 - 841.5	13M4G7D	QPSK	0.300	24.77
LTE Band 26	831.5 - 841.5	13M4W7D	16QAM	0.245	23.90
LTE Band 25	1850.7 - 1914.3	1M12G7D	QPSK	0.206	23.14
LTE Band 25	1850.7 - 1914.3	1M12W7D	16QAM	0.174	22.40
LTE Band 25	1851.5 - 1913.5	2M72G7D	QPSK	0.196	22.93
LTE Band 25	1851.5 - 1913.5	2M71W7D	16QAM	0.165	22.18
LTE Band 25	1852.5 - 1912.5	4M51G7D	QPSK	0.234	23.70
LTE Band 25	1852.5 - 1912.5	4M50W7D	16QAM	0.192	22.84
LTE Band 25	1855 - 1910	9M00G7D	QPSK	0.227	23.56
LTE Band 25	1855 - 1910	8M96W7D	16QAM	0.195	22.90
LTE Band 25	1857.5 - 1907.5	13M5G7D	QPSK	0.217	23.37
LTE Band 25	1857.5 - 1907.5	13M5W7D	16QAM	0.179	22.54
LTE Band 25	1860 - 1905	18M0G7D	QPSK	0.236	23.72
LTE Band 25	1860 - 1905	18M0W7D	16QAM	0.186	22.70
LTE Band 41	2498.5 - 2687.5	4M51G7D	QPSK	0.243	23.85
LTE Band 41	2498.5 - 2687.5	4M49W7D	16QAM	0.213	23.29
LTE Band 41	2501 - 2685	8M99G7D	QPSK	0.311	24.93
LTE Band 41	2501 - 2685	8M97W7D	16QAM	0.254	24.06
LTE Band 41	2503.5 - 2682.5	13M5G7D	QPSK	0.319	25.04
LTE Band 41	2503.5 - 2682.5	13M5W7D	16QAM	0.253	24.04
LTE Band 41	2506 - 2680	17M9G7D	QPSK	0.312	24.95
LTE Band 41	2506 - 2680	18M0W7D	16QAM	0.340	25.32

This equipment has been shown to be capable of compliance with the applicable technical standards as indicated in the measurement report and was tested in accordance with the measurement procedures specified in §2.947. Test results reported herein relate only to the item(s) tested.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.


Randy Ortanez
President

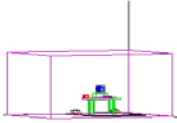


FCC ID: A3LSMJ120P		FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 1 of 94

TABLE OF CONTENTS

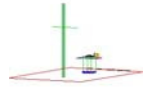
FCC PART 22, 24, & 27 MEASUREMENT REPORT	3
1.0 INTRODUCTION	4
1.1 Scope.....	4
1.2 Testing Facility	4
2.0 PRODUCT INFORMATION.....	5
2.1 Equipment Description	5
2.2 Device Capabilities	5
2.3 Test Configuration.....	5
2.4 EMI Suppression Device(s)/Modifications.....	5
3.0 DESCRIPTION OF TESTS	6
3.1 Measurement Procedure.....	6
3.2 Cellular - Base Frequency Blocks	6
3.3 Cellular - Mobile Frequency Blocks.....	6
3.4 PCS - Base Frequency Blocks.....	6
3.5 PCS - Mobile Frequency Blocks	7
3.6 BRS/EBS Frequency Block.....	7
3.7 Radiated Power and Radiated Spurious Emissions.....	8
4.0 MEASUREMENT UNCERTAINTY	9
5.0 TEST EQUIPMENT CALIBRATION DATA	10
6.0 SAMPLE CALCULATIONS	11
7.0 TEST RESULTS.....	12
7.1 Summary.....	12
7.2 Occupied Bandwidth	13
7.3 Spurious and Harmonic Emissions at Antenna Terminal	29
7.4 Band Edge Emissions at Antenna Terminal.....	44
7.5 Peak-Average Ratio.....	67
7.6 Radiated Power (ERP/EIRP)	74
7.7 Radiated Spurious Emissions Measurements.....	79
7.8 Frequency Stability / Temperature Variation	87
8.0 CONCLUSION.....	94

FCC ID: A3LSMJ120P		FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 2 of 94



MEASUREMENT REPORT

FCC Part 22, 24, & 27

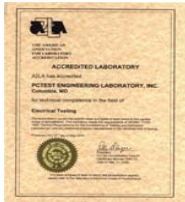


§2.1033 General Information

APPLICANT: Samsung Electronics Co., Ltd.
APPLICANT ADDRESS: 129, Samsung-ro,
 Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Korea
TEST SITE: PCTEST ENGINEERING LABORATORY, INC.
TEST SITE ADDRESS: 7185 Oakland Mills Road, Columbia, MD 21045 USA
FCC RULE PART(S): §2; §22; §24; §27
BASE MODEL: SM-J120P
FCC ID: A3LSMJ120P
FCC CLASSIFICATION: PCS Licensed Transmitter Held to Ear (PCE)
FREQUENCY TOLERANCE: $\pm 0.00025\%$ (2.5 ppm)
Test Device Serial No.: 03820 ☐ Production ☒ Pre-Production ☐ Engineering
DATE(S) OF TEST: 2/15 - 2/26/2016
TEST REPORT S/N: 0Y1602150336.A3L

Test Facility / Accreditations

Measurements were performed at PCTEST Engineering Lab located in Columbia, MD 21046, U.S.A.



- PCTEST facility is an FCC registered (PCTEST Reg. No. 159966) test facility with the site description report on file and has met all the requirements specified in Section 2.948 of the FCC Rules and Industry Canada (2451B-1).
- PCTEST Lab is accredited to ISO 17025 by U.S. National Institute of Standards and Technology (NIST) under the National Voluntary Laboratory Accreditation Program (NVLAP Lab code: 100431-0) in EMC, FCC and Telecommunications.
- PCTEST Lab is accredited to ISO 17025-2005 by the American Association for Laboratory Accreditation (A2LA) in Specific Absorption Rate (SAR) testing, Hearing Aid Compatibility (HAC) testing, CTIA Test Plans, and wireless testing for FCC and Industry Canada Rules.
- PCTEST Lab is a recognized U.S. Conformity Assessment Body (CAB) in EMC and R&TTE (n.b. 0982) under the U.S.-EU Mutual Recognition Agreement (MRA).
- PCTEST TCB is a Telecommunication Certification Body (TCB) accredited to ISO/IEC Guide 65 by the American National Standards Institute (ANSI) in all scopes of FCC Rules and Industry Canada Standards (RSS).
- PCTEST facility is an IC registered (2451B-1) test laboratory with the site description on file at Industry Canada.
- PCTEST is a CTIA Authorized Test Laboratory (CATL) for AMPS, CDMA, and EvDO wireless devices and for Over-the-Air (OTA) Antenna Performance testing for AMPS, CDMA, GSM, GPRS, EGPRS, UMTS (W-CDMA), CDMA 1xEVDO, and CDMA 1xRTT.

FCC ID: A3LSMJ120P		FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 3 of 94

1.0 INTRODUCTION

1.1 Scope

Measurement and determination of electromagnetic emissions (EME) of radio frequency devices including intentional and/or unintentional radiators for compliance with the technical rules and regulations of the Federal Communications Commission and the Industry Canada Certification and Engineering Bureau.

1.2 Testing Facility

The map below shows the location of the PCTEST LABORATORY, its proximity to the FCC Laboratory, the Columbia vicinity, the Baltimore-Washington Internt'l (BWI) airport, the city of Baltimore and the Washington, DC area. (See Figure 1-1).

These measurement tests were conducted at the PCTEST Engineering Laboratory, Inc. facility located at 7185 Oakland Mills Road, Columbia, MD 21046. The site coordinates are 39° 10'23" N latitude and 76° 49'50" W longitude. The facility is 0.4 miles North of the FCC laboratory, and the ambient signal and ambient signal strength are approximately equal to those of the FCC laboratory. The detailed description of the measurement facility was found to be in compliance with the requirements of § 2.948 according to ANSI C63.4-2014 on January 22, 2015.

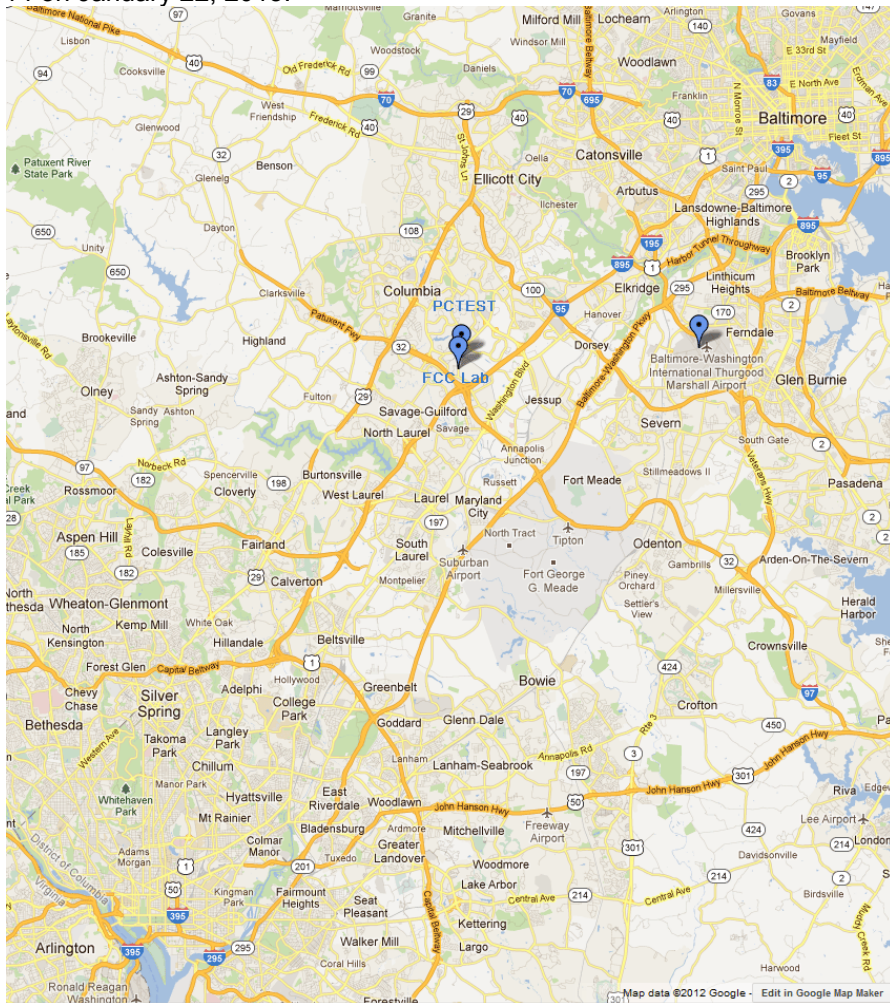


Figure 1-1. Map of the Greater Baltimore and Metropolitan Washington, D.C. area

FCC ID: A3LSMJ120P		FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 4 of 94

2.0 PRODUCT INFORMATION

2.1 Equipment Description

The Equipment Under Test (EUT) is the **Samsung Portable Handset FCC ID: A3LSMJ120P**. The test data contained in this report pertains only to the emissions due to the EUT's LTE function.

2.2 Device Capabilities

This device contains the following capabilities:

850/1900 CDMA/EvDO Rev0/A (BC0, BC1, BC10), 850/1900 GSM/GPRS/EDGE, 850/1900 WCDMA/HSPA, Multi-band LTE, 802.11b/g/n WLAN, Bluetooth (1x, EDR, LE)

2.3 Test Configuration

The Samsung Portable Handset FCC ID: A3LSMJ120P was tested per the guidance of ANSI/TIA-603-C-2004 and KDB 971168 D01 v02r02. See Section 7.0 of this test report for a description of the radiated and antenna port conducted emissions tests.

2.4 EMI Suppression Device(s)/Modifications

No EMI suppression device(s) were added and no modifications were made during testing.

FCC ID: A3LSMJ120P		FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 5 of 94

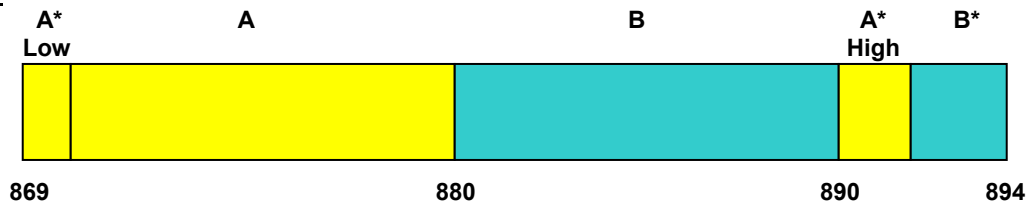
3.0 DESCRIPTION OF TESTS

3.1 Measurement Procedure

The measurement procedures described in the document titled “Land Mobile FM or PM – Communications Equipment – Measurements and Performance Standards” (ANSI/TIA-603-C-2004) and “Procedures for Compliance Measurement of the Fundamental Emission Power of Licensed Wideband (> 1 MHz) Digital Transmission Systems” (KDB 971168 D01 v02r02) were used in the measurement of the **Samsung Portable Handset FCC ID: A3LSMJ120P**.

3.2 Cellular - Base Frequency Blocks

§22.905



BLOCK 1: 869 – 880 MHz (A* Low + A)

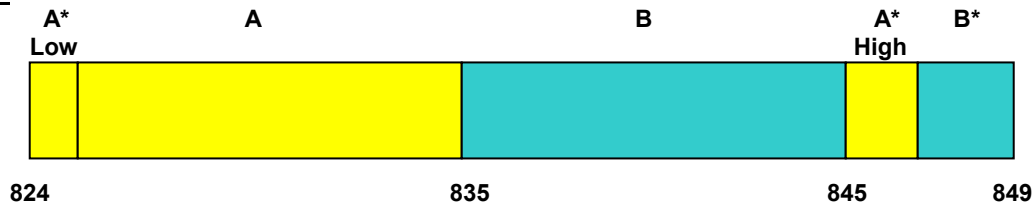
BLOCK 2: 880 – 890 MHz (B)

BLOCK 3: 890 – 891.5 MHz (A* High)

BLOCK 4: 891.5 – 894 MHz (B*)

3.3 Cellular - Mobile Frequency Blocks

§22.905



BLOCK 1: 824 – 835 MHz (A* Low + A)

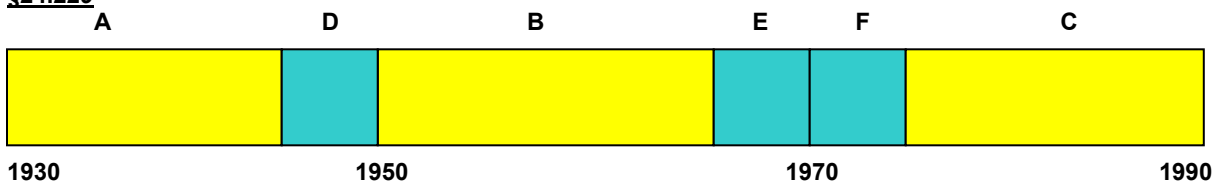
BLOCK 2: 835 – 845 MHz (B)

BLOCK 3: 845 – 846.5 MHz (A* High)

BLOCK 4: 846.5 – 849 MHz (B*)

3.4 PCS - Base Frequency Blocks

§24.229



BLOCK 1: 1930 – 1945 MHz (A)

BLOCK 2: 1945 – 1950 MHz (D)

BLOCK 3: 1950 – 1965 MHz (B)

BLOCK 4: 1965 – 1970 MHz (E)

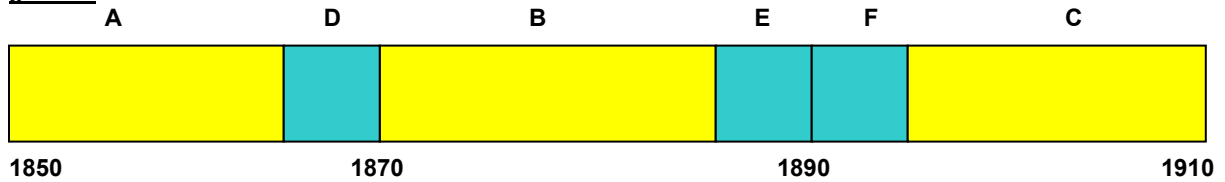
BLOCK 5: 1970 – 1975 MHz (F)

BLOCK 6: 1975 – 1990 MHz (C)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset	Page 6 of 94

3.5 PCS - Mobile Frequency Blocks

§24.229

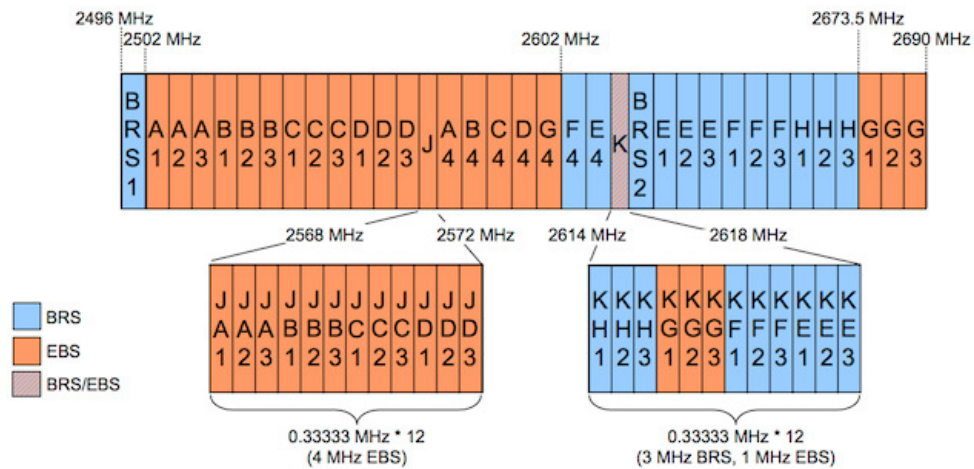


BLOCK 1: 1850 – 1865 MHz (A)
BLOCK 2: 1865 – 1870 MHz (D)
BLOCK 3: 1870 – 1885 MHz (B)

BLOCK 4: 1885 – 1890 MHz (E)
BLOCK 5: 1890 – 1895 MHz (F)
BLOCK 6: 1895 – 1910 MHz (C)

3.6 BRS/EBS Frequency Block

§27.5



FCC ID: A3LSMJ20P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 7 of 94

3.7 Radiated Power and Radiated Spurious Emissions

§2.1053 §22.913(a.2) §22.917(a) §24.232(c) §24.238(a) §27.50(h.2) §27.53(m)

The radiated test facilities consisted of an indoor 3 meter semi-anechoic chamber used for final measurements and exploratory measurements, when necessary. The measurement area is contained within the semi-anechoic chamber which is shielded from any ambient interference. The test site inside the chamber is a 6m x 5.2m elliptical, obstruction-free area in accordance with Clause 5, Figure 5.7 of ANSI C63.4-2014. For measurements above 1GHz absorbers are arranged on the floor between the turn table and the antenna mast in such a way so as to maximize the reduction of reflections. For measurements below 1GHz, the absorbers are removed. An ETS Lindgren Model 2188 raised turntable is used for radiated measurement. It is a continuously rotatable, remote-controlled, metallic turntable and 2 meters (6.56 ft.) in diameter. The turn table is flush with the raised floor of the chamber in order to maintain its function as a ground plane. A 78cm high PVC support structure is placed on top of the turntable. A ¾" (~1.9cm) sheet of high density polyethylene is used as the table top and is placed on top of the PVC supports to bring the total height of the table to 80cm.

The equipment under test was transmitting while connected to its integral antenna and is placed on a turntable 3 meters from the receive antenna. The receive antenna height is adjusted between 1 and 4 meter height, the turntable is rotated through 360 degrees, and the EUT is manipulated through all orthogonal planes representative of its typical use to achieve the highest reading on the receive spectrum analyzer. Radiated power levels are also investigated with the receive antenna horizontally and vertically polarized. The maximized power level is recorded using the spectrum analyzer "Channel Power" function with the integration band set to the emissions' occupied bandwidth, a RMS detector, RBW = 100kHz, VBW = 300kHz, and a 1 second sweep time over a minimum of 10 sweeps, per the guidelines of KDB 971168.

Per the guidance of ANSI/TIA-603-C-2004, a half-wave dipole is then substituted in place of the EUT. For emissions above 1GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator with the level of the signal generator being adjusted to obtain the same receive spectrum analyzer level previously recorded from the spurious emission from the EUT. The power of the emission is calculated using the following formula:

$$P_d \text{ [dBm]} = P_g \text{ [dBm]} - \text{cable loss [dB]} + \text{antenna gain [dBd/dBi]}$$

Where, P_d is the dipole equivalent power, P_g is the generator output into the substitution antenna, and the antenna gain is the gain of the substitute antenna used relative to either a half-wave dipole (dBd) or an isotropic source (dBi). The substitute level is equal to $P_g \text{ [dBm]} - \text{cable loss [dB]}$.

The calculated P_d levels are then compared to the absolute spurious emission limit of -13dBm which is equivalent to the required minimum attenuation of $43 + 10\log_{10}(\text{Power [Watts]})$. For Band 41, the calculated P_d levels are compared to the absolute spurious emission limit of -25dBm which is equivalent to the required minimum attenuation of $55 + 10\log_{10}(\text{Power [Watts]})$.

FCC ID: A3LSMJ120P		FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 8 of 94

4.0 MEASUREMENT UNCERTAINTY

The measurement uncertainties shown below were calculated in accordance with the requirements of ANSI C63.4-2014. All measurement uncertainty values are shown with a coverage factor of $k = 2$ to indicate a 95% level of confidence. The measurement data shown herein meets or exceeds the U_{CISPR} measurement uncertainty values specified in CISPR 16-4-2 and, thus, can be compared directly to specified limits to determine compliance.

Contribution	Expanded Uncertainty ($\pm$ dB)
Conducted Bench Top Measurements	1.13
Radiated Disturbance (<1GHz)	4.98
Radiated Disturbance (>1GHz)	5.07
Radiated Disturbance (>18GHz)	5.09

FCC ID: A3LSMJ120P		FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 9 of 94

5.0 TEST EQUIPMENT CALIBRATION DATA

Test Equipment Calibration is traceable to the National Institute of Standards and Technology (NIST).

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
-	LTX3	Licensed Transmitter Cable Set	6/12/2015	Annual	6/12/2016	LTX3
-	RE1	Radiated Emissions Cable Set (UHF/EHF)	4/28/2015	Annual	4/28/2016	RE1
Agilent	8447D	Broadband Amplifier	6/12/2015	Annual	6/12/2016	2443A01900
Agilent	N9020A	MXA Signal Analyzer	11/5/2015	Annual	11/5/2016	US46470561
Com-Power	AL-130	9kHz - 30MHz Loop Antenna	7/30/2015	Biennial	7/30/2017	121034
Emco	3115	Horn Antenna (1-18GHz)	3/30/2014	Biennial	3/30/2016	9704-5182
Espec	ESX-2CA	Environmental Chamber	3/17/2015	Annual	3/17/2016	17620
ETS Lindgren	3117	1-18 GHz DRG Horn (Medium)	4/8/2014	Biennial	4/8/2016	125518
ETS Lindgren	3160-09	18-26.5 GHz Standard Gain Horn	6/17/2014	Biennial	6/17/2016	135427
ETS Lindgren	3164-08	Quad Ridge Horn Antenna	10/22/2014	Biennial	10/22/2016	128338
K & L	11SH10-3075/U18000	High Pass Filter	7/18/2015	Annual	7/18/2016	11SH10-3075/U18000-2
K & L	13SH10-1000/U1000	N Type High Pass Filter	7/18/2015	Annual	7/18/2016	13SH10-1000/U1000-1
Mini Circuits	PWR-SEN-4GHS	USB Power Sensor	3/11/2015	Annual	3/11/2016	11401010036
Mini Circuits	TVA-11-422	RF Power Amp	N/A			QA1317001
Mini-Circuits	PWR-SENS-4RMS	USB Power Sensor	3/11/2015	Annual	3/11/2016	11210140001
Mini-Circuits	SSG-4000HP	Synthesized Signal Generator	N/A			11208010032
Rhode & Schwarz	TS-PR18	Pre-Amplifier	3/5/2015	Annual	3/5/2016	101622
Rohde & Schwarz	CMW500	Radio Communication Tester	10/21/2015	Annual	10/21/2016	102060
Rohde & Schwarz	ESU26	EMI Test Receiver (26.5GHz)	3/12/2015	Annual	3/12/2016	100342
Rohde & Schwarz	TS-PR18	1-18 GHz Pre-Amplifier	3/5/2015	Annual	3/5/2016	100071
Rohde & Schwarz	TS-PR26	18-26.5 GHz Pre-Amplifier	3/3/2015	Annual	3/3/2016	100040
Schwarzbeck	UHA 9105	Dipole Antenna (400 - 1GHz) Rx	2/21/2014	Biennial	2/21/2016	9105-2404
Seekonk	NC-100	Torque Wrench 5/16", 8" lbs	3/18/2014	Biennial	3/18/2016	N/A
Sunol	JB5	Bi-Log Antenna (30M - 5GHz)	3/28/2014	Biennial	3/28/2016	A051107

Table 5-1. Test Equipment

Notes:

1. For equipment listed above that has a calibration date or calibration due date that falls within the test date range, care was taken to ensure that this equipment was used after the calibration date and before the calibration due date.
2. Equipment with a calibration date of "N/A" shown in this list was not used to make direct calibrated measurements.

FCC ID: A3LSMJ120P	 FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION) 		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset	Page 10 of 94

6.0 SAMPLE CALCULATIONS

Emission Designator

QPSK Modulation

Emission Designator = 8M62G7D

LTE BW = 8.62 MHz

G = Phase Modulation

7 = Quantized/Digital Info

D = Data transmission, telemetry, telecommand

16QAM Modulation

Emission Designator = 8M45W7D

LTE BW = 8.45 MHz

W = Amplitude/Angle Modulated

7 = Quantized/Digital Info

D = Data transmission, telemetry, telecommand

Spurious Radiated Emission – LTE Band

Example: Middle Channel LTE Mode 2nd Harmonic (1564 MHz)

The average spectrum analyzer reading at 3 meters with the EUT on the turntable was –81.0 dBm. The gain of the substituted antenna is 8.1 dBi. The signal generator connected to the substituted antenna terminals is adjusted to produce a reading of –81.0 dBm on the spectrum analyzer. The loss of the cable between the signal generator and the terminals of the substituted antenna is 2.0 dB at 1564 MHz. So 6.1 dB is added to the signal generator reading of –30.9 dBm yielding –24.80 dBm. The fundamental EIRP was 25.501 dBm so this harmonic was 25.501 dBm – (-24.80).

FCC ID: A3LSMJ120P		FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 11 of 94

7.0 TEST RESULTS

7.1 Summary

Company Name: Samsung Electronics Co., Ltd.
 FCC ID: A3LSMJ120P
 FCC Classification: PCS Licensed Transmitter Held to Ear (PCE)
 Mode(s): LTE

FCC Part Section(s)	Test Description	Test Limit	Test Condition	Result	Reference
TRANSMITTER MODE (TX)					
2.1049	Occupied Bandwidth	N/A	CONDUCTED	PASS	Section 7.2
2.1051 22.917(a) 24.238(a)	Out of Band Emissions	$> 43 + 10\log_{10}(P[\text{Watts}])$ at Band Edge and for all out-of-band emissions		PASS	Section 7.3, 7.4
27.53(m)	Out of Band Emissions	$> 43 + 10\log_{10}(P[\text{Watts}])$ at channel edges and $> 55 + 10\log_{10}(P[\text{Watts}])$ at 5.5MHz away and beyond channel edges		PASS	Section 7.3, 7.4
24.232(d)	Peak-Average Ratio	< 13 dB		PASS	Section 7.5
2.1046	Transmitter Conducted Output Power	N/A		PASS	See RF Exposure Report
2.1055. 22.355 24.235 27.54	Frequency Stability	< 2.5 ppm (Part 22) and fundamental emissions stay within authorized frequency block (Part 24, 27)		PASS	Section 7.8
22.913(a.2)	Effective Radiated Power (Band 26)	< 7 Watts max. ERP	RADIATED	PASS	Section 7.6
24.232(c) 27.50(h.2)	Equivalent Isotropic Radiated Power (Band 25, 41)	< 2 Watts max. EIRP		PASS	Section 7.6
2.1053 22.917(a) 24.238(a)	Undesirable Emissions	$> 43 + 10\log_{10}(P[\text{Watts}])$ for all out-of-band emissions		PASS	Section 7.7
27.53(m)	Undesirable Emissions	$> 43 + 10\log_{10}(P[\text{Watts}])$ at channel edges $> 55 + 10\log_{10}(P[\text{Watts}])$ at 5.5MHz away and beyond channel edges		PASS	Section 7.7

Table 7-1. Summary of Test Results

Notes:

- 1) All modes of operation and data rates were investigated. The test results shown in the following sections represent the worst case emissions.
- 2) The analyzer plots (Sections 7.2, 7.3, 7.4, 7.5) were all taken with a correction table loaded into the analyzer. The correction table was used to account for the losses of the cables, directional couplers, and attenuators used as part of the system to maintain a link between the call box and the EUT at all frequencies of interest.
- 3) All antenna port conducted emissions testing was performed on a test bench with the antenna port of the EUT connected to the spectrum analyzer through calibrated cables, attenuators, and couplers.
- 4) For conducted spurious emissions, automated test software was used to measure emissions and capture the corresponding plots necessary to show compliance. The measurement software utilized is PCTEST "LTE Automation," Version 4.0.

FCC ID: A3LSMJ120P		FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset	Page 12 of 94	

7.2 Occupied Bandwidth

\$2.1049

Test Overview

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. All modes of operation were investigated and the worst case configuration results are reported in this section.

Test Procedure Used

KDB 971168 D01 v02r02 – Section 4.2

Test Settings

1. The signal analyzer's automatic bandwidth measurement capability was used to perform the 99% occupied bandwidth and the 26dB bandwidth. The bandwidth measurement was not influenced by any intermediate power nulls in the fundamental emission.
2. RBW = 1 – 5% of the expected OBW
3. VBW $\geq 3 \times$ RBW
4. Detector = Peak
5. Trace mode = max hold
6. Sweep = auto couple
7. The trace was allowed to stabilize
8. If necessary, steps 2 – 7 were repeated after changing the RBW such that it would be within 1 – 5% of the 99% occupied bandwidth observed in Step 7

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

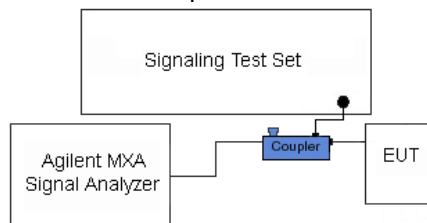
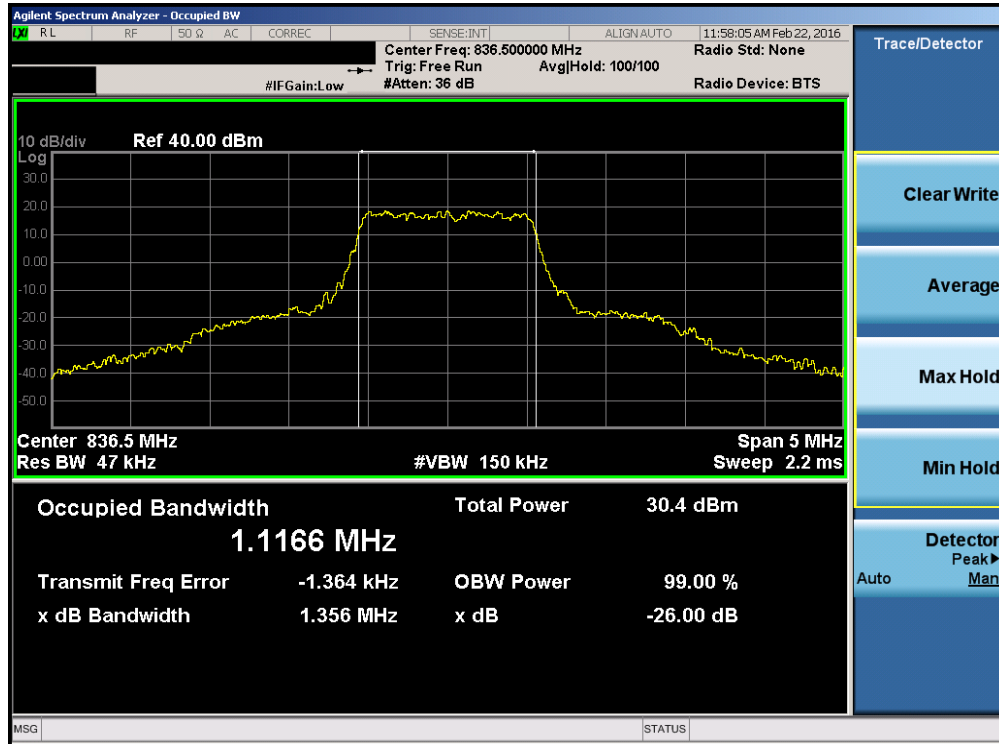


Figure 7-1. Test Instrument & Measurement Setup

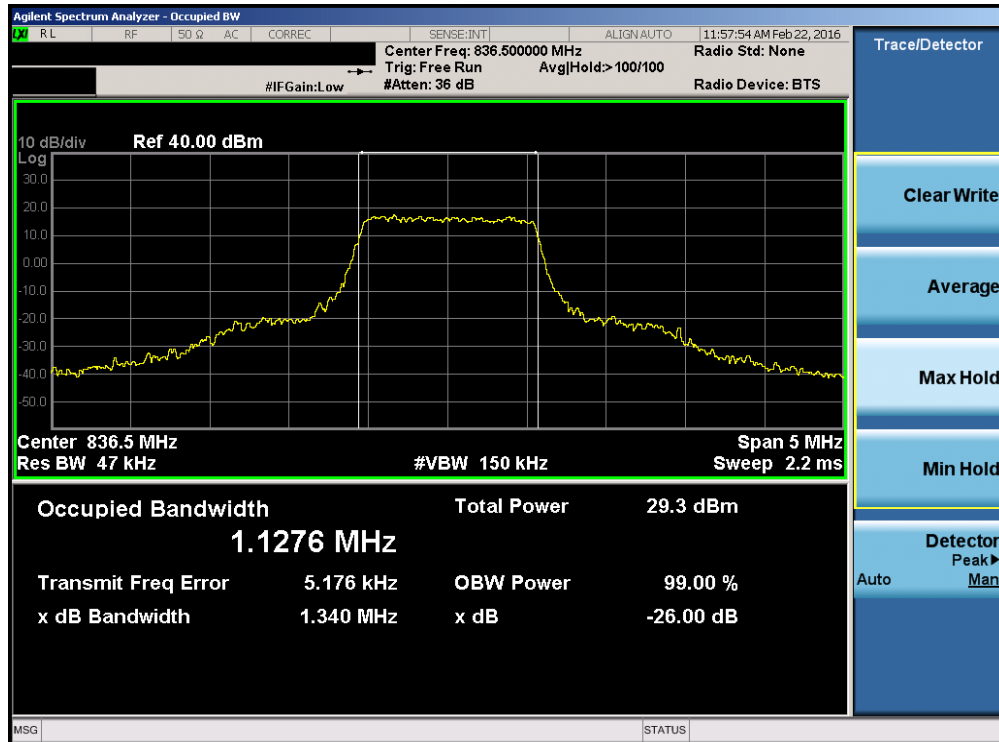
Test Notes

None.

FCC ID: A3LSMJ120P		FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset	Page 13 of 94	

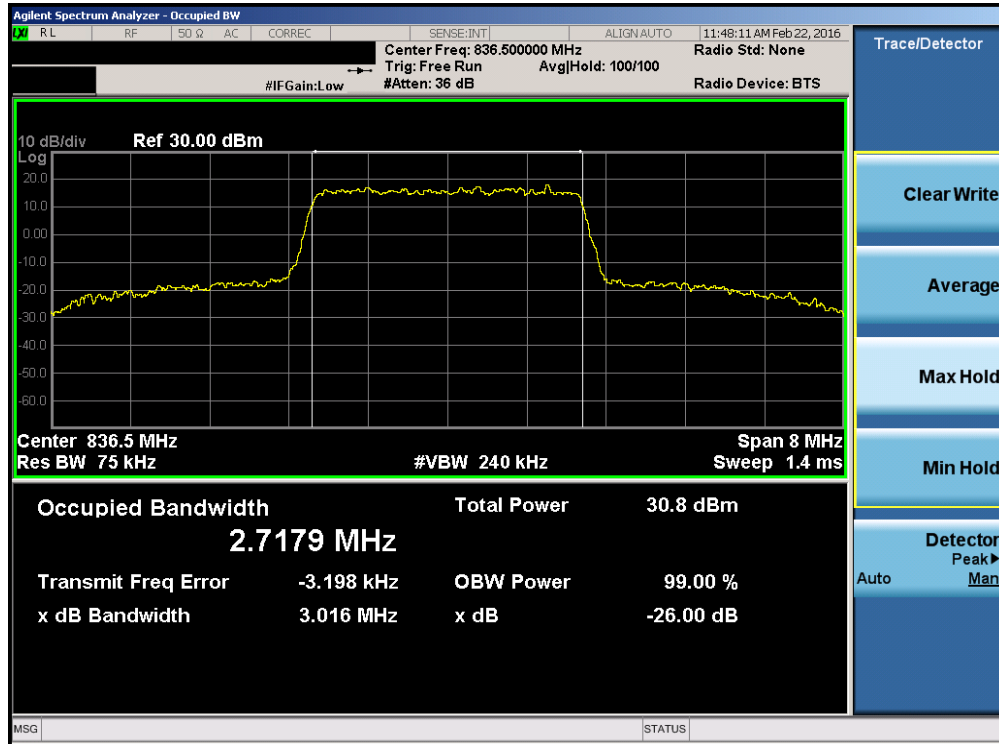


Plot 7-1. Occupied Bandwidth Plot (Band 26 – 1.4MHz QPSK – RB Size 6)

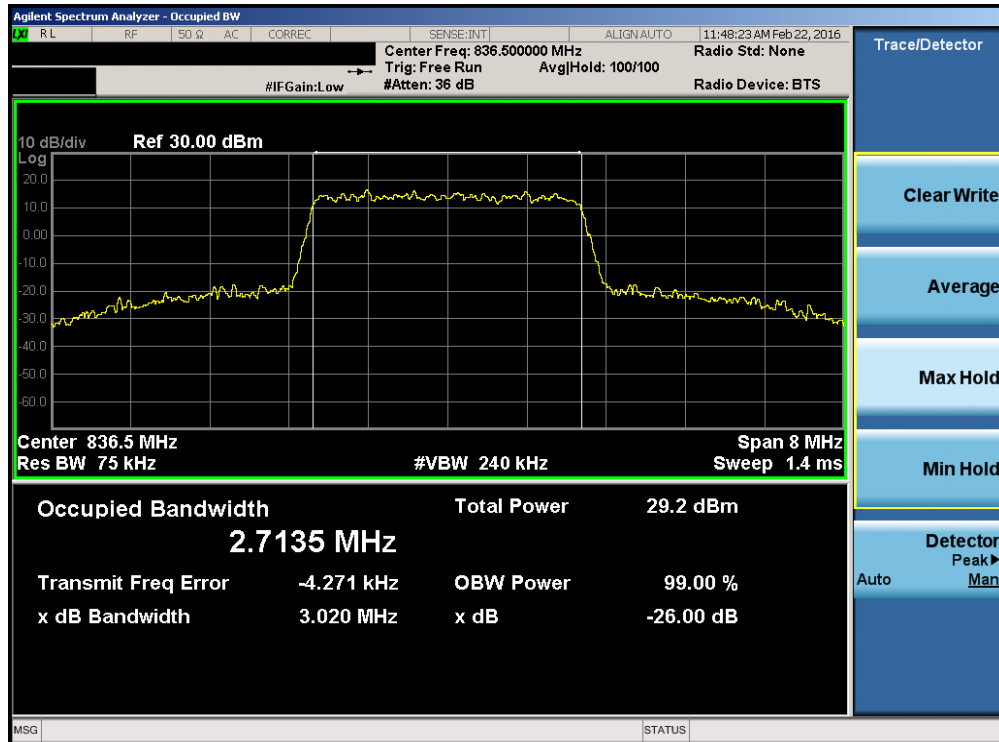


Plot 7-2. Occupied Bandwidth Plot (Band 26 – 1.4MHz 16-QAM – RB Size 6)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 14 of 94

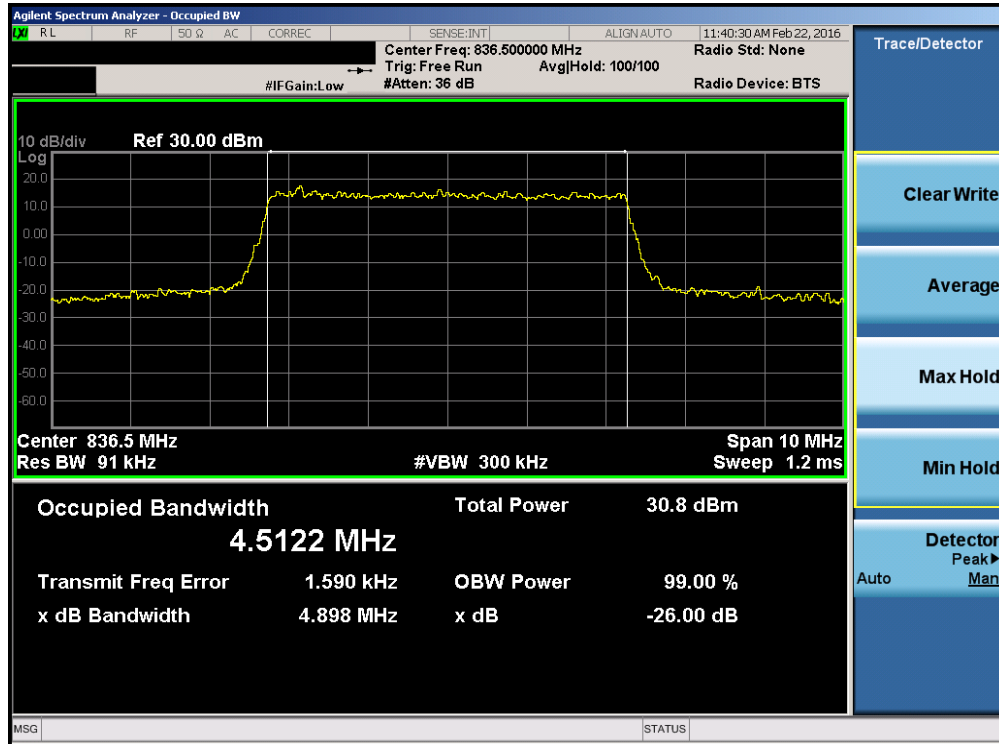


Plot 7-3. Occupied Bandwidth Plot (Band 26 – 3.0MHz QPSK – RB Size 15)

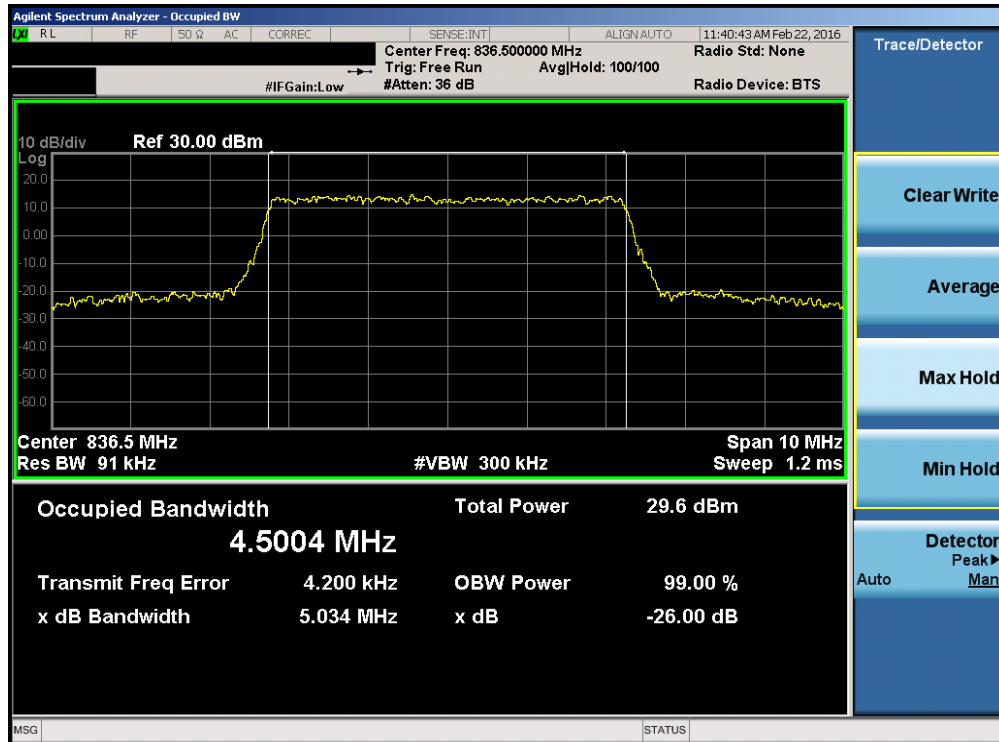


Plot 7-4. Occupied Bandwidth Plot (Band 26 – 3.0MHz 16-QAM – RB Size 15)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 15 of 94

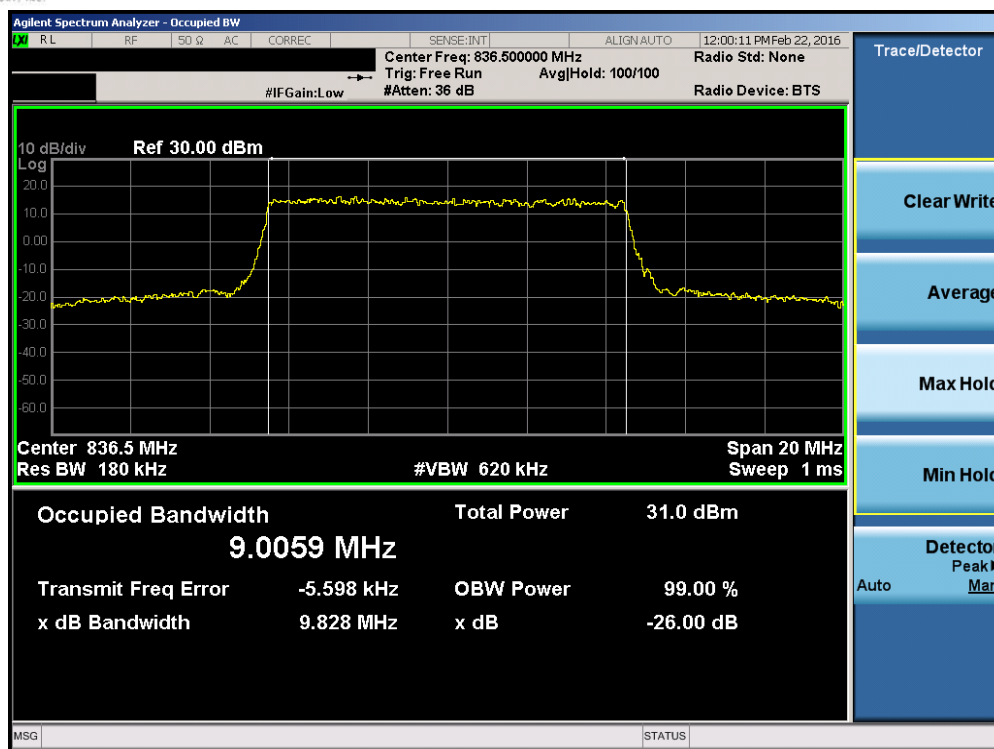


Plot 7-5. Occupied Bandwidth Plot (Band 26 – 5.0MHz QPSK – RB Size 25)

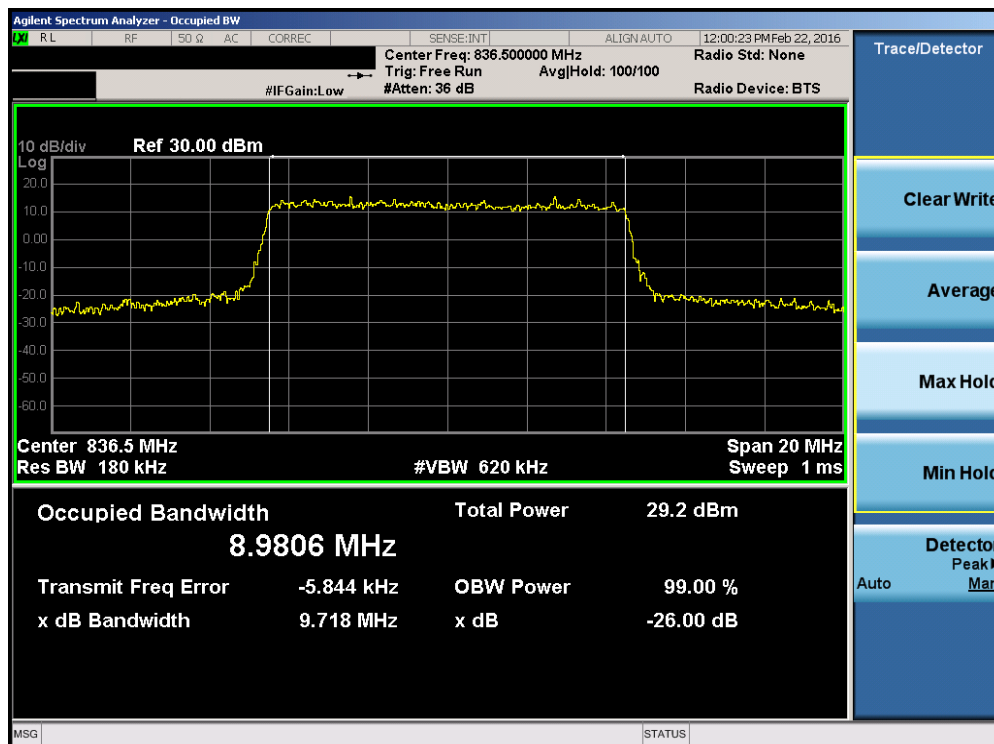


Plot 7-6. Occupied Bandwidth Plot (Band 26 – 5.0MHz 16-QAM – RB Size 25)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 16 of 94

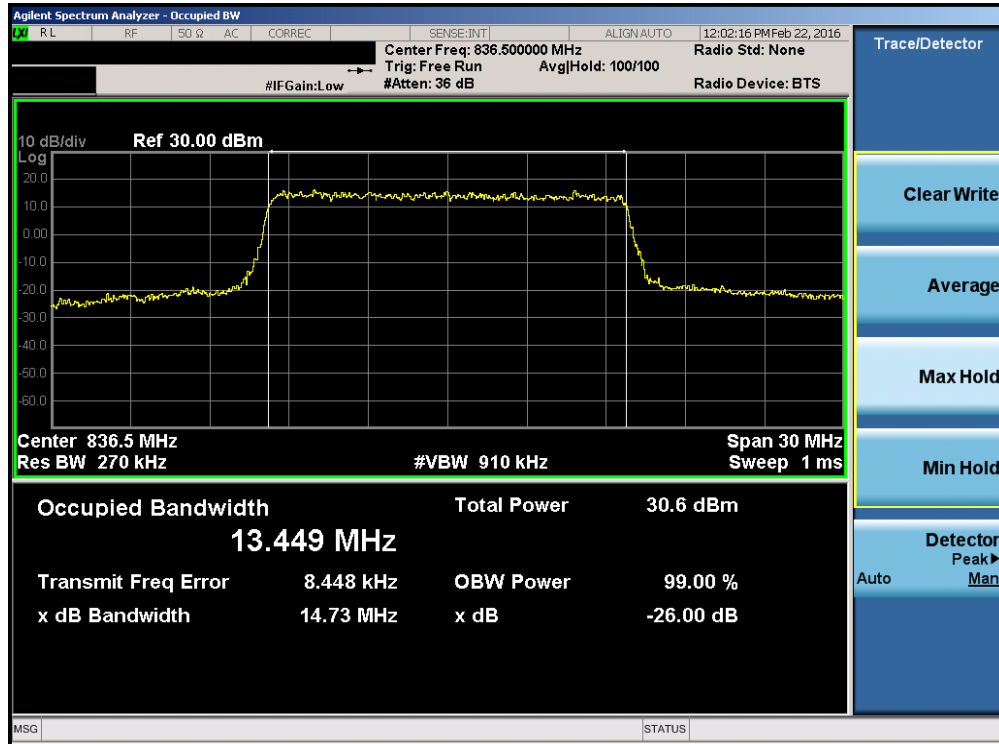


Plot 7-7. Occupied Bandwidth Plot (Band 26 – 10.0MHz QPSK – RB Size 50)

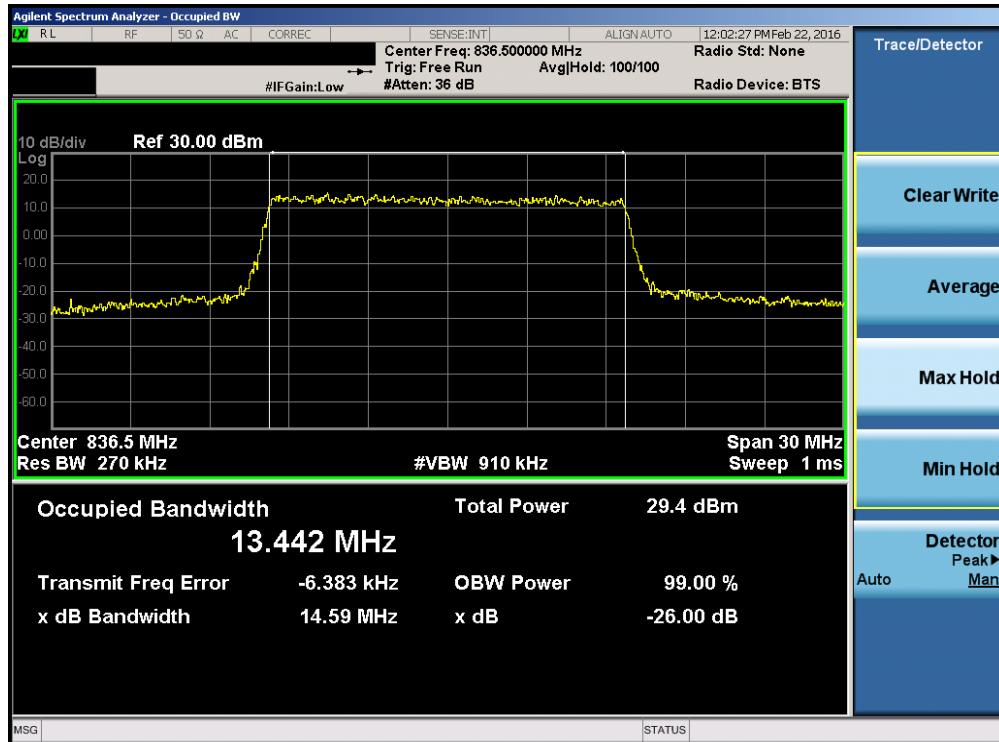


Plot 7-8. Occupied Bandwidth Plot (Band 26 – 10.0MHz 16-QAM – RB Size 50)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 17 of 94

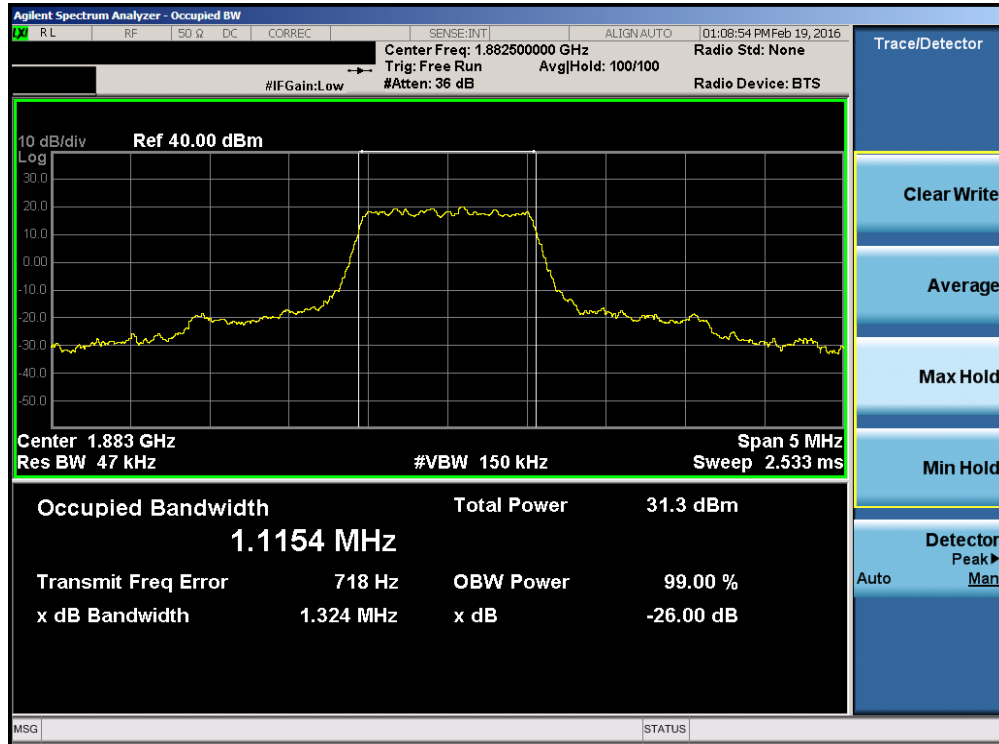


Plot 7-9. Occupied Bandwidth Plot (Band 26 – 15.0MHz QPSK – RB Size 75)

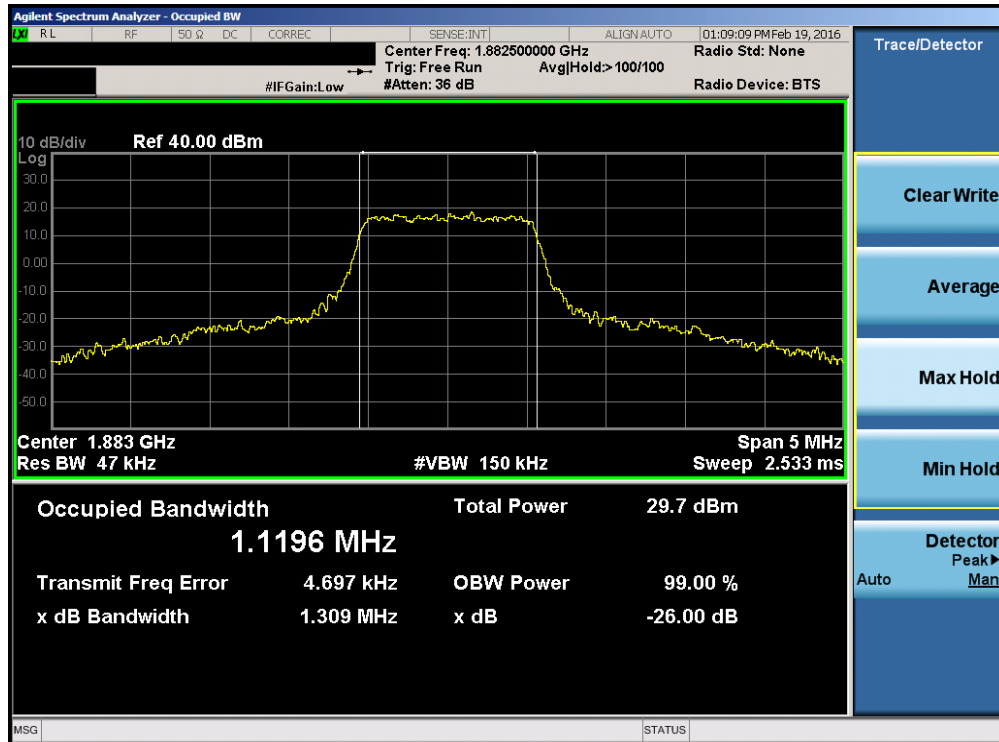


Plot 7-10. Occupied Bandwidth Plot (Band 26 – 15.0MHz 16-QAM – RB Size 75)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 18 of 94

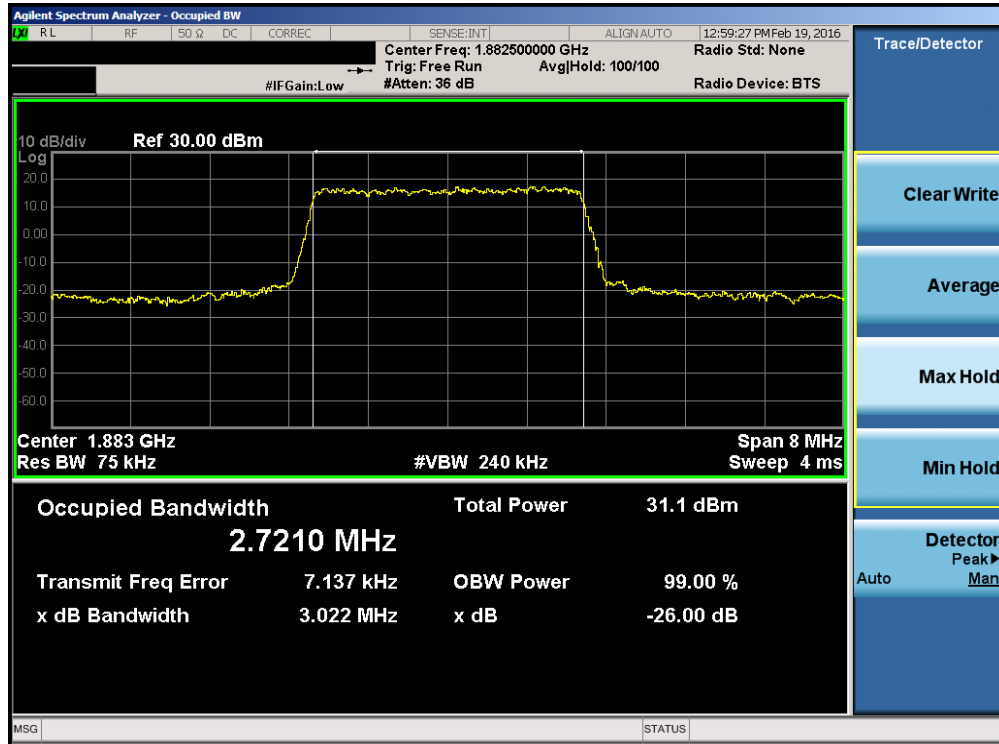


Plot 7-11. Occupied Bandwidth Plot (Band 25 – 1.4MHz QPSK – RB Size 6)

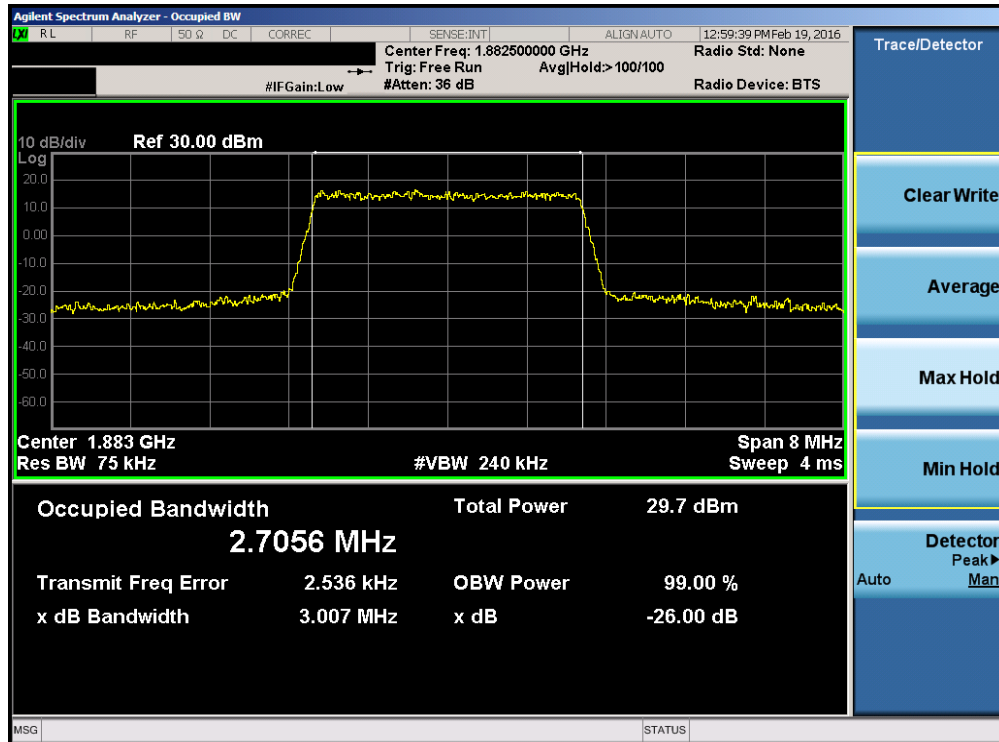


Plot 7-12. Occupied Bandwidth Plot (Band 25 – 1.4MHz 16-QAM – RB Size 6)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 19 of 94

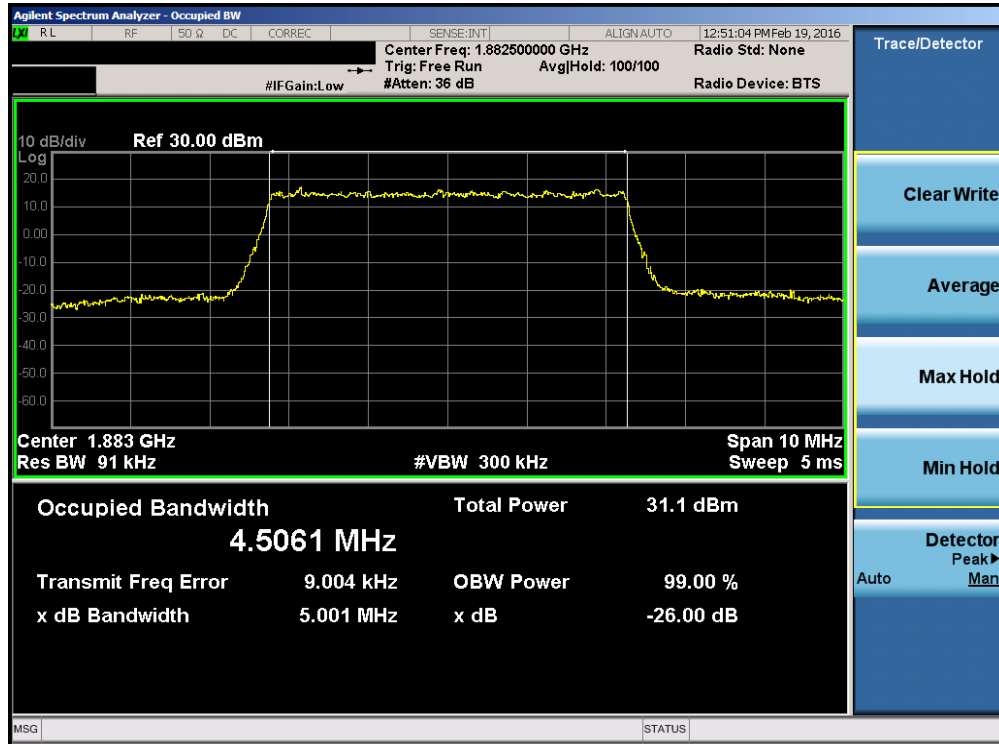


Plot 7-13. Occupied Bandwidth Plot (Band 25 – 3.0MHz QPSK – RB Size 15)

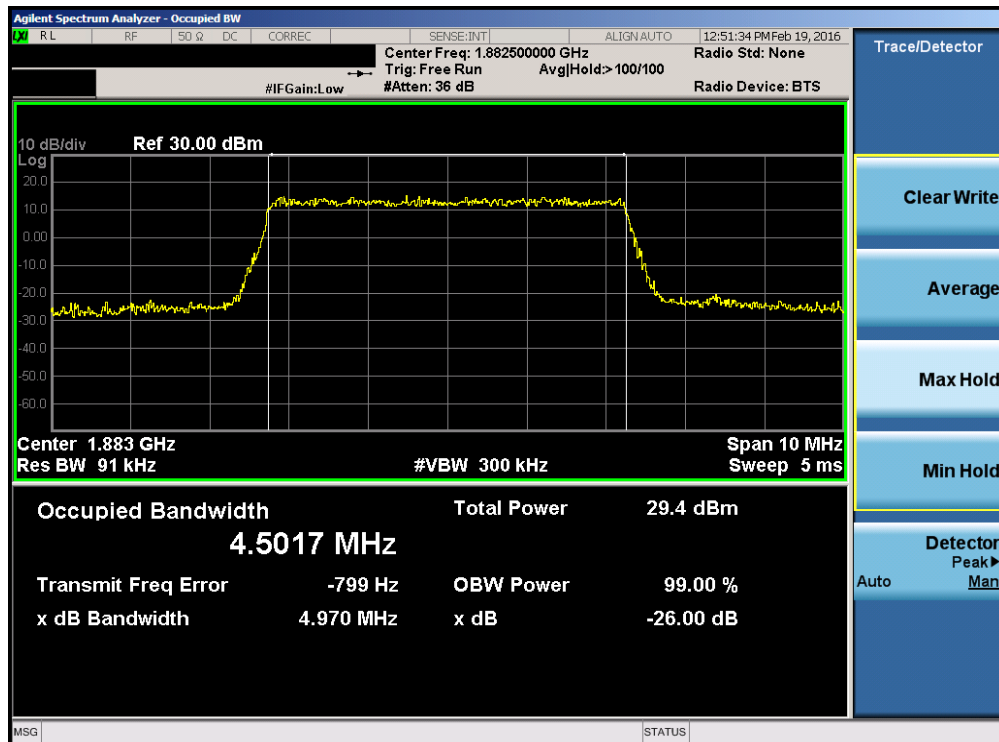


Plot 7-14. Occupied Bandwidth Plot (Band 25 – 3.0MHz 16-QAM – RB Size 15)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 20 of 94

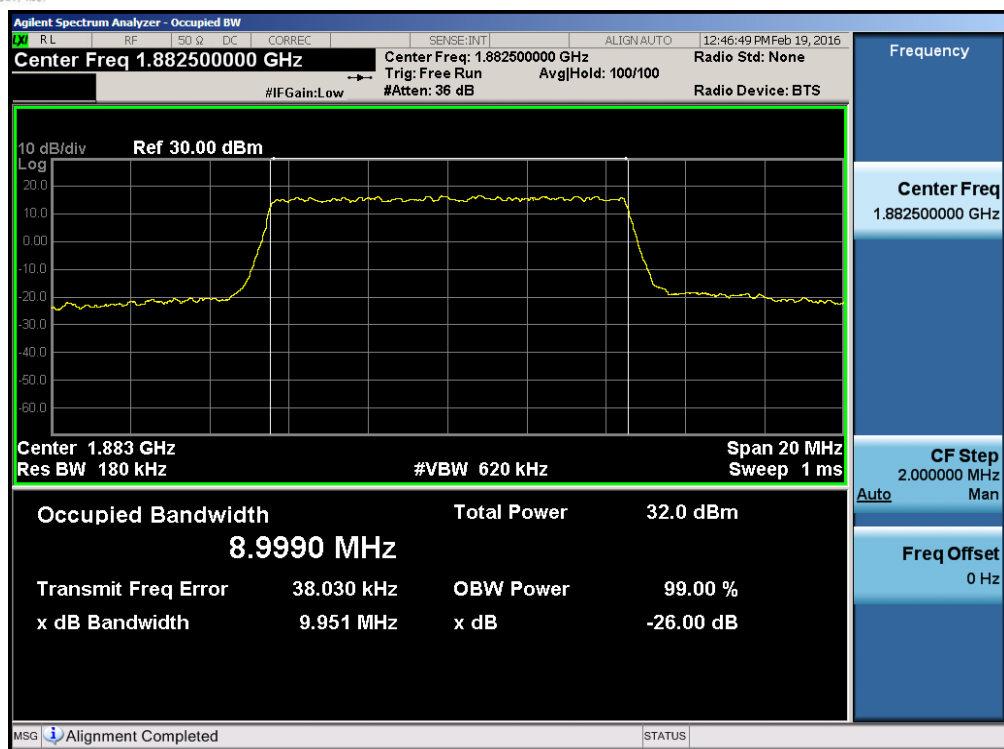


Plot 7-15. Occupied Bandwidth Plot (Band 25 – 5.0MHz QPSK – RB Size 25)

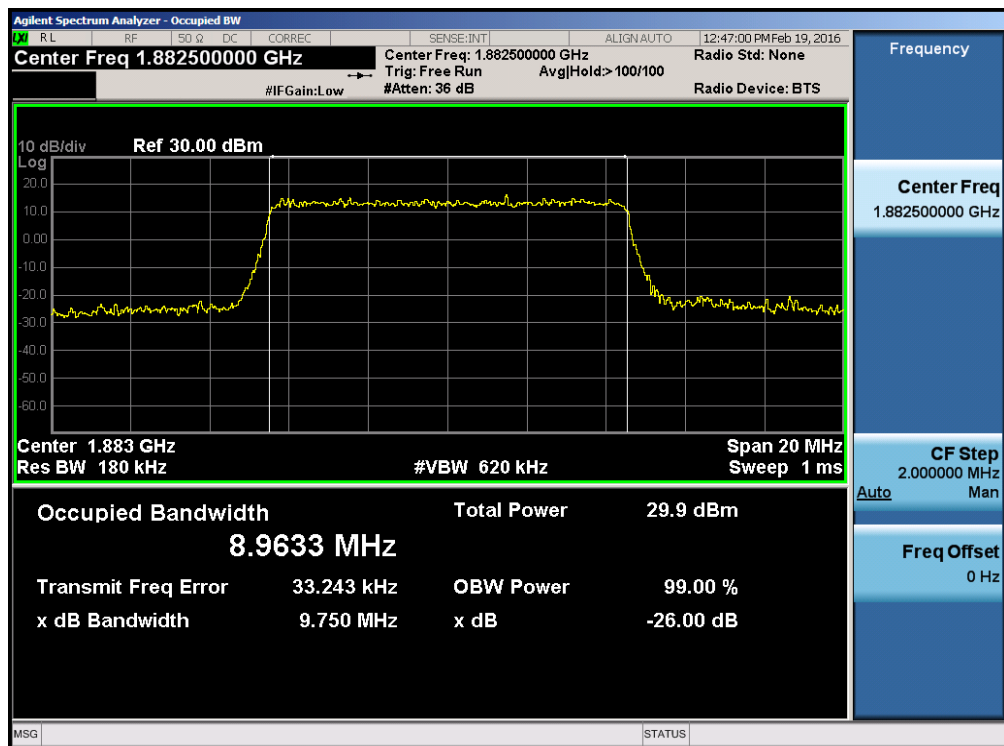


Plot 7-16. Occupied Bandwidth Plot (Band 25 – 5.0MHz 16-QAM – RB Size 25)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 21 of 94

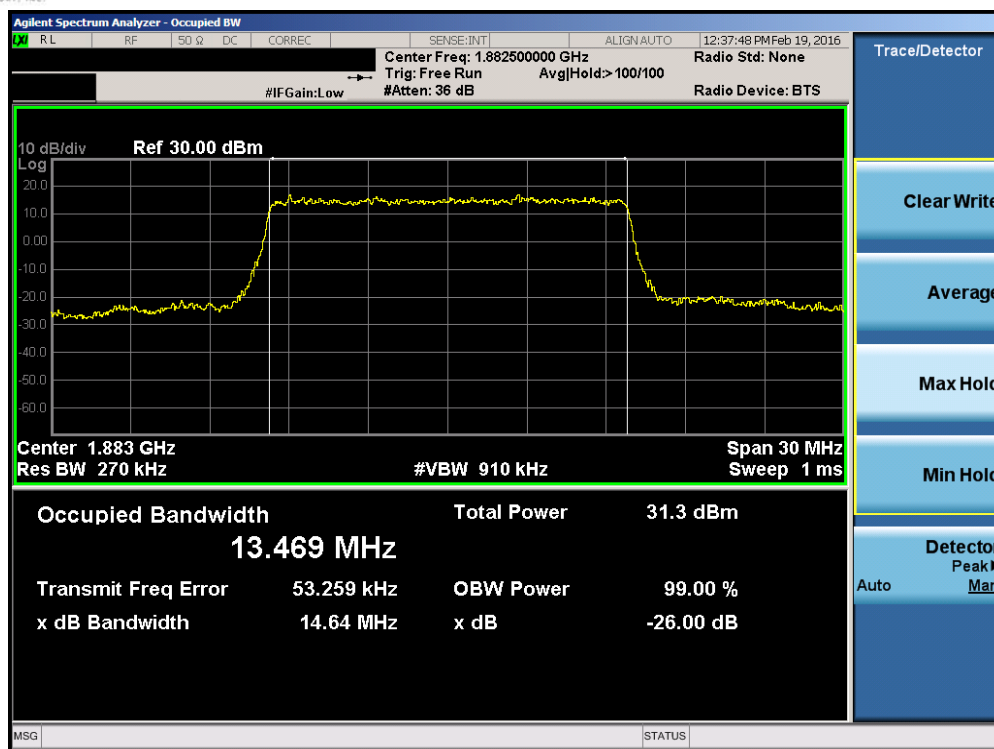


Plot 7-17. Occupied Bandwidth Plot (Band 25 – 10.0MHz QPSK – RB Size 50)

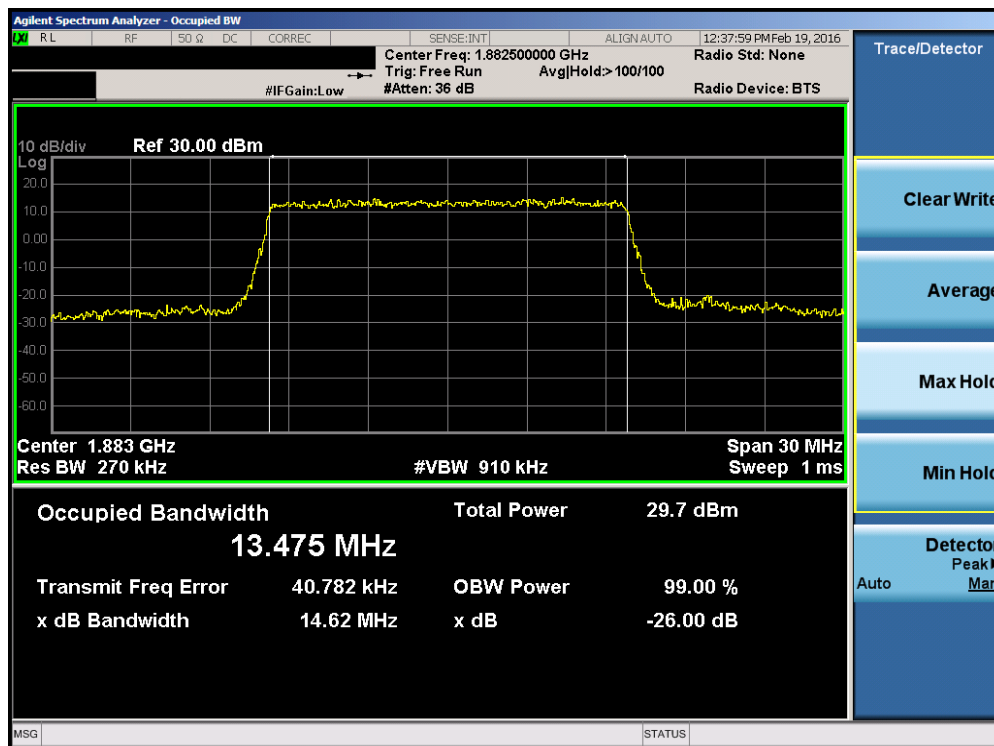


Plot 7-18. Occupied Bandwidth Plot (Band 25 – 10.0MHz 16-QAM – RB Size 50)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 22 of 94

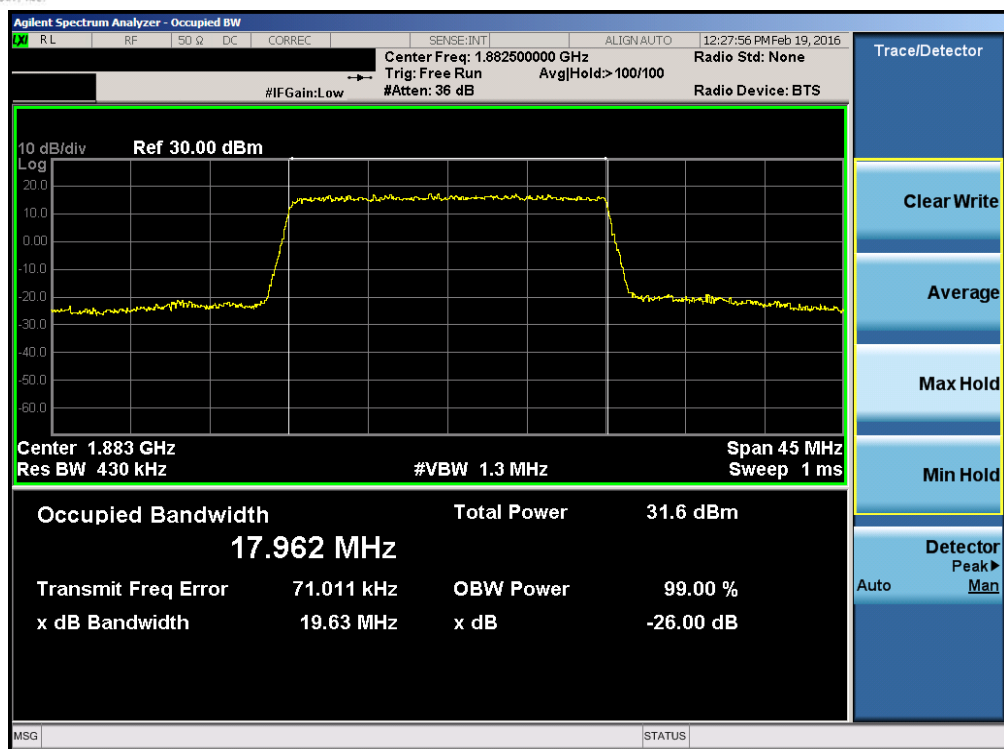


Plot 7-19. Occupied Bandwidth Plot (Band 25 – 15.0MHz QPSK – RB Size 75)

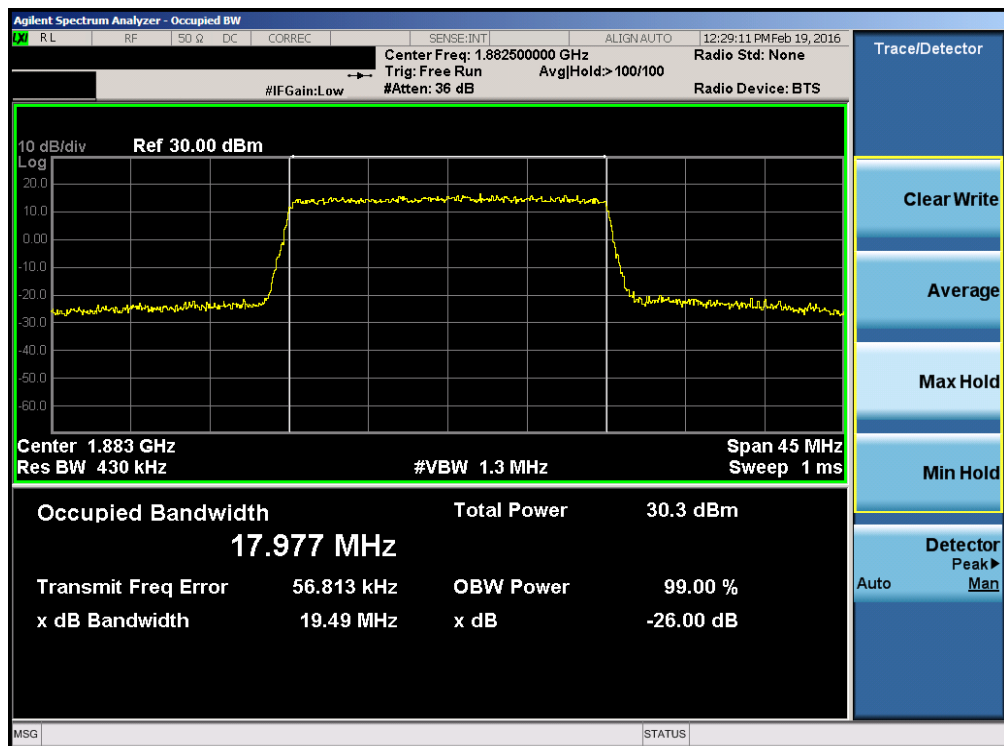


Plot 7-20. Occupied Bandwidth Plot (Band 25 – 15.0MHz 16-QAM – RB Size 75)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 23 of 94

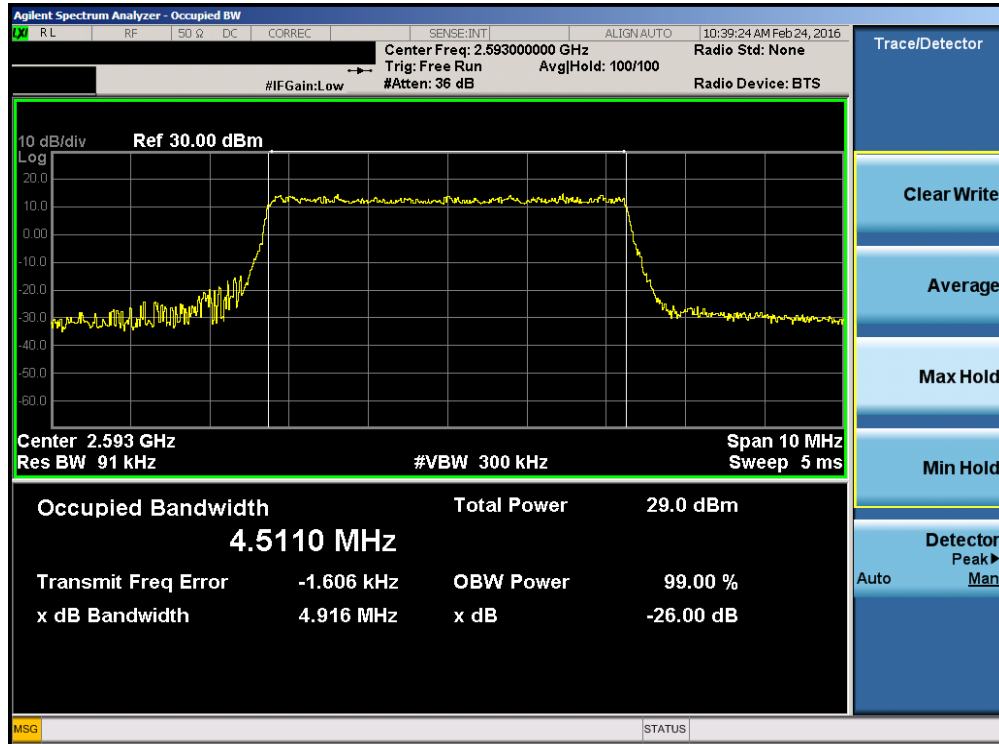


Plot 7-21. Occupied Bandwidth Plot (Band 25 – 20.0MHz QPSK – RB Size 100)

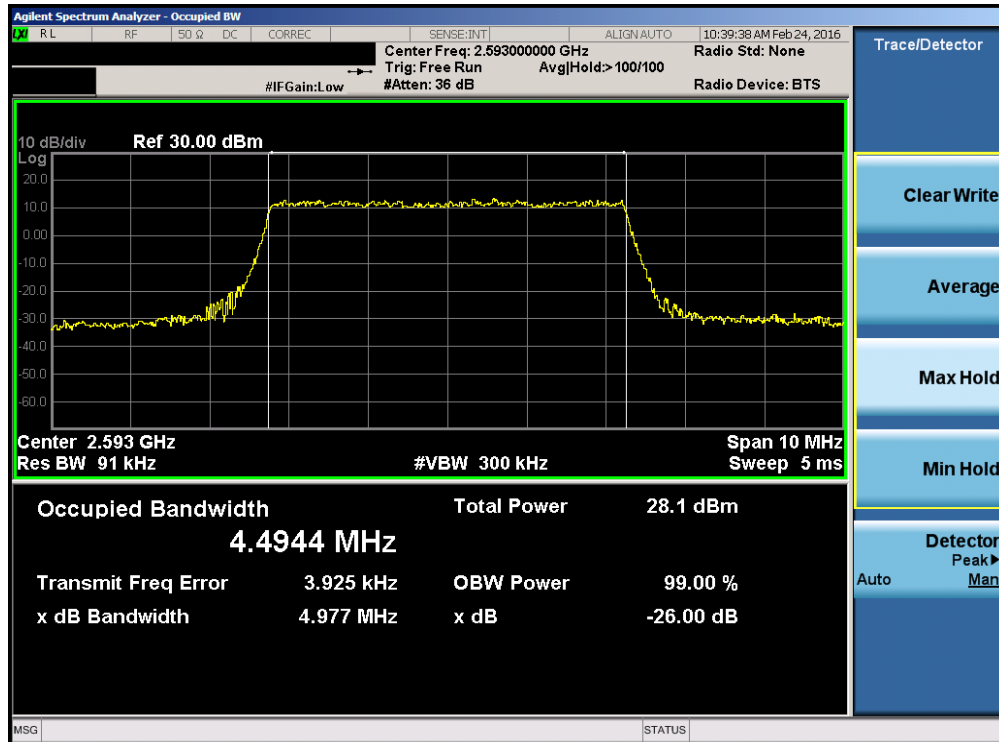


Plot 7-22. Occupied Bandwidth Plot (Band 25 – 20.0MHz 16-QAM – RB Size 100)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 24 of 94

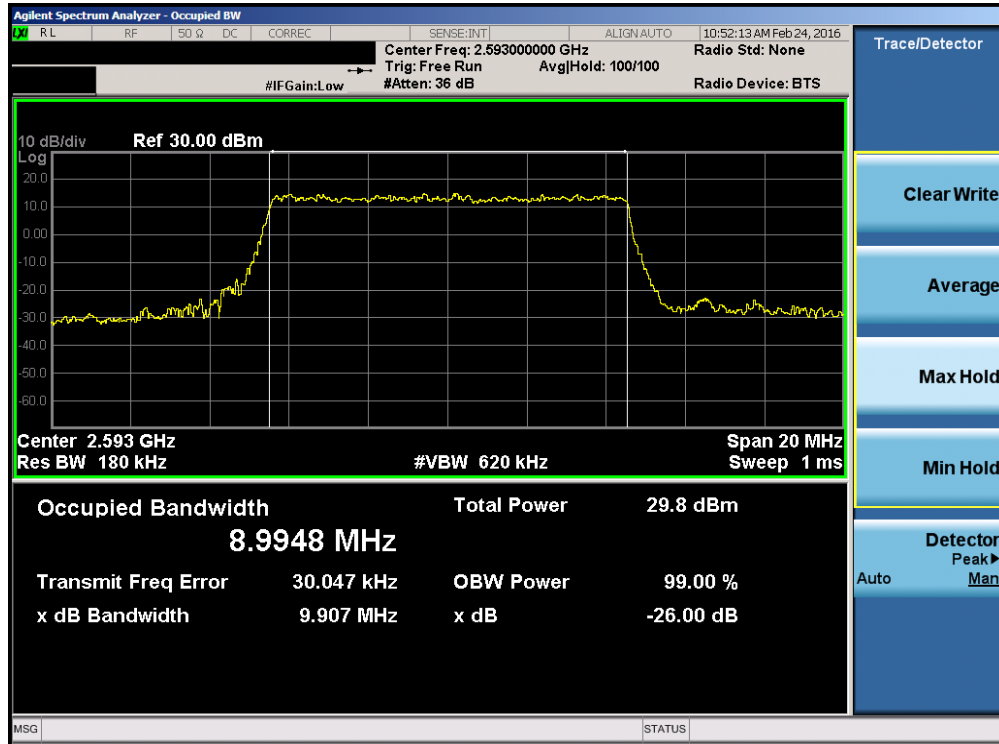


Plot 7-23. Occupied Bandwidth Plot (Band 41 – 5.0MHz QPSK – RB Size 25)

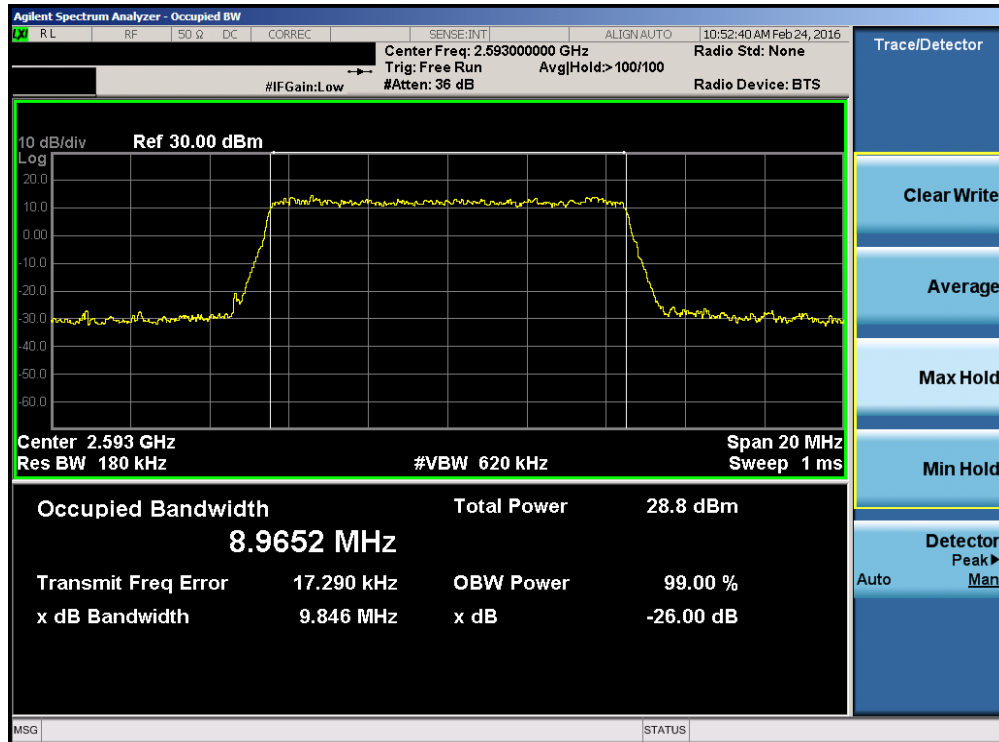


Plot 7-24. Occupied Bandwidth Plot (Band 41 – 5.0MHz 16-QAM – RB Size 25)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 25 of 94

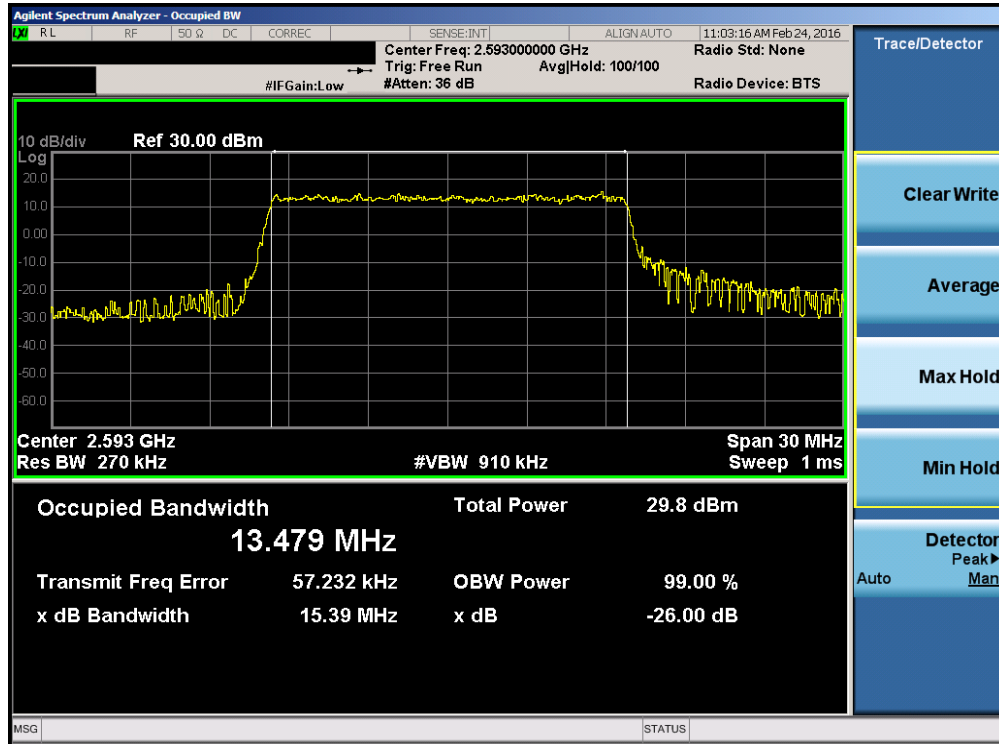


Plot 7-25. Occupied Bandwidth Plot (Band 41 – 10.0MHz QPSK – RB Size 50)

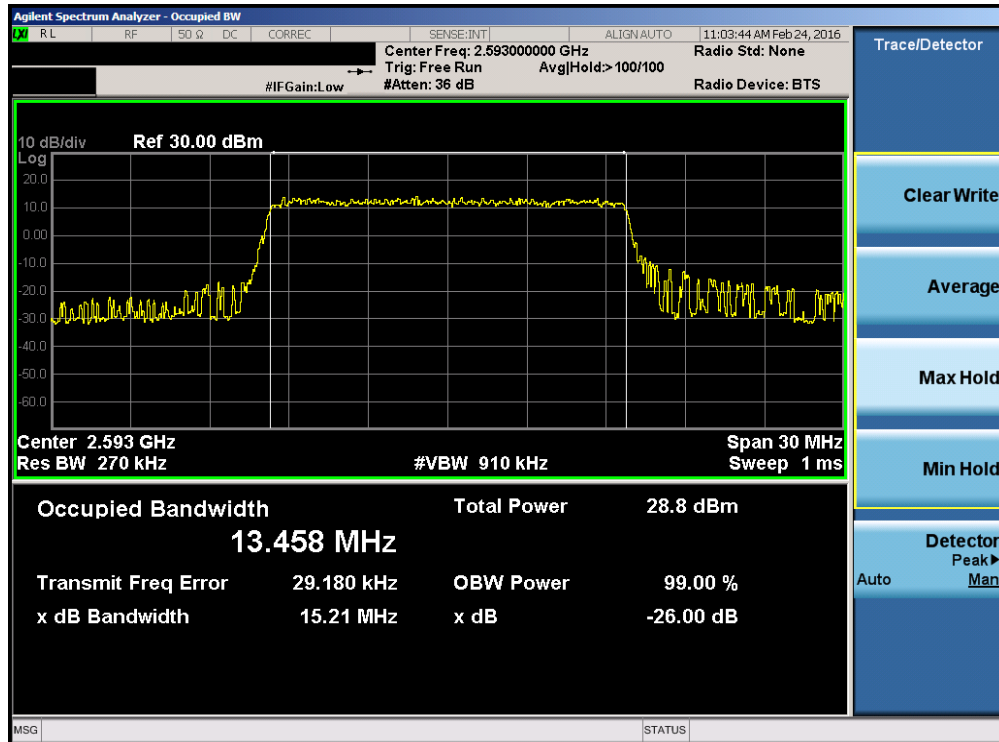


Plot 7-26. Occupied Bandwidth Plot (Band 41 – 10.0MHz 16-QAM – RB Size 50)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 26 of 94

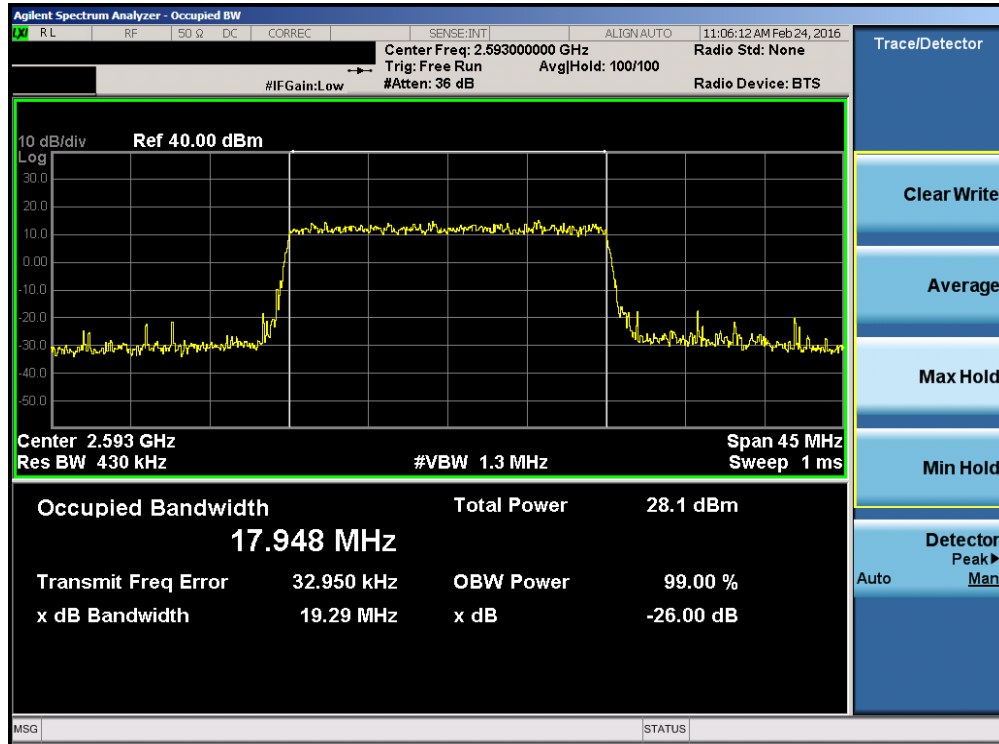


Plot 7-27. Occupied Bandwidth Plot (Band 41 – 15.0MHz QPSK – RB Size 75)

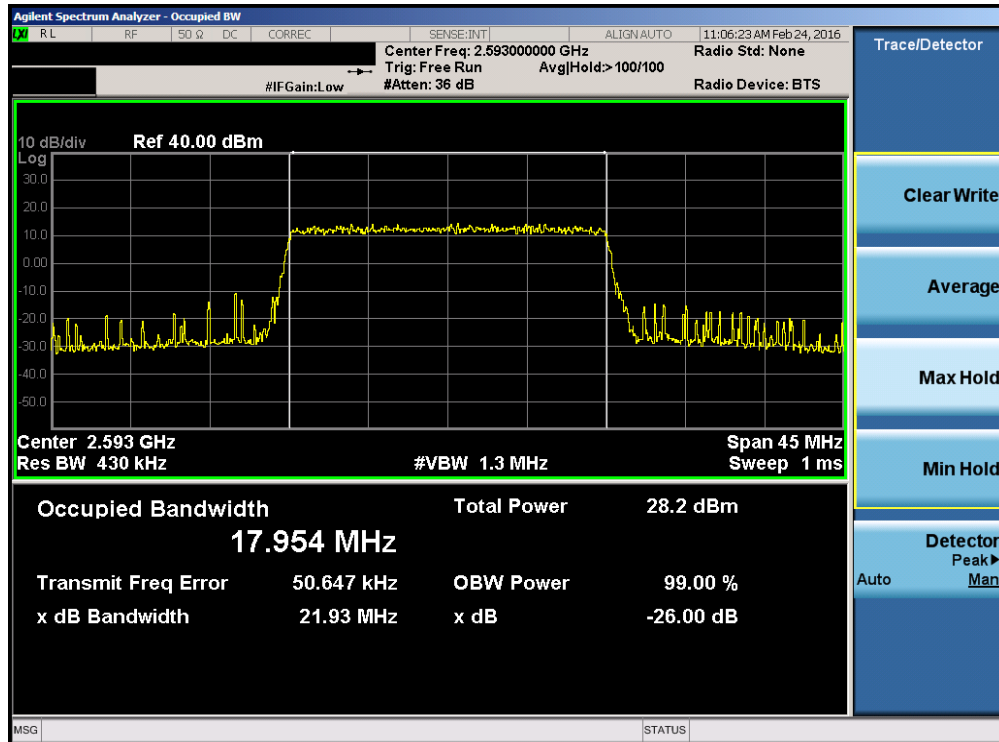


Plot 7-28. Occupied Bandwidth Plot (Band 41 – 15.0MHz 16-QAM – RB Size 75)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 27 of 94



Plot 7-29. Occupied Bandwidth Plot (Band 41 – 20.0MHz QPSK – RB Size 100)



Plot 7-30. Occupied Bandwidth Plot (Band 41 – 20.0MHz 16-QAM – RB Size 100)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 28 of 94

7.3 Spurious and Harmonic Emissions at Antenna Terminal

§2.1051 §22.917(a) §24.238(a) §27.53(m)

Test Overview

The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies. All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

For Band 41, the minimum permissible attenuation level of any spurious emission is $55 + \log_{10}(P_{[Watts]})$.

The minimum permissible attenuation level of any spurious emission is $43 + \log_{10}(P_{[Watts]})$, where P is the transmitter power in Watts.

Test Procedure Used

KDB 971168 D01 v02r02 – Section 6.0

Test Settings

1. Start frequency was set to 30MHz and stop frequency was set to at least 10 * the fundamental frequency (separated into at least two plots per channel)
2. Detector = RMS
3. Trace mode = trace average for continuous emissions, max hold for pulse emissions
4. Sweep time = auto couple
5. The trace was allowed to stabilize
6. Please see test notes below for RBW and VBW settings

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

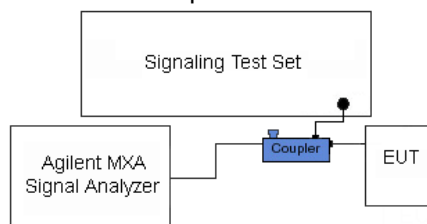


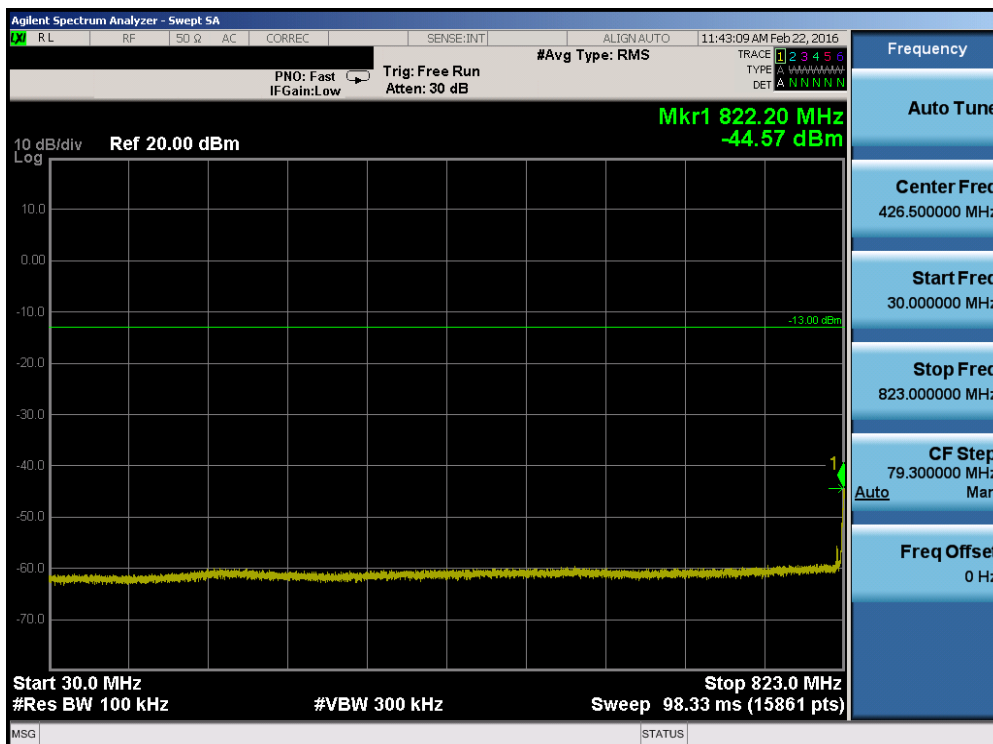
Figure 7-2. Test Instrument & Measurement Setup

Test Notes

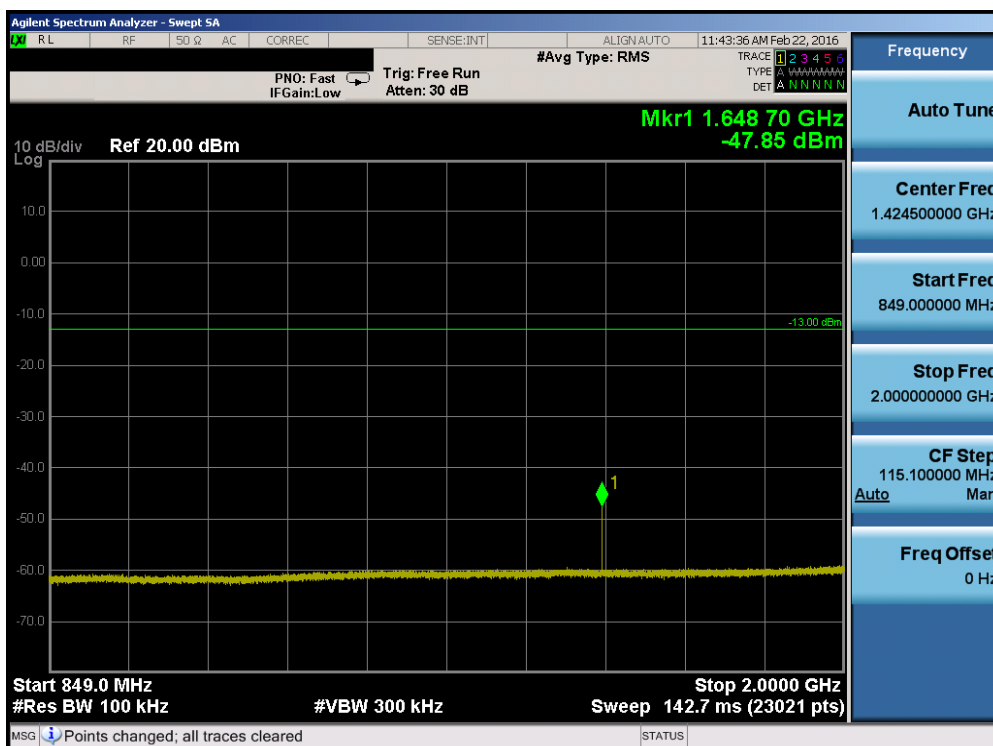
Compliance with the applicable limits is based on the use of measurement instrumentation employing a resolution bandwidth of 100 kHz or greater for frequencies less than 1 GHz and 1 MHz or greater for frequencies greater than 1 GHz. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission bandwidth is defined as the

FCC ID: A3LSMJ120P		FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 29 of 94

width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

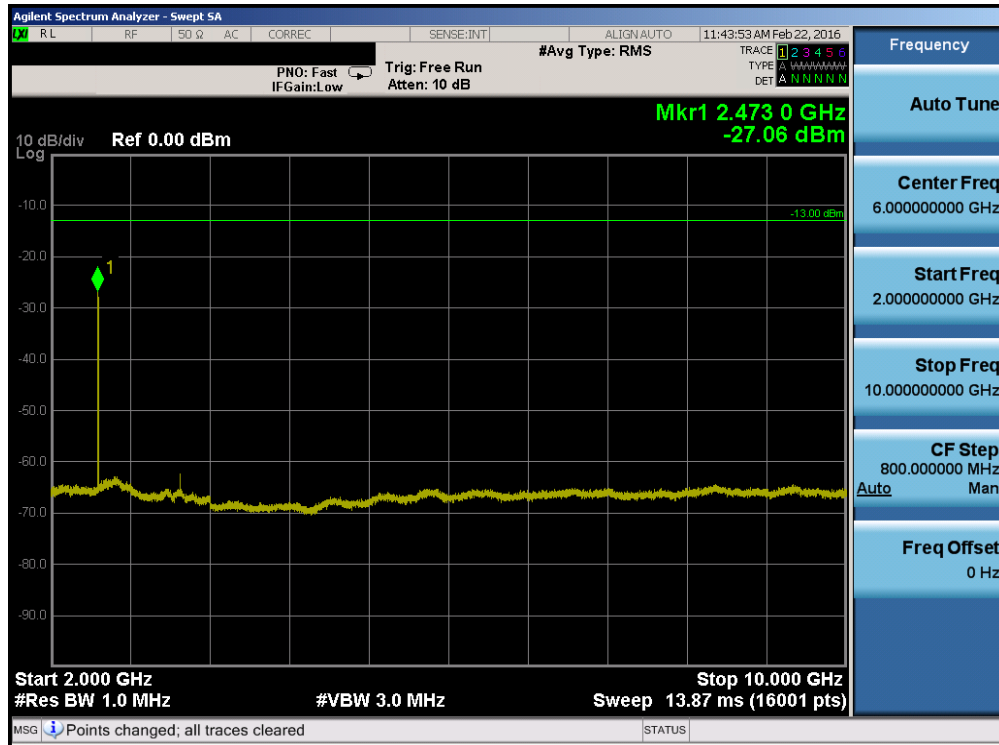


Plot 7-31. Conducted Spurious Plot (Band 26 – 5.0MHz QPSK – RB Size 1, RB Offset 0 – Low Channel)

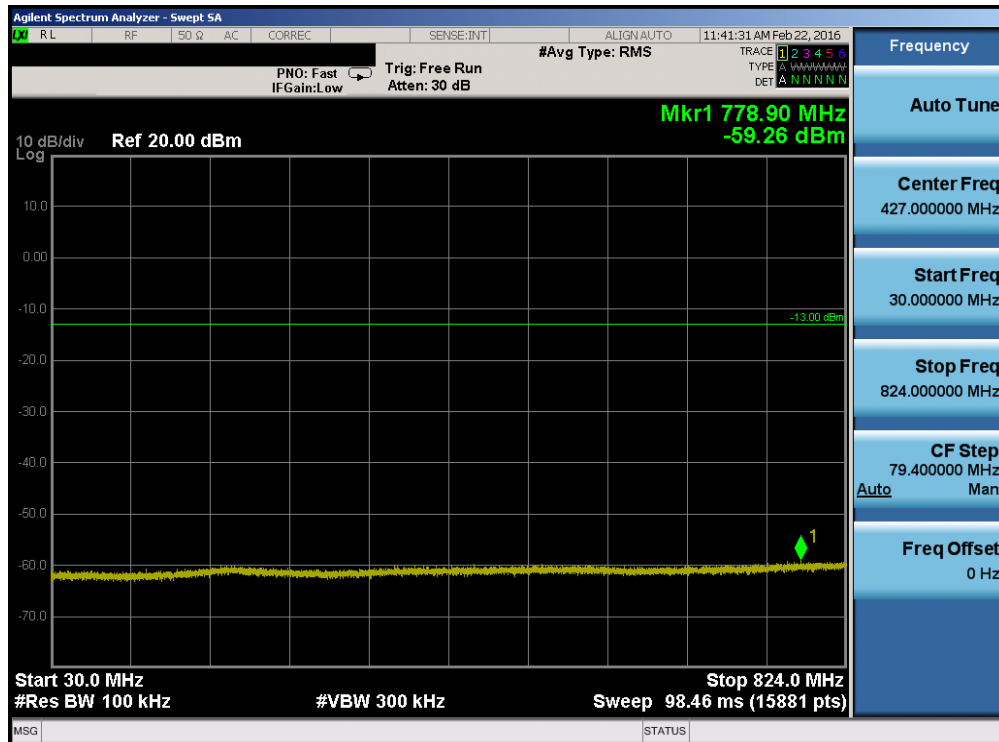


Plot 7-32. Conducted Spurious Plot (Band 26 – 5.0MHz QPSK – RB Size 1, RB Offset 0 – Low Channel)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 30 of 94

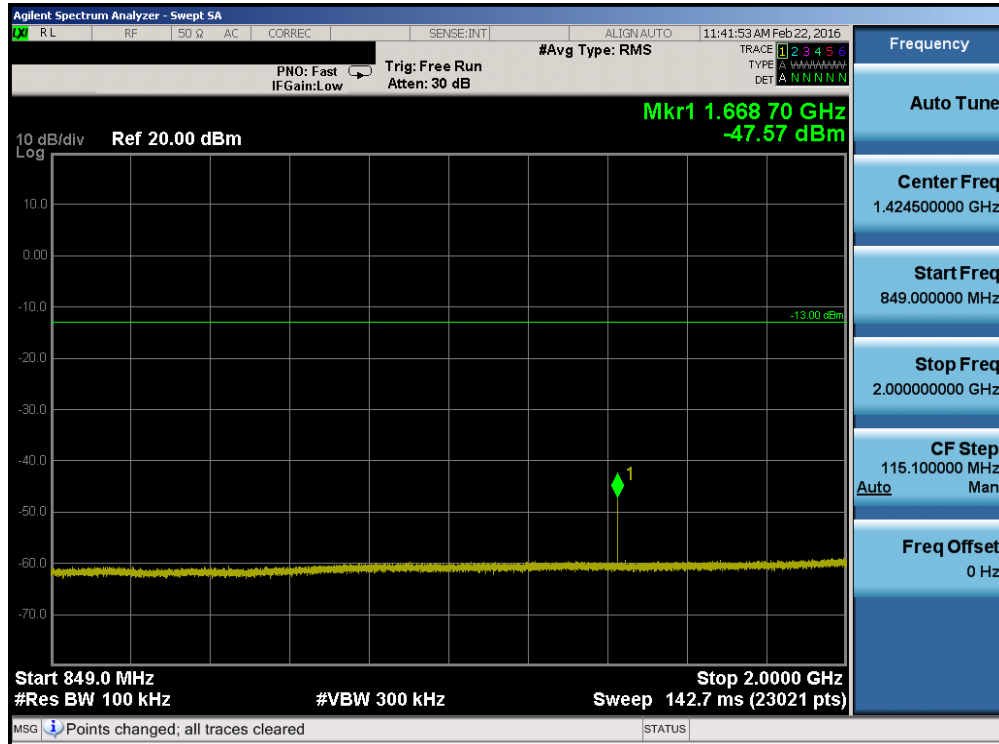


Plot 7-33. Conducted Spurious Plot (Band 26 – 5.0MHz QPSK – RB Size 1, RB Offset 0 – Low Channel)

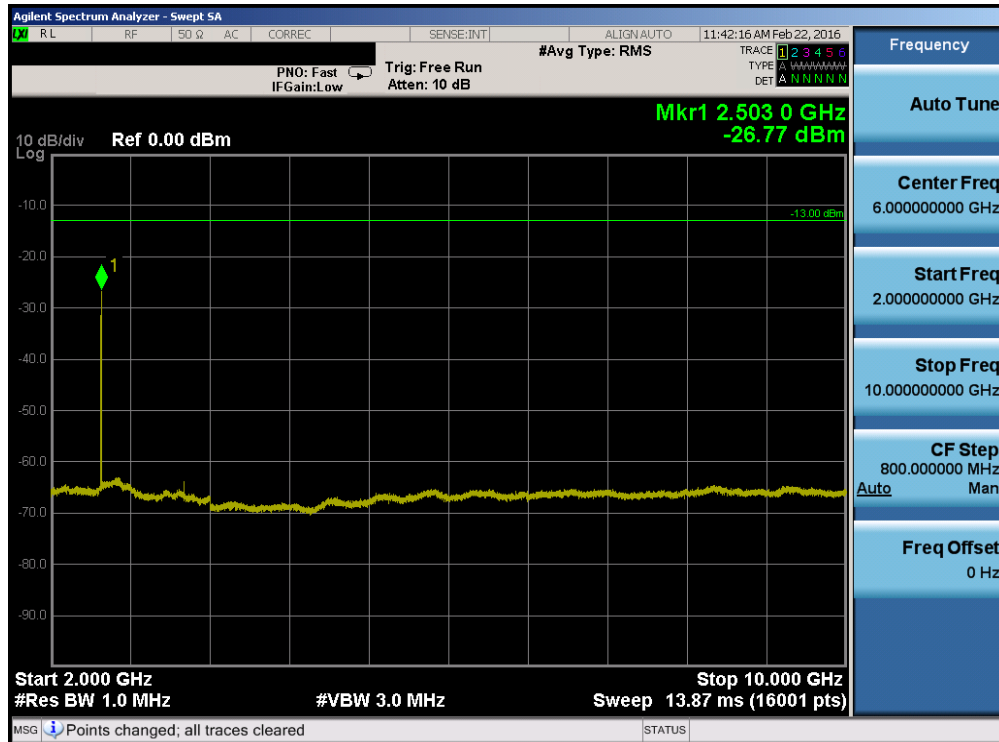


Plot 7-34. Conducted Spurious Plot (Band 26 – 5.0MHz QPSK – RB Size 1, RB Offset 0 – Mid Channel)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 31 of 94

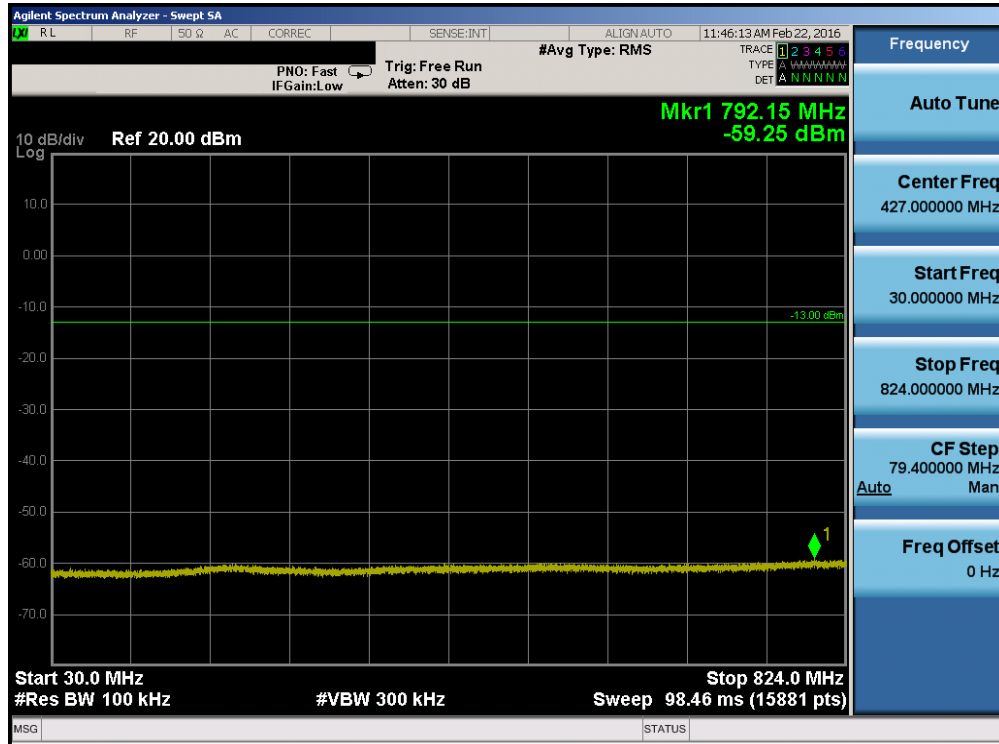


Plot 7-35. Conducted Spurious Plot (Band 26 – 5.0MHz QPSK – RB Size 1, RB Offset 0 – Mid Channel)

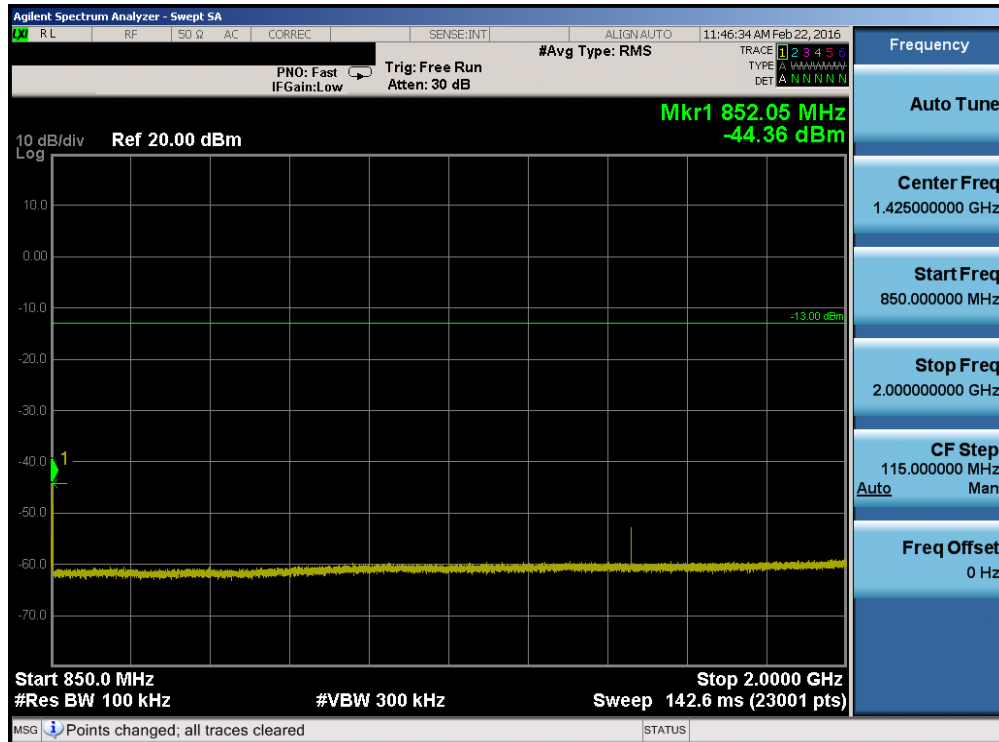


Plot 7-36. Conducted Spurious Plot (Band 26 – 5.0MHz QPSK – RB Size 1, RB Offset 0 – Mid Channel)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 32 of 94

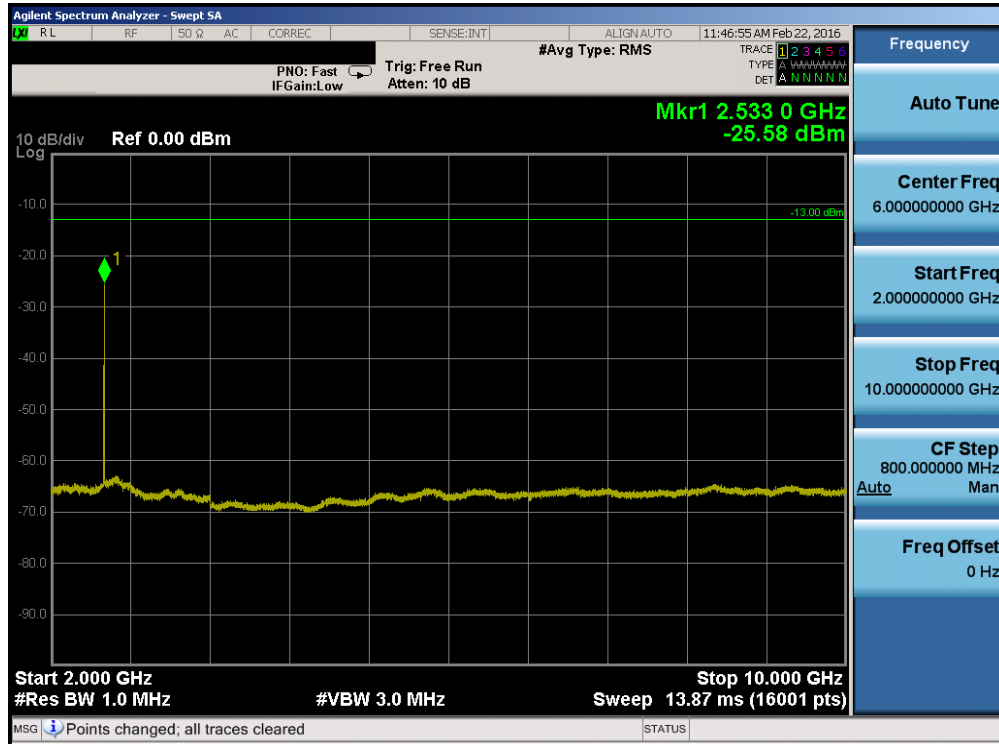


Plot 7-37. Conducted Spurious Plot (Band 26 – 5.0MHz QPSK – RB Size 1, RB Offset 0 – High Channel)

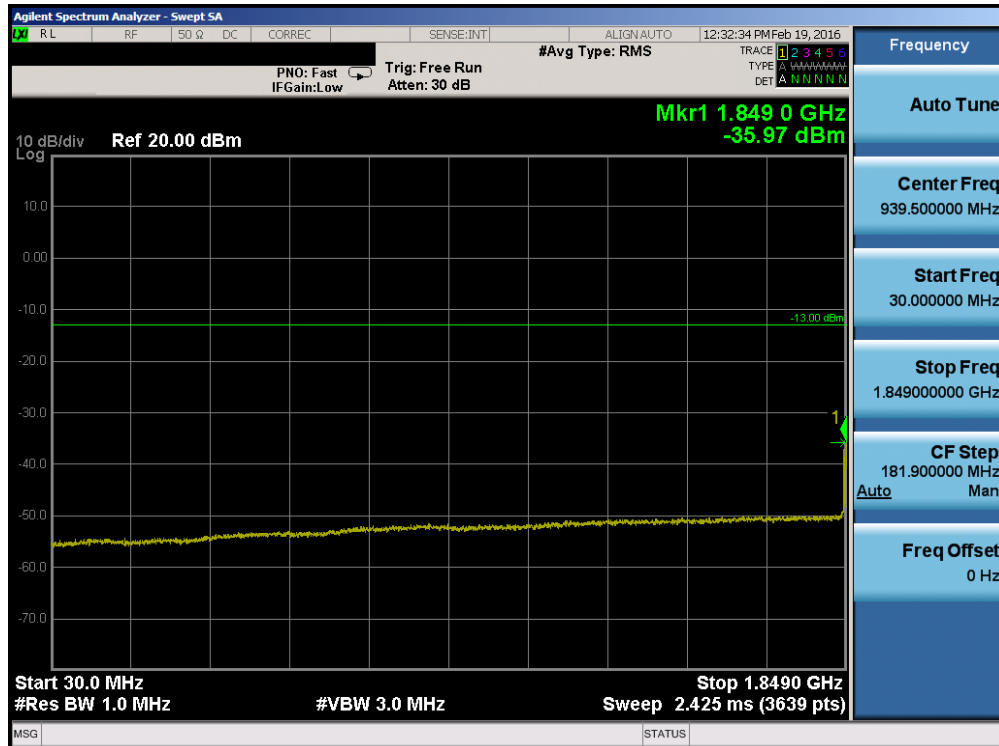


Plot 7-38. Conducted Spurious Plot (Band 26 – 5.0MHz QPSK – RB Size 1, RB Offset 0 – High Channel)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 33 of 94

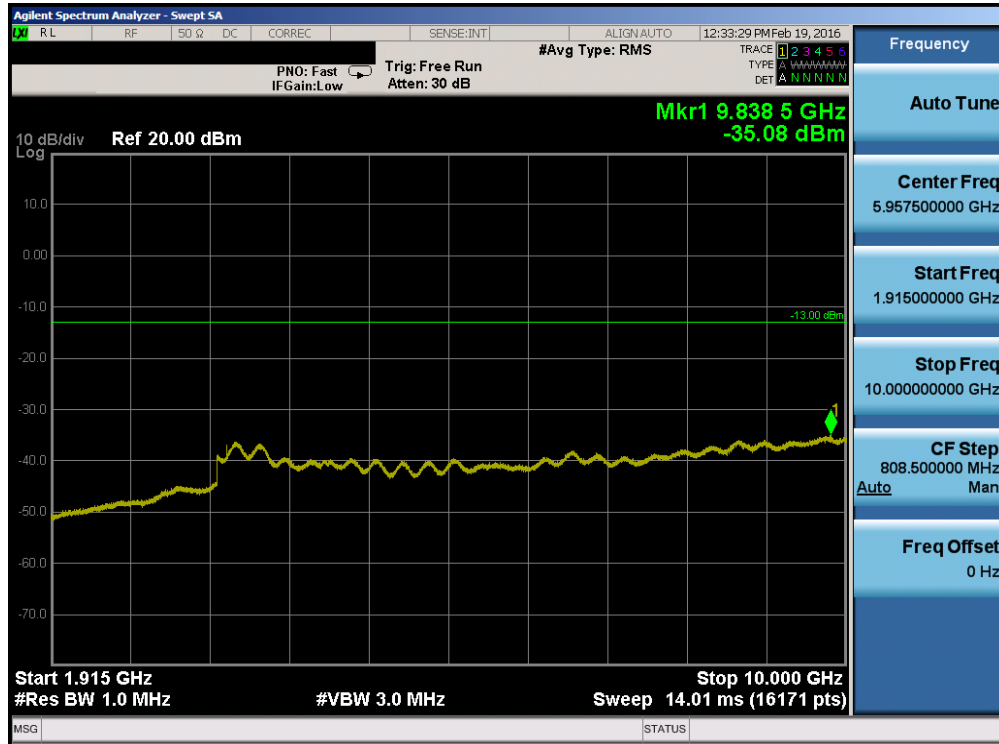


Plot 7-39. Conducted Spurious Plot (Band 26 – 5.0MHz QPSK – RB Size 1, RB Offset 0 – High Channel)

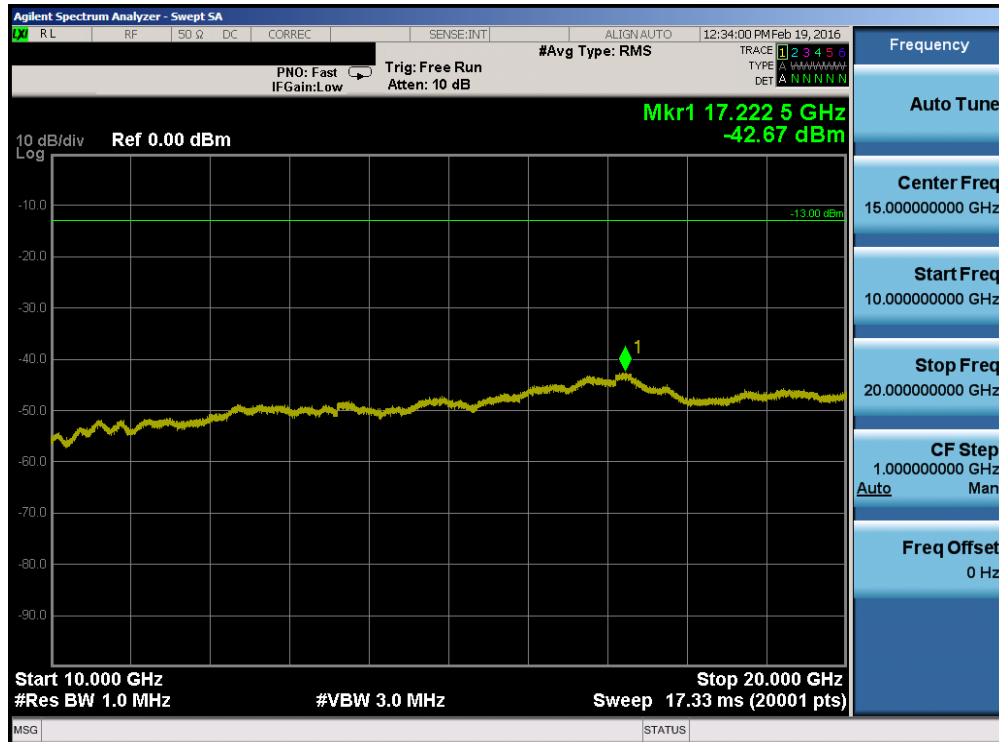


Plot 7-40. Conducted Spurious Plot (Band 25 – 20.0MHz QPSK – RB Size 1, RB Offset 0– Low Channel)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 34 of 94

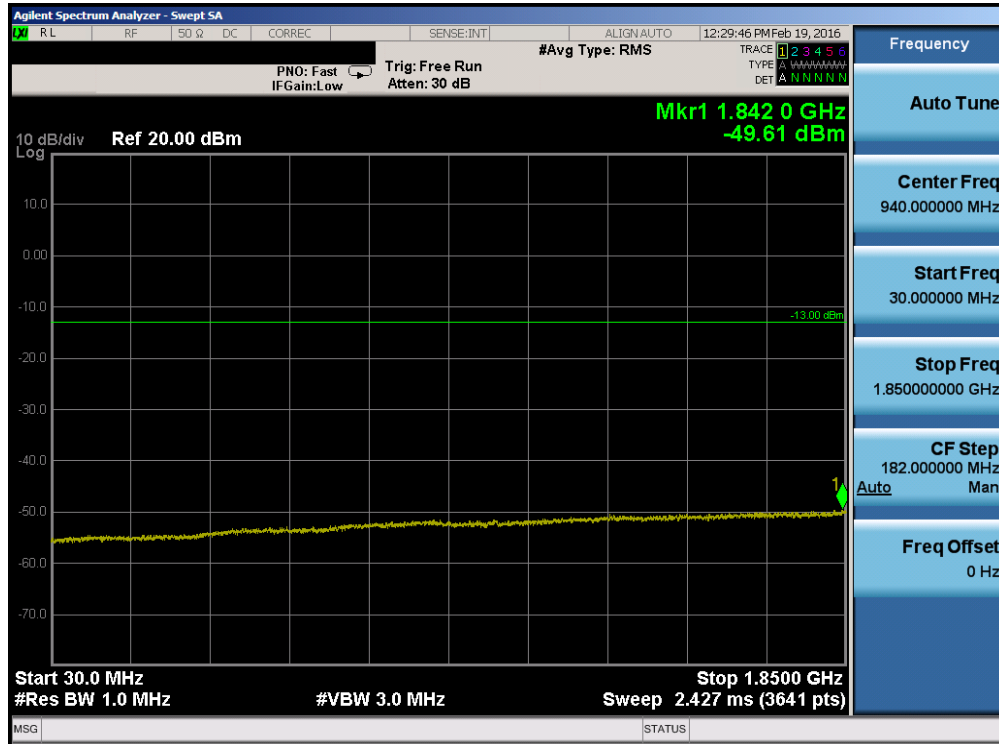


Plot 7-41. Conducted Spurious Plot (Band 25 – 20.0MHz QPSK – RB Size 1, RB Offset 0 – Low Channel)

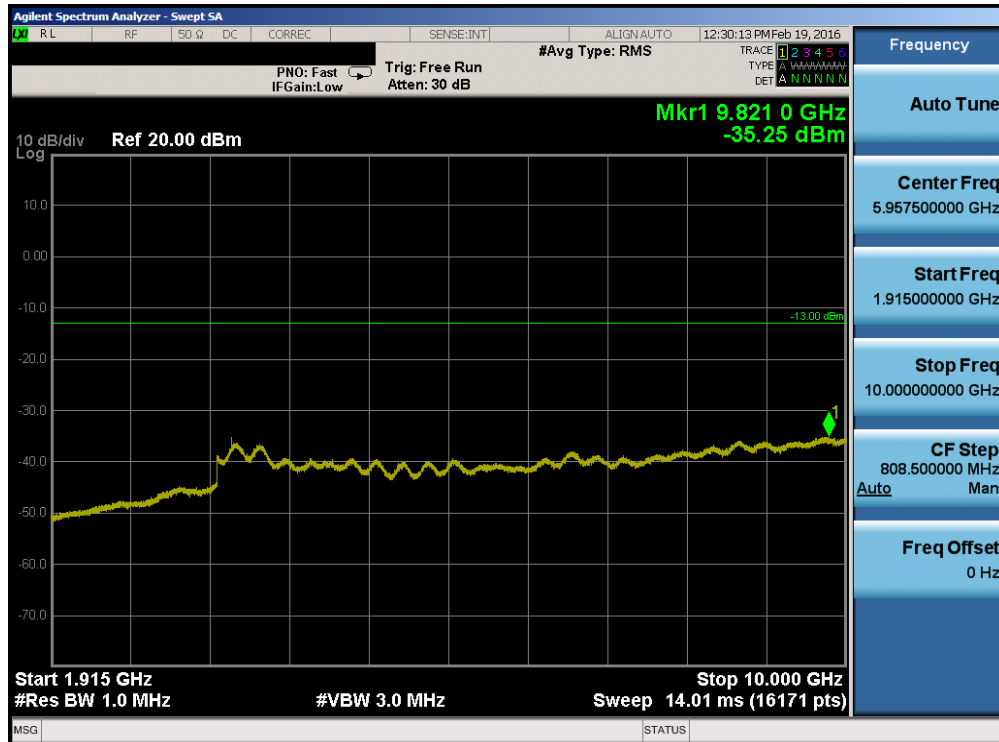


Plot 7-42. Conducted Spurious Plot (Band 25 – 20.0MHz QPSK – RB Size 1, RB Offset 0 – Low Channel)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 35 of 94

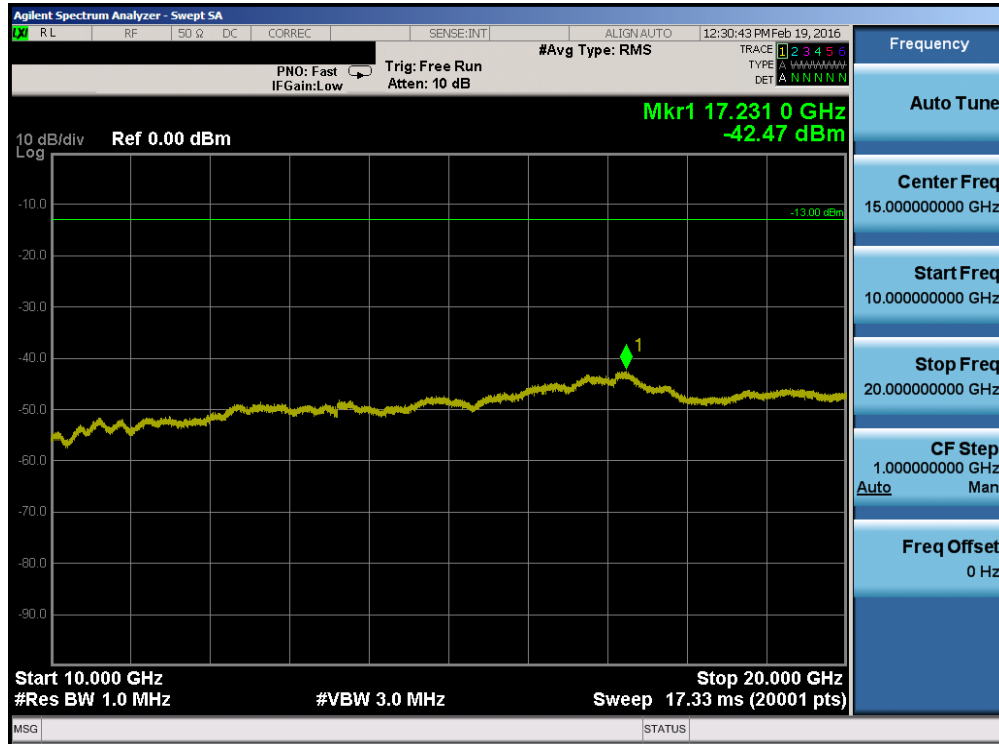


Plot 7-43. Conducted Spurious Plot (Band 25 – 20.0MHz QPSK – RB Size 1, RB Offset 0 – Mid Channel)

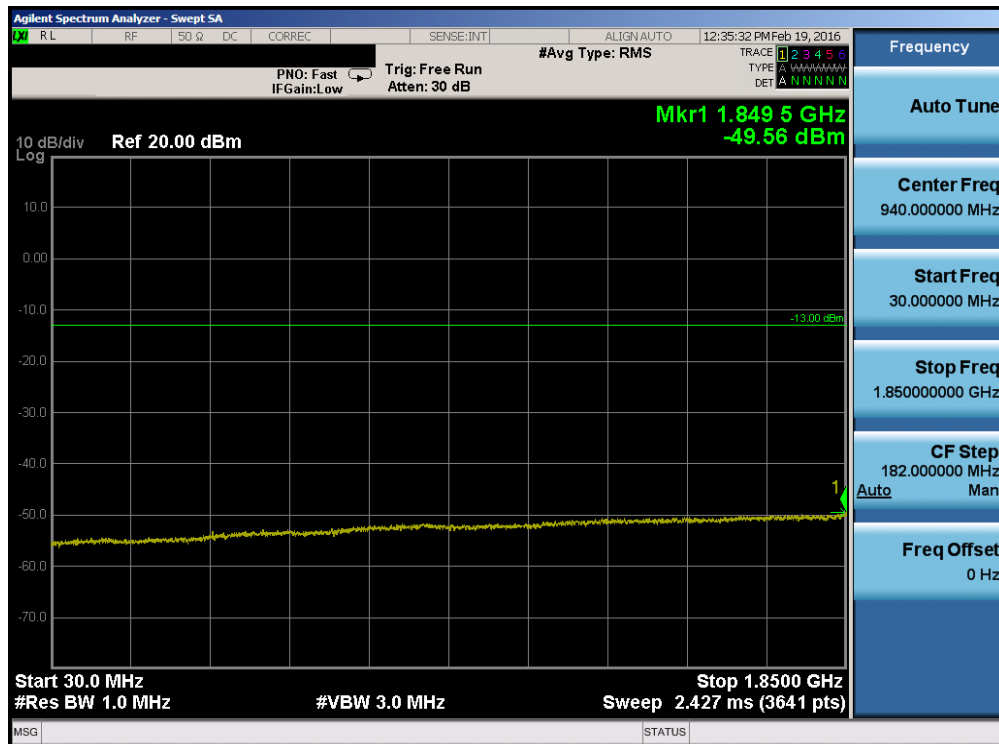


Plot 7-44. Conducted Spurious Plot (Band 25 – 20.0MHz QPSK – RB Size 1, RB Offset 0 – Mid Channel)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 36 of 94

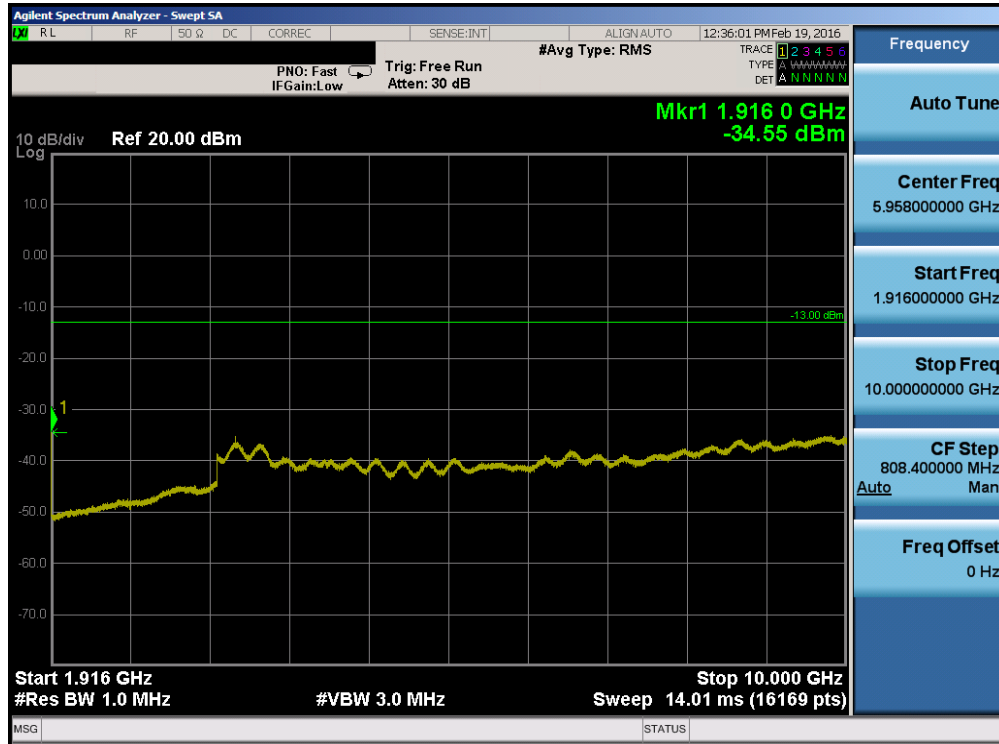


Plot 7-45. Conducted Spurious Plot (Band 25 – 20.0MHz QPSK – RB Size 1, RB Offset 0 – Mid Channel)

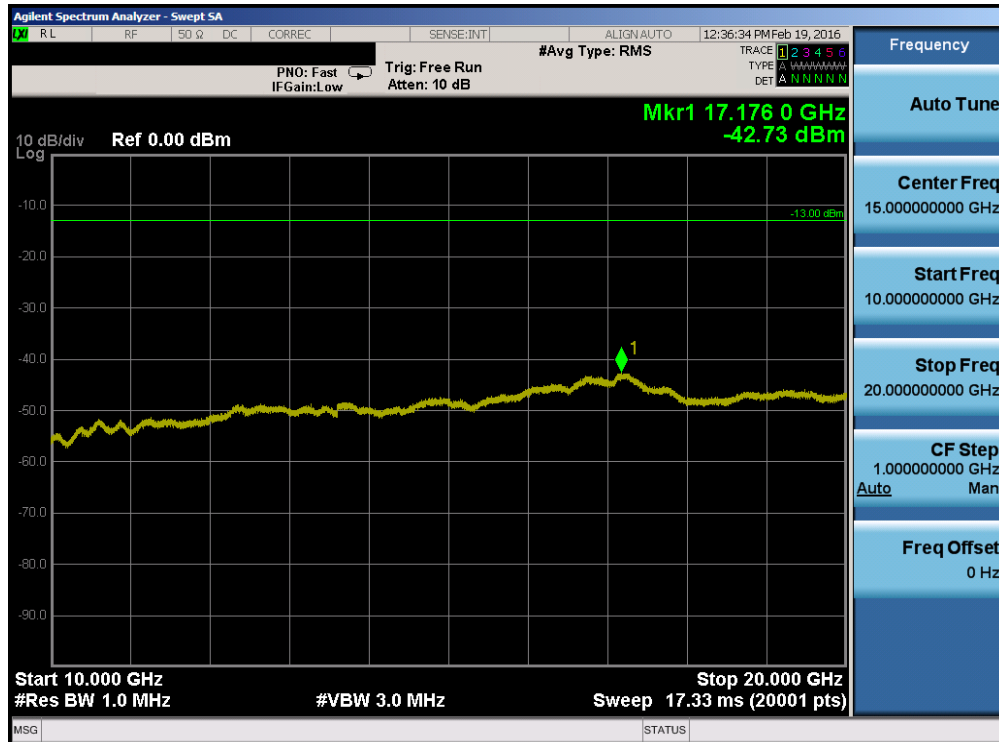


Plot 7-46. Conducted Spurious Plot (Band 25 – 20.0MHz QPSK – RB Size 1, RB Offset 0 – High Channel)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 37 of 94

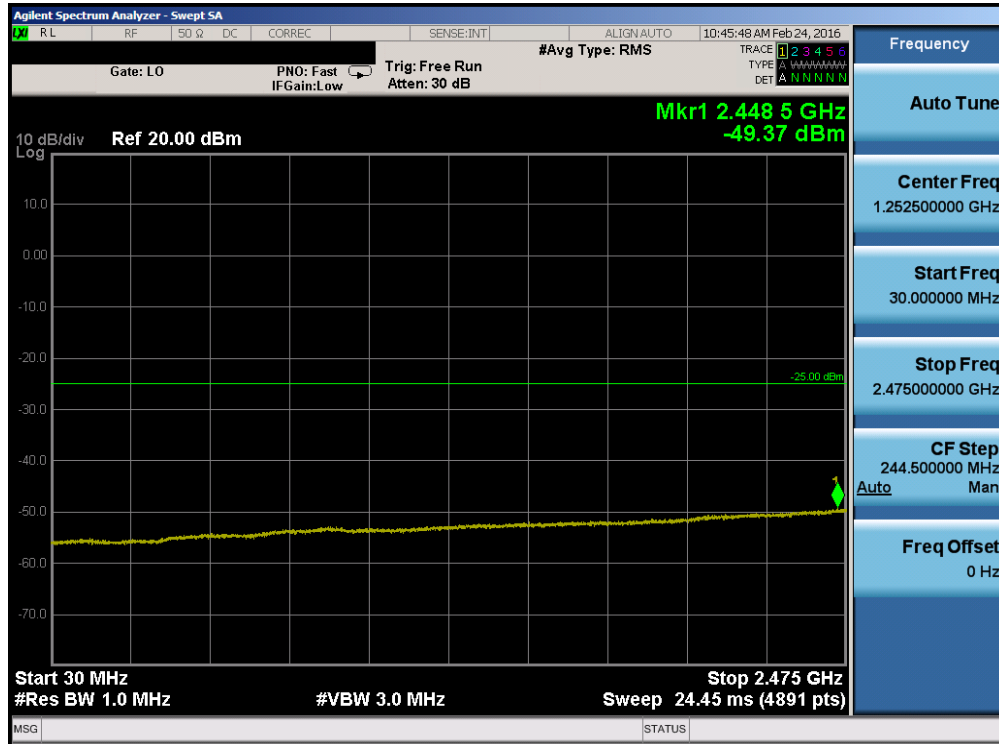


Plot 7-47. Conducted Spurious Plot (Band 25 – 20.0MHz QPSK – RB Size 1, RB Offset 0 – High Channel)

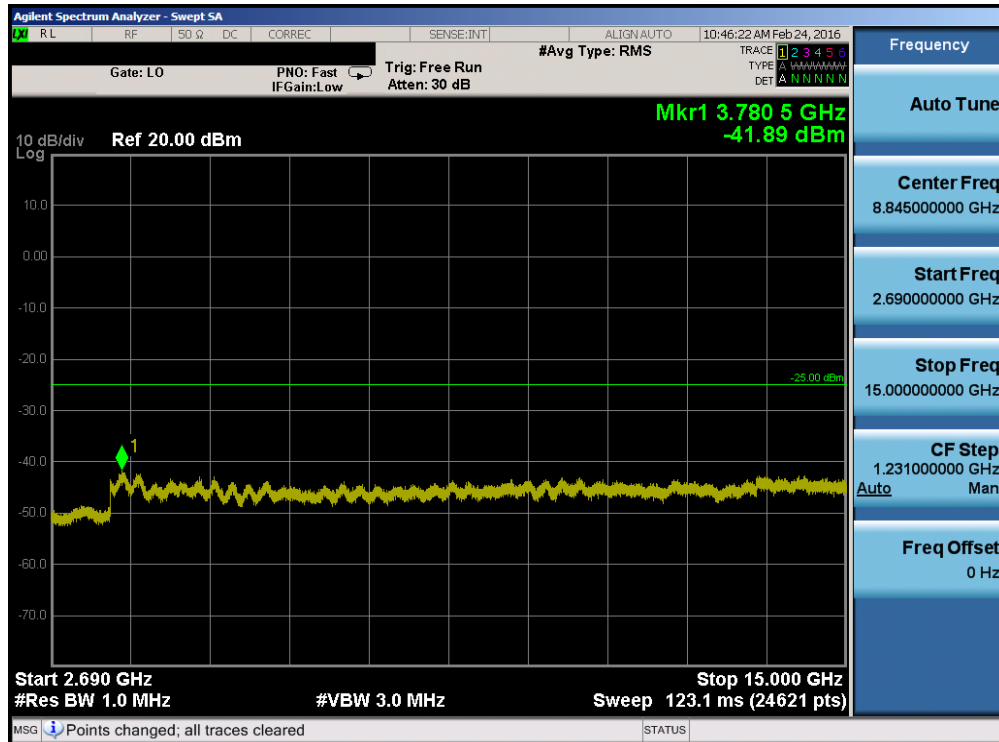


Plot 7-48. Conducted Spurious Plot (Band 25 – 20.0MHz QPSK – RB Size 1, RB Offset 0 – High Channel)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 38 of 94

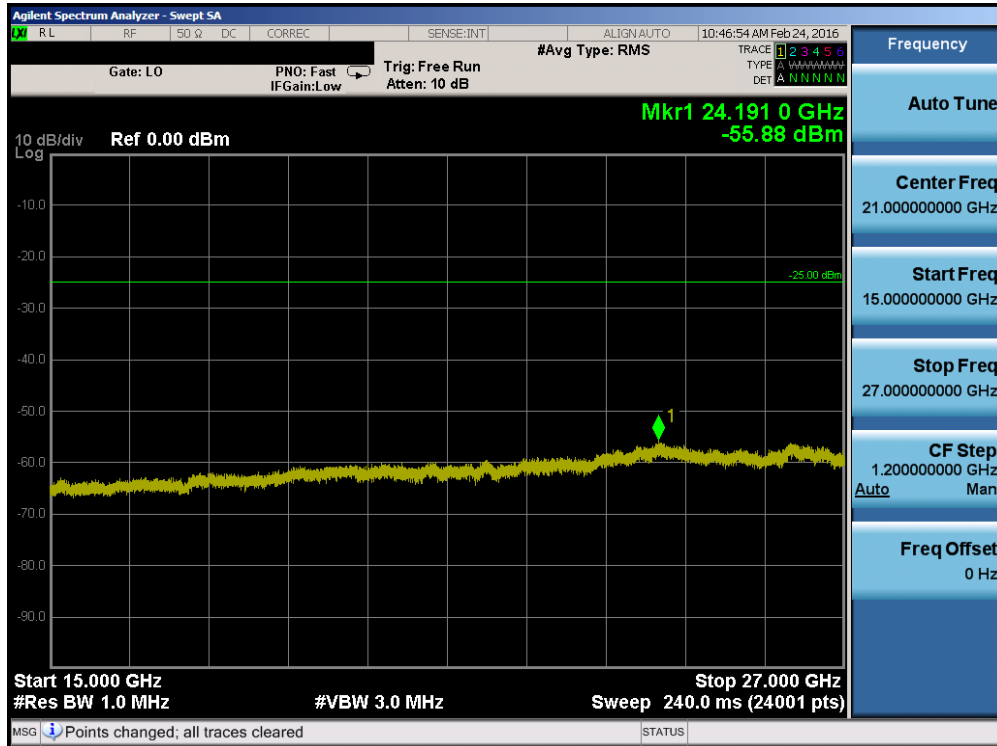


Plot 7-49. Conducted Spurious Plot (Band 41 – 5.0MHz QPSK – RB Size 1, RB Offset 0 – Low Channel)



Plot 7-50. Conducted Spurious Plot (Band 41 – 5.0MHz QPSK – RB Size 1, RB Offset 0 – Low Channel)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 39 of 94

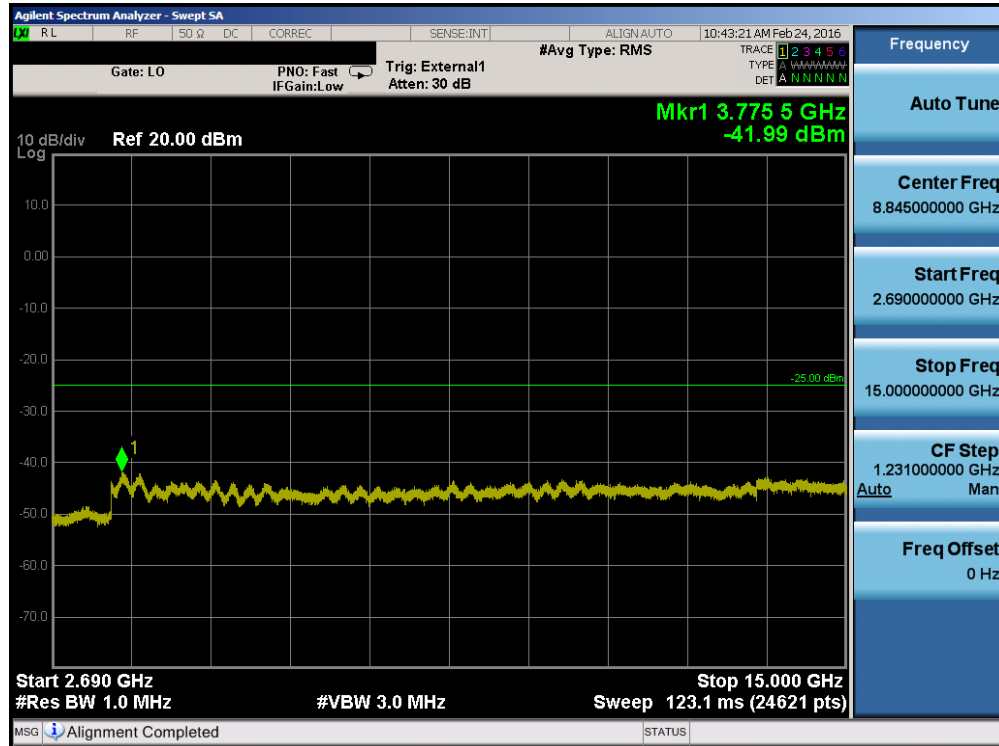


Plot 7-51. Conducted Spurious Plot (Band 41 – 5.0MHz QPSK – RB Size 1, RB Offset 0 – Low Channel)

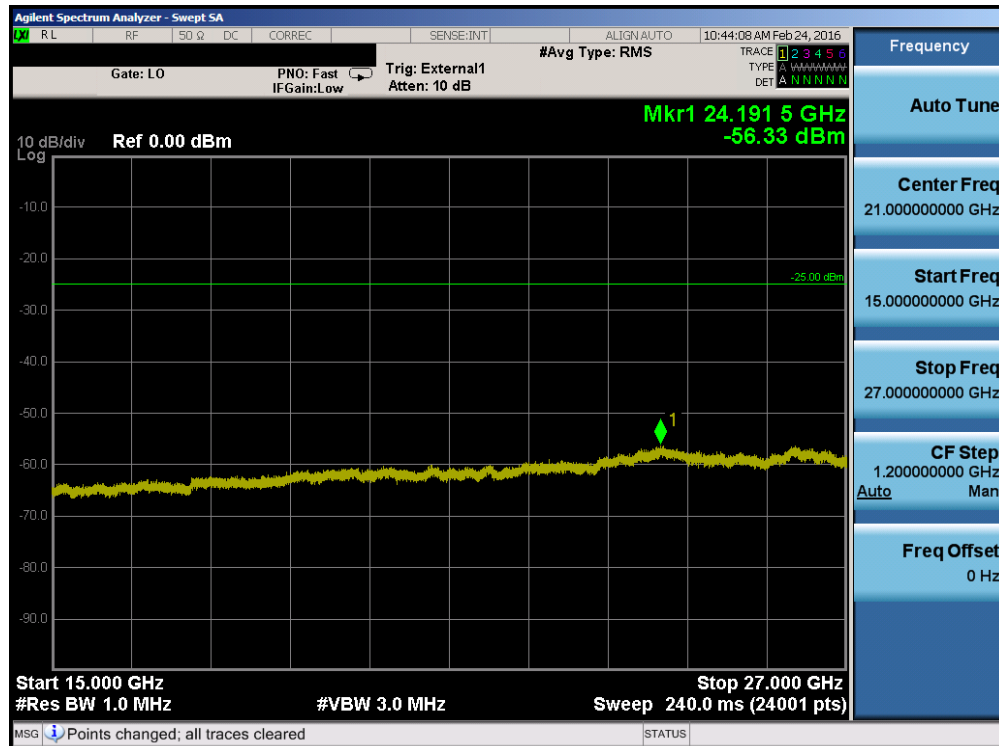


Plot 7-52. Conducted Spurious Plot (Band 41 – 5.0MHz QPSK – RB Size 1, RB Offset 0 – Mid Channel)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 40 of 94

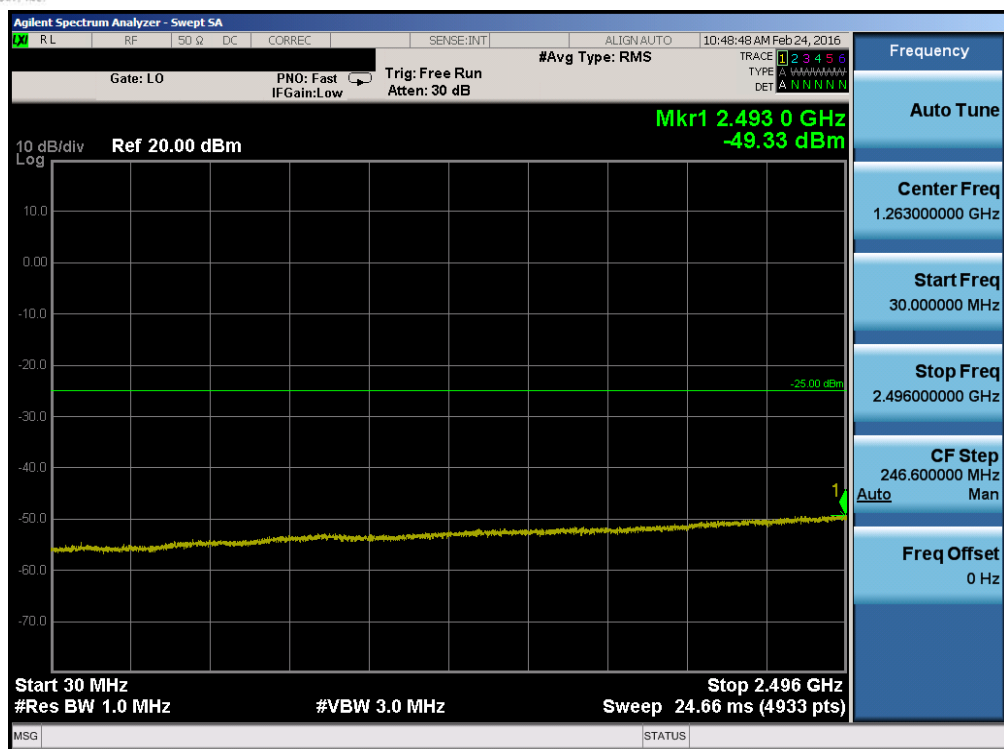


Plot 7-53. Conducted Spurious Plot (Band 41 – 5.0MHz QPSK – RB Size 1, RB Offset 0 – Mid Channel)

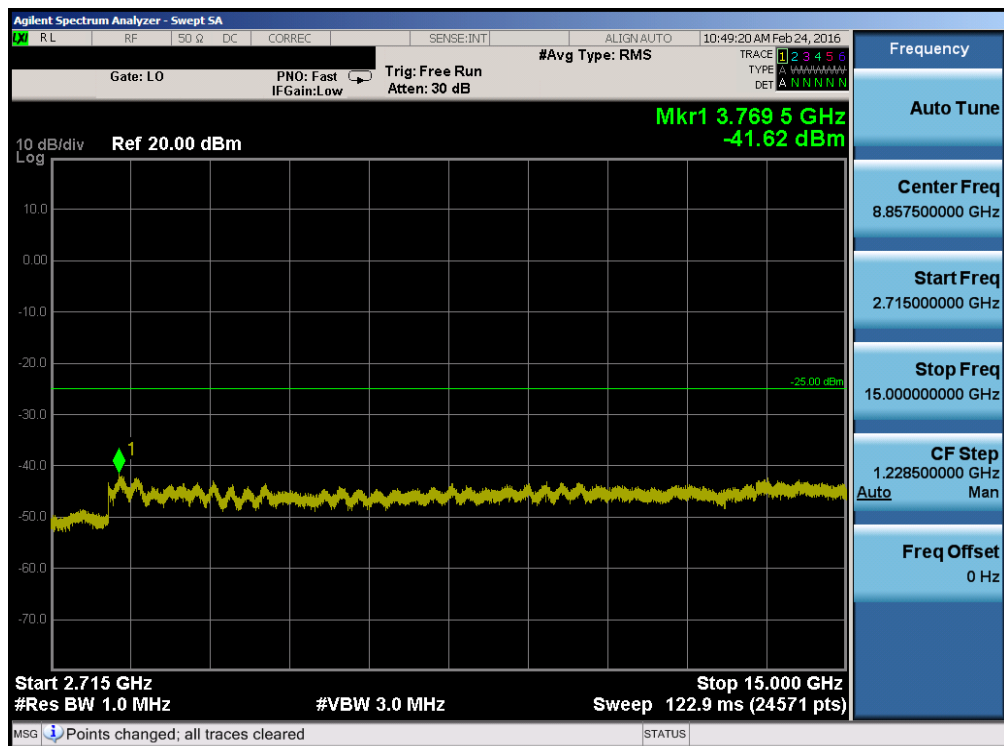


Plot 7-54. Conducted Spurious Plot (Band 41 – 5.0MHz QPSK – RB Size 1, RB Offset 0 – Mid Channel)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 41 of 94



Plot 7-55. Conducted Spurious Plot (Band 41 – 5.0MHz QPSK – RB Size 1, RB Offset 0 – High Channel)



Plot 7-56. Conducted Spurious Plot (Band 41 – 5.0MHz QPSK – RB Size 1, RB Offset 0 – High Channel)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 42 of 94



Plot 7-57. Conducted Spurious Plot (Band 41 – 5.0MHz QPSK – RB Size 1, RB Offset 0 – High Channel)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 43 of 94

7.4 Band Edge Emissions at Antenna Terminal

\$2.1051 \$22.917(a) \$24.238(a) \$27.53(m)

Test Overview

All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies. All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

The minimum permissible attenuation level for Band 41 is as noted in the Test Notes on the following page.

The minimum permissible attenuation level of any spurious emission is $43 + \log_{10}(P_{[Watts]})$, where P is the transmitter power in Watts.

Test Procedure Used

KDB 971168 D01 v02r02 – Section 6.0

Test Settings

1. Start and stop frequency were set such that the band edge would be placed in the center of the plot
2. Span was set large enough so as to capture all out of band emissions near the band edge
3. RBW $\geq 1\%$ of the emission bandwidth
4. VBW $\geq 3 \times$ RBW
5. Detector = RMS
6. Number of sweep points $\geq 2 \times$ Span/RBW
7. Trace mode = trace average for continuous emissions, max hold for pulse emissions
8. Sweep time = auto couple
9. The trace was allowed to stabilize

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

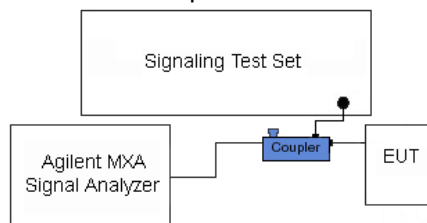


Figure 7-3. Test Instrument & Measurement Setup

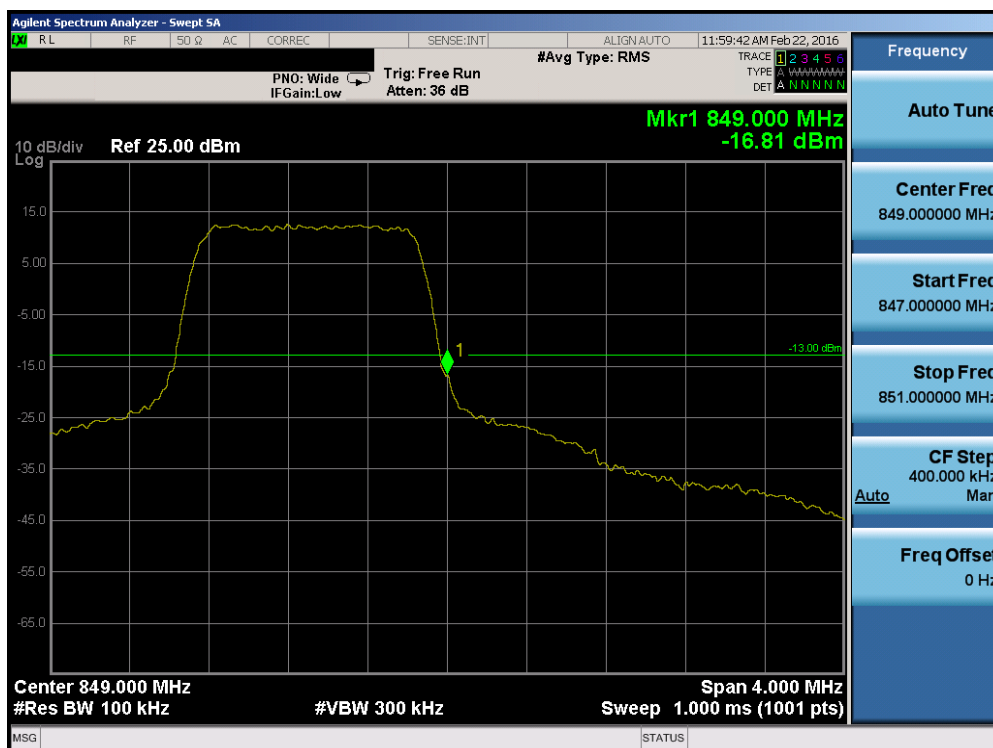
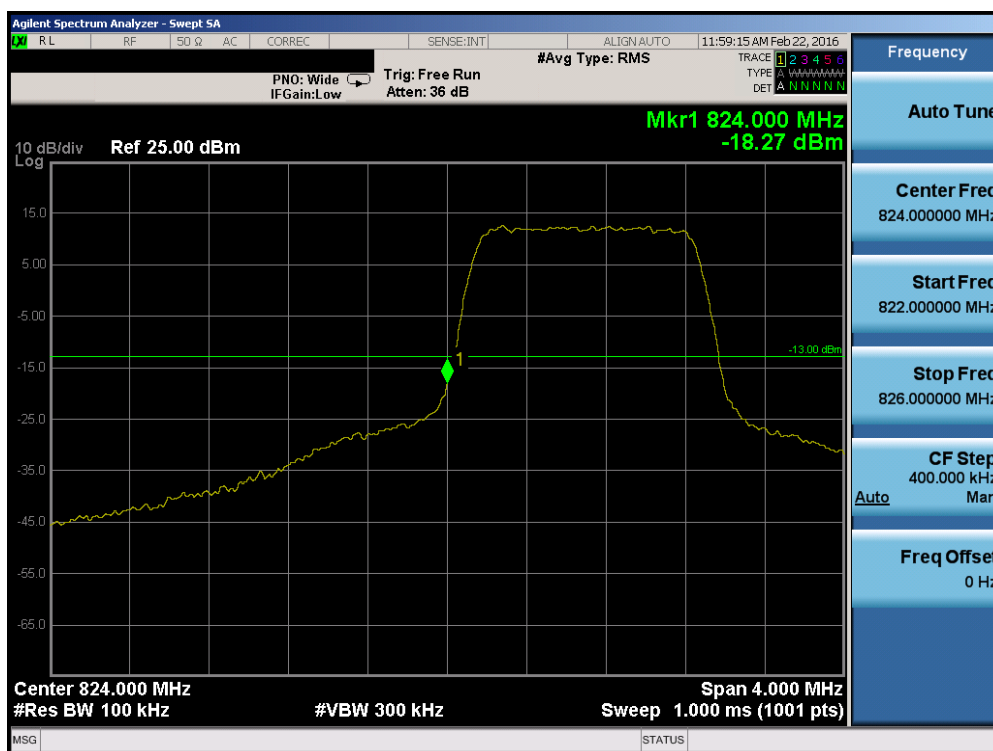
FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 44 of 94

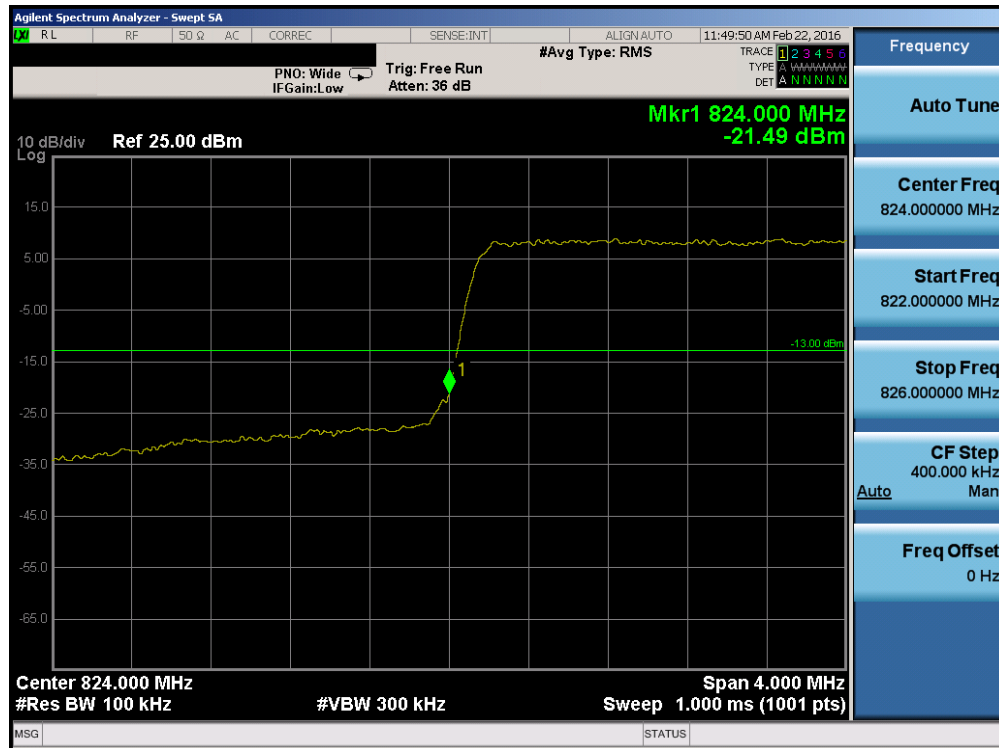
Test Notes

Per 22.917(b) 24.238(a) in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed to demonstrate compliance with the out-of-band emissions limit. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

Per 27.53(m) for operations in the BRS/EBS bands, the attenuation factor shall be not less than $40 + 10 \log(P)$ dB on all frequencies between the channel edge and 5 megahertz from the channel edge, $43 + 10 \log(P)$ dB on all frequencies between 5 megahertz and X megahertz from the channel edge, and $55 + 10 \log(P)$ dB on all frequencies more than X megahertz from the channel edge, where X is the greater of 6 megahertz or the actual emission bandwidth. In addition, the attenuation factor shall not be less than $43 + 10 \log(P)$ dB on all frequencies between 2490.5 MHz and 2496 MHz and $55 + 10 \log(P)$ dB at or below 2490.5 MHz.

FCC ID: A3LSMJ120P		FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)			Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset			Page 45 of 94



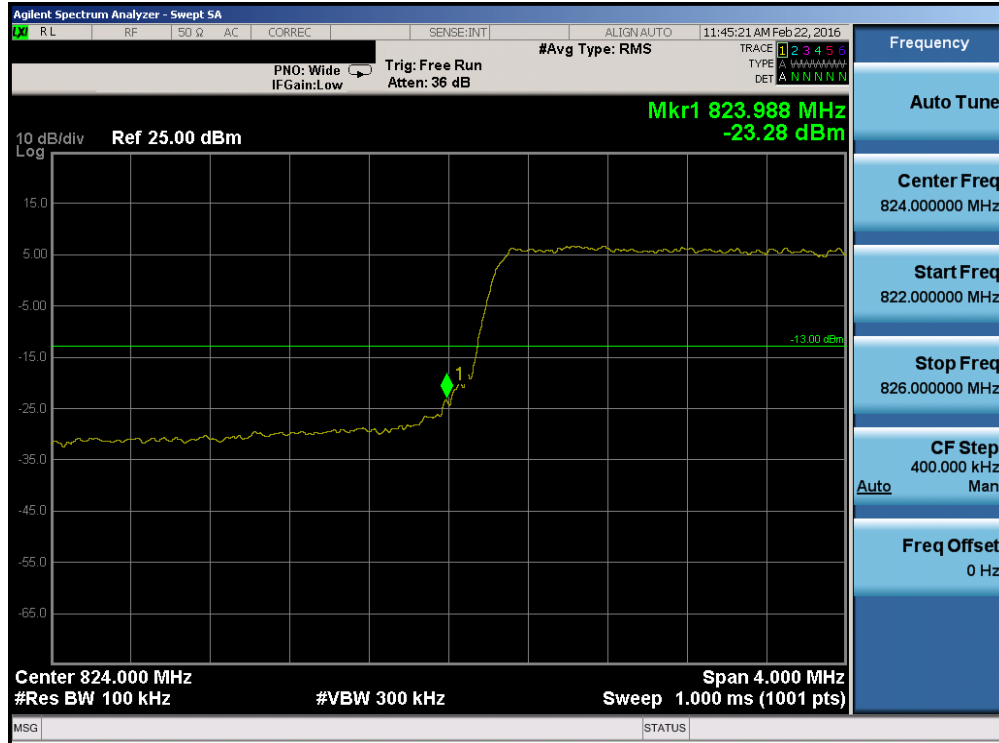


Plot 7-60. Lower Band Edge Plot (Band 26 – 3.0MHz QPSK – RB Size 15)

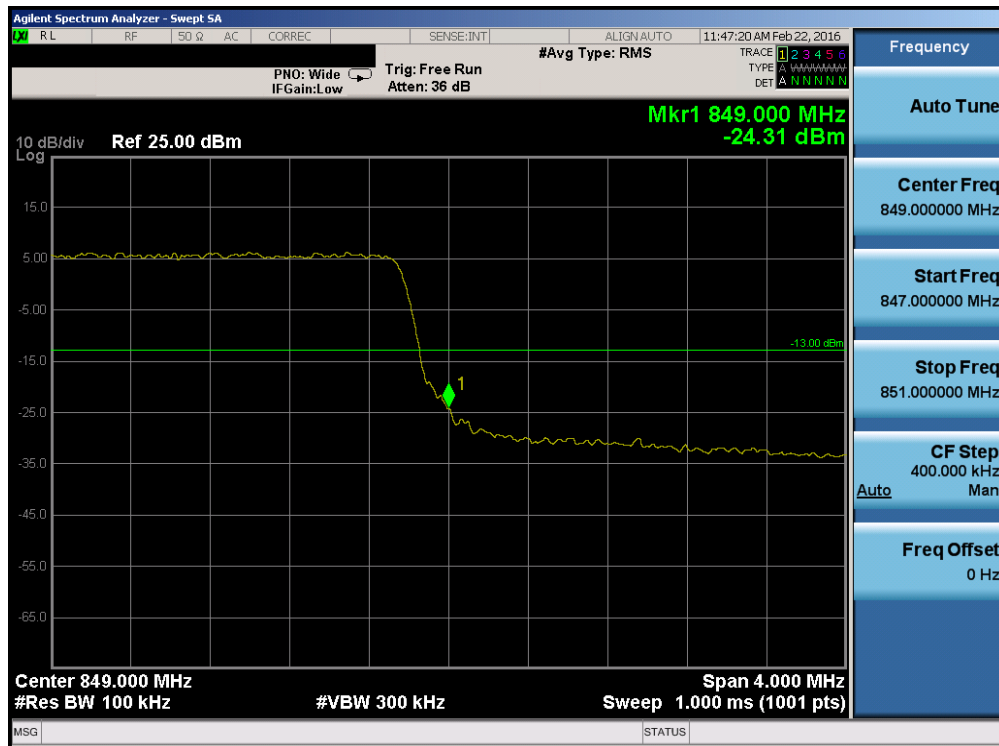


Plot 7-61. Upper Band Edge Plot (Band 26 – 3.0MHz QPSK – RB Size 15)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 47 of 94

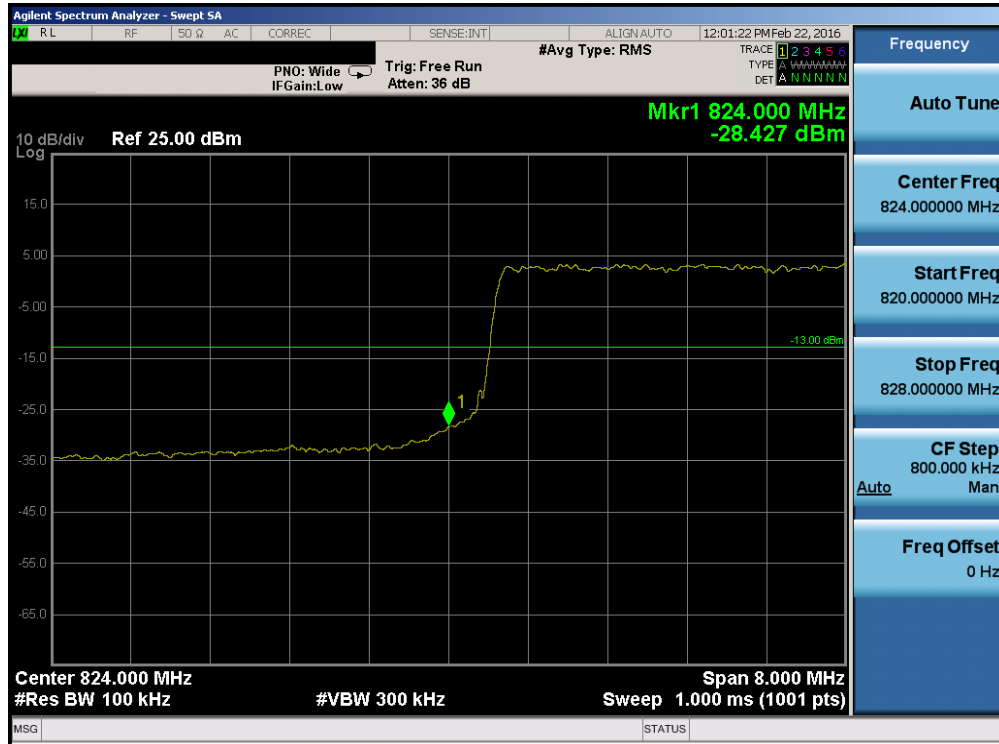


Plot 7-62. Lower Band Edge Plot (Band 26 – 5.0MHz QPSK – RB Size 25)



Plot 7-63. Upper Band Edge Plot (Band 26 – 5.0MHz QPSK – RB Size 25)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 48 of 94

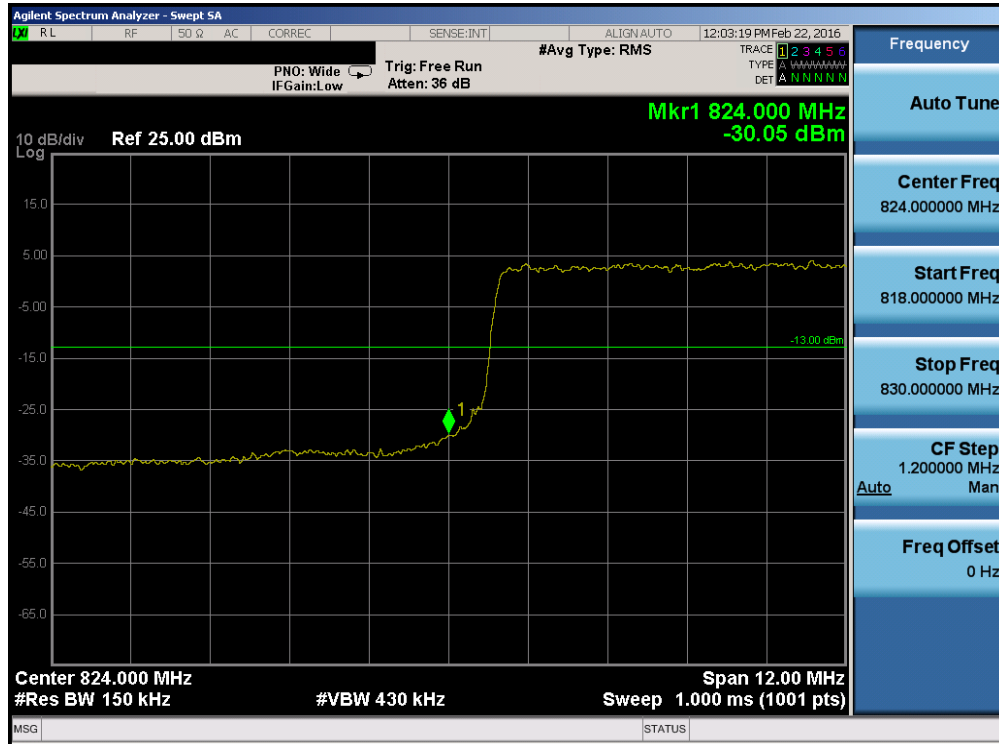


Plot 7-64. Lower Band Edge Plot (Band 26 – 10.0MHz QPSK – RB Size 50)



Plot 7-65. Upper Band Edge Plot (Band 26 – 10.0MHz QPSK – RB Size 50)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 49 of 94

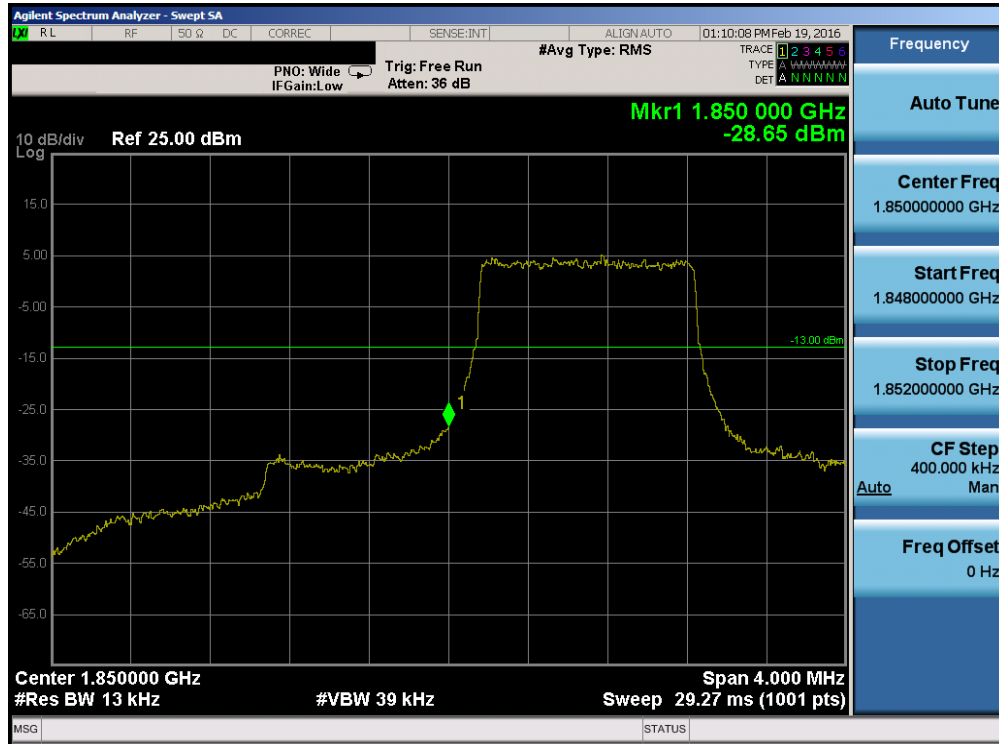


Plot 7-66. Lower Band Edge Plot (Band 26 – 15.0MHz QPSK – RB Size 75)

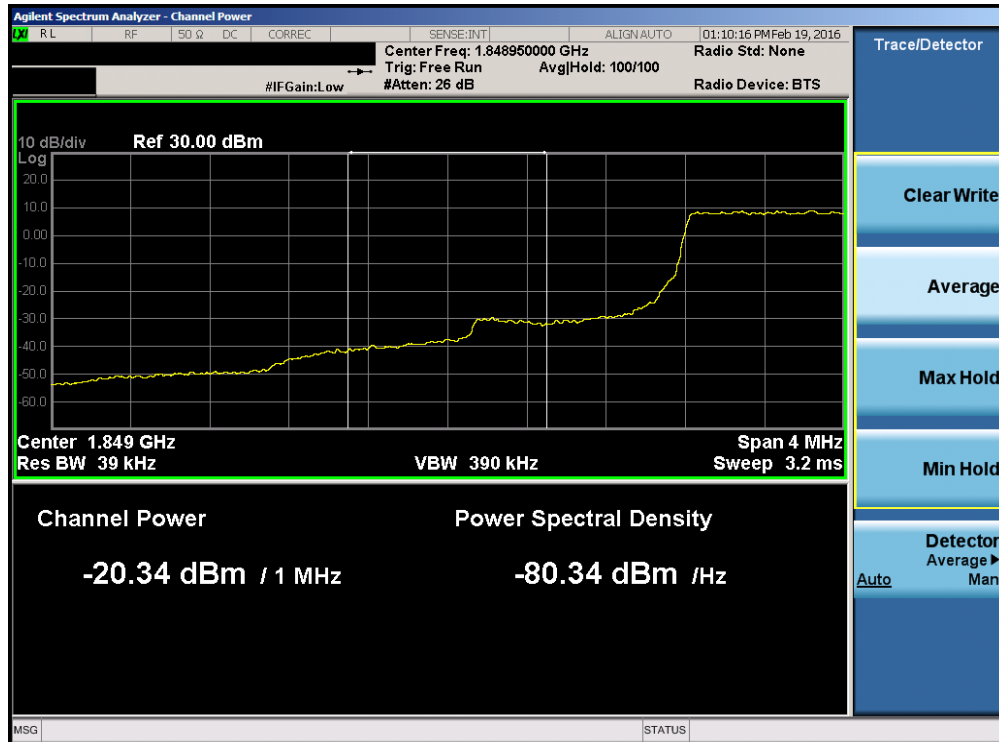


Plot 7-67. Upper Band Edge Plot (Band 26 – 15.0MHz QPSK – RB Size 75)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 50 of 94



Plot 7-68. Lower Band Edge Plot (Band 25 – 1.4MHz QPSK – RB Size 6)

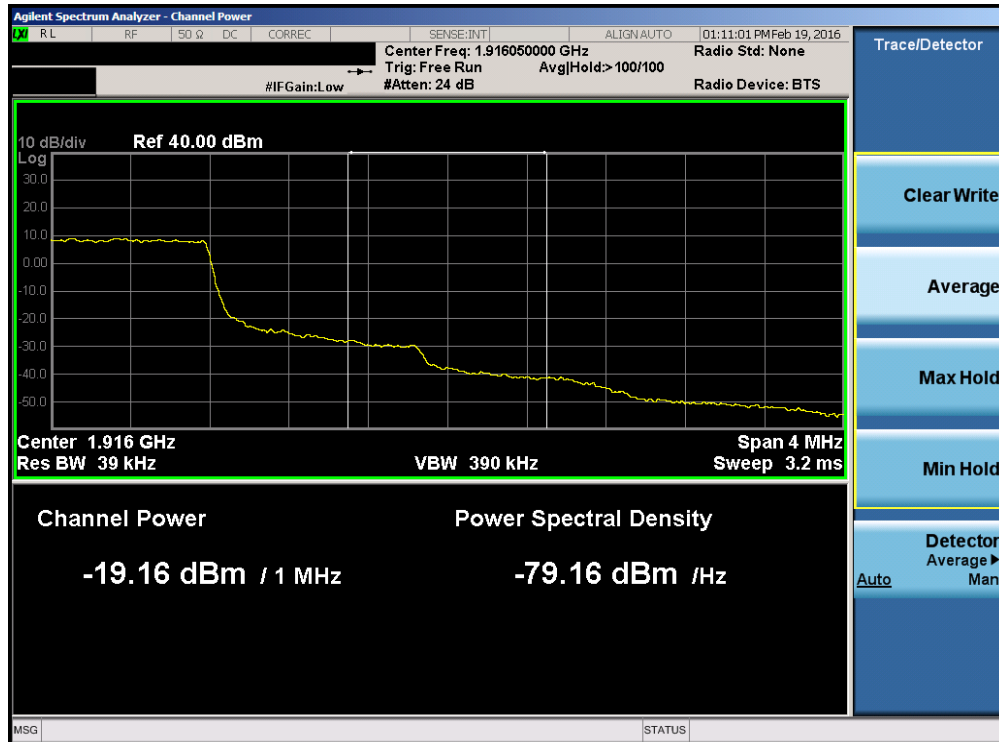


Plot 7-69. Lower Extended Band Edge Plot (Band 25 – 1.4MHz QPSK – RB Size 6)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 51 of 94

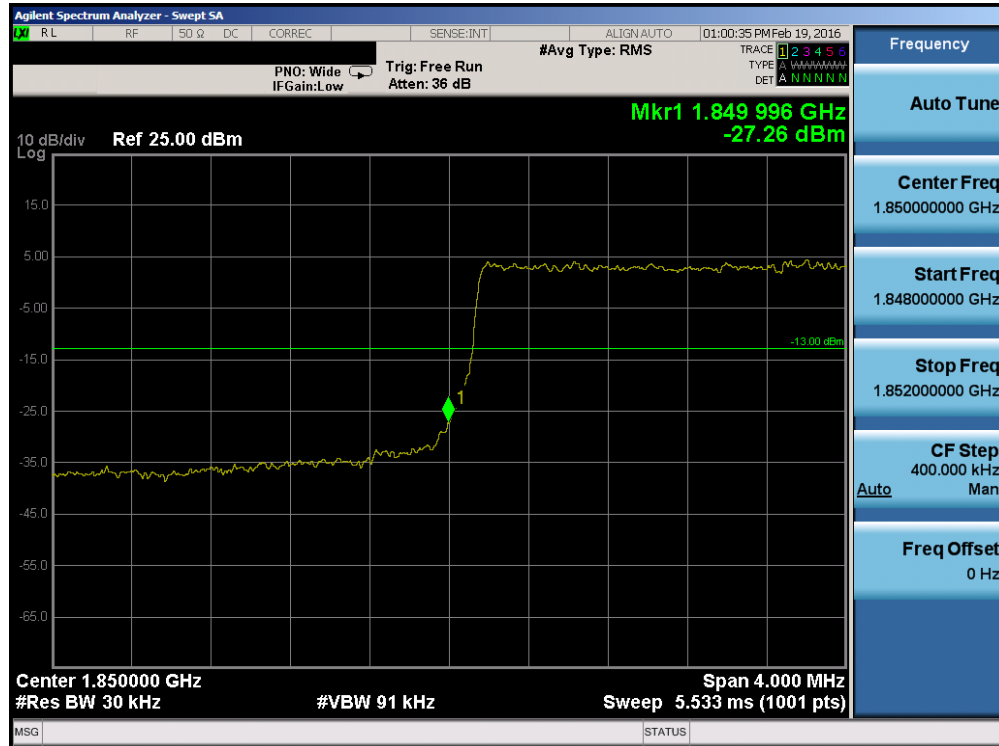


Plot 7-70. Upper Band Edge Plot (Band 25 – 1.4MHz QPSK – RB Size 6)

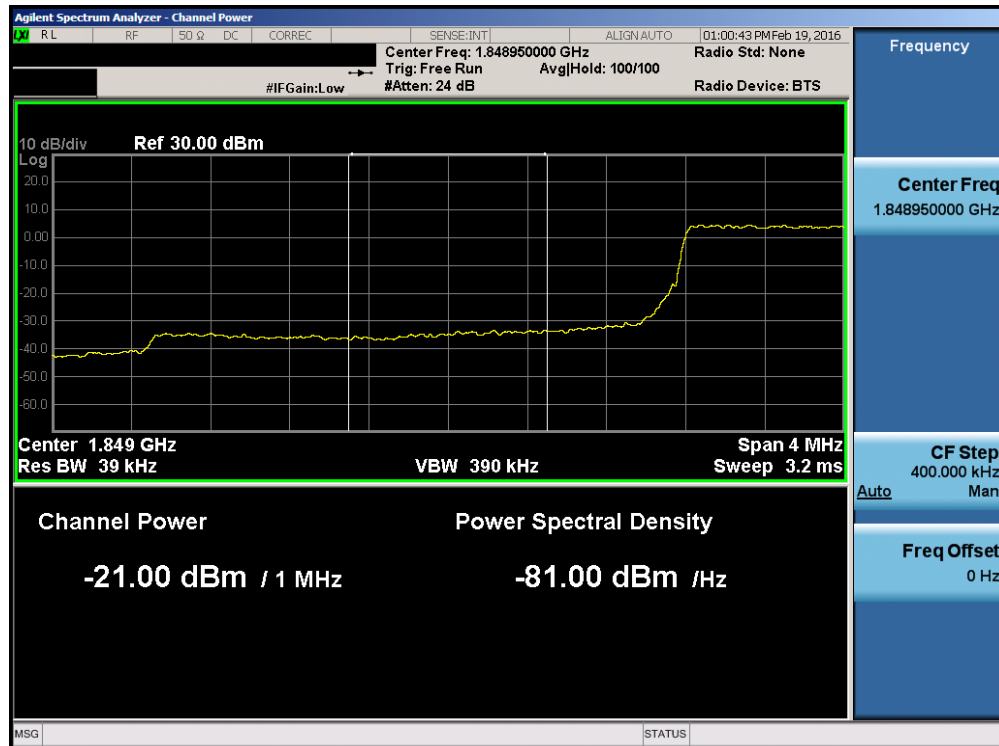


Plot 7-71. Upper Extended Band Edge Plot (Band 25 – 1.4MHz QPSK – RB Size 6)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 52 of 94



Plot 7-72. Lower Band Edge Plot (Band 25 – 3.0MHz QPSK – RB Size 15)

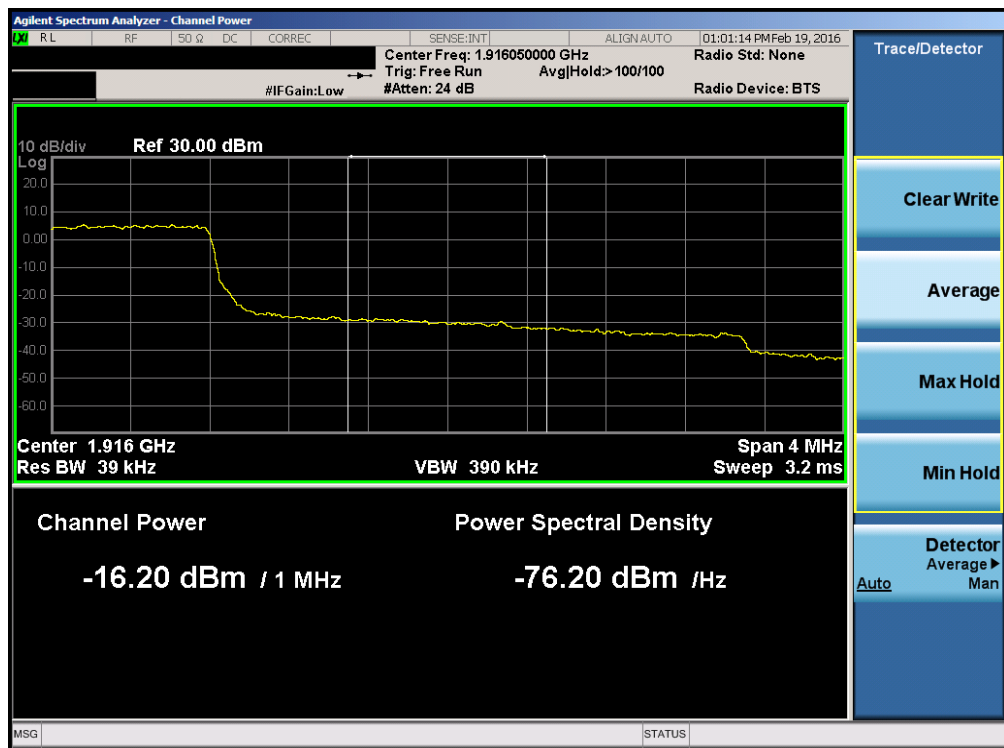


Plot 7-73. Lower Extended Band Edge Plot (Band 25 – 3.0MHz QPSK – RB Size 15)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 53 of 94

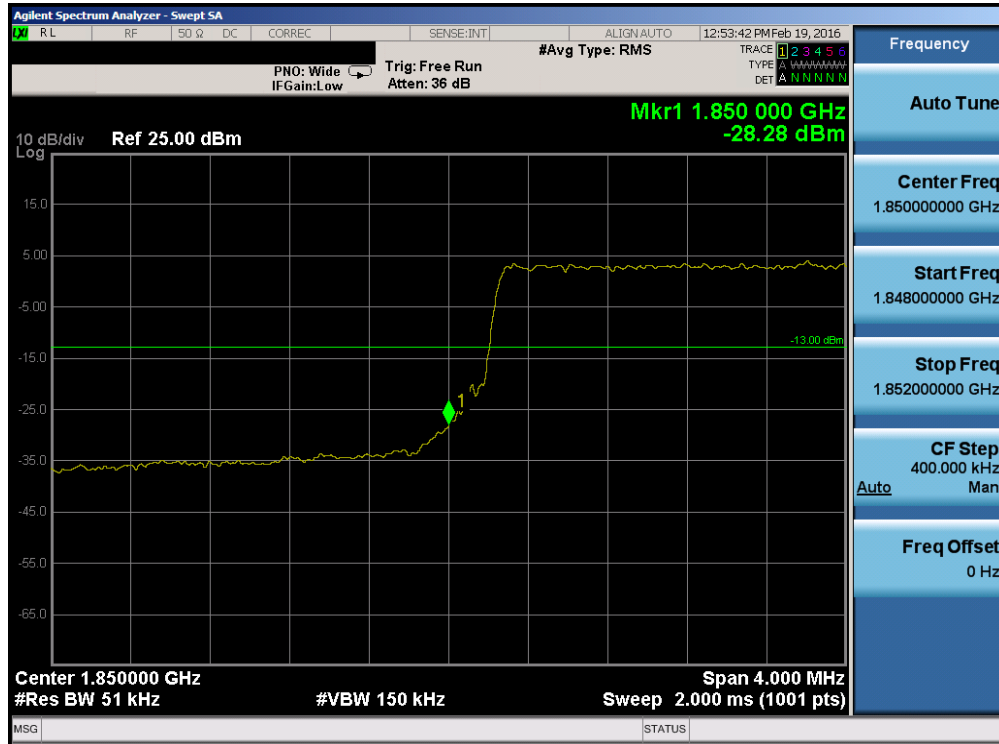


Plot 7-74. Upper Band Edge Plot (Band 25 – 3.0MHz QPSK – RB Size 15)

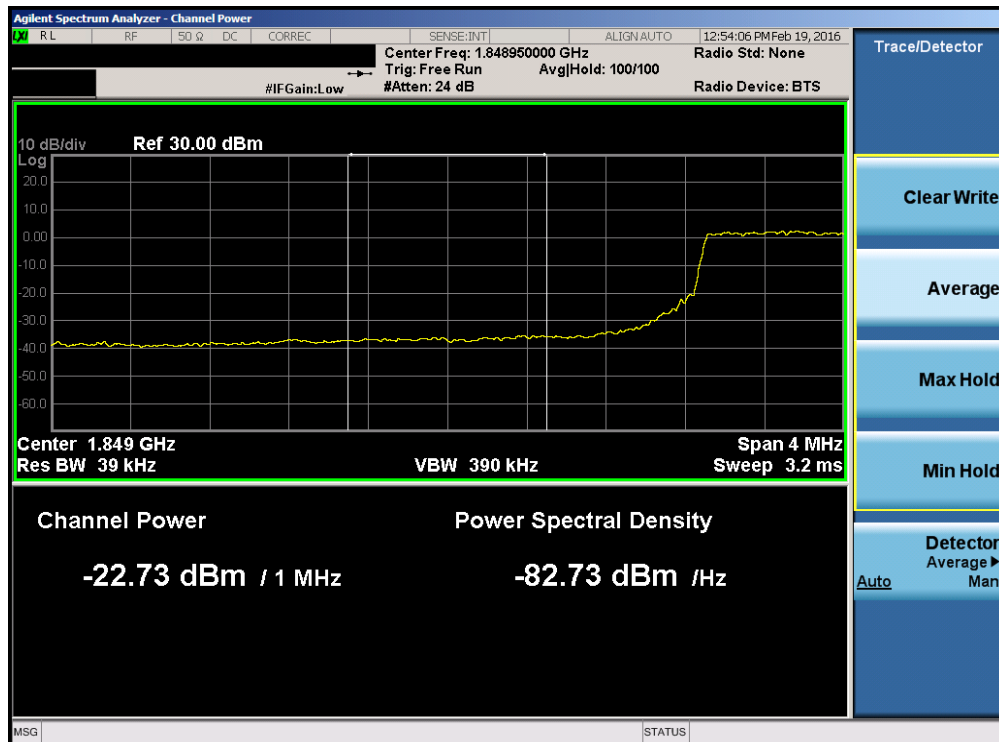


Plot 7-75. Upper Extended Band Edge Plot (Band 25 – 3.0MHz QPSK – RB Size 15)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 54 of 94

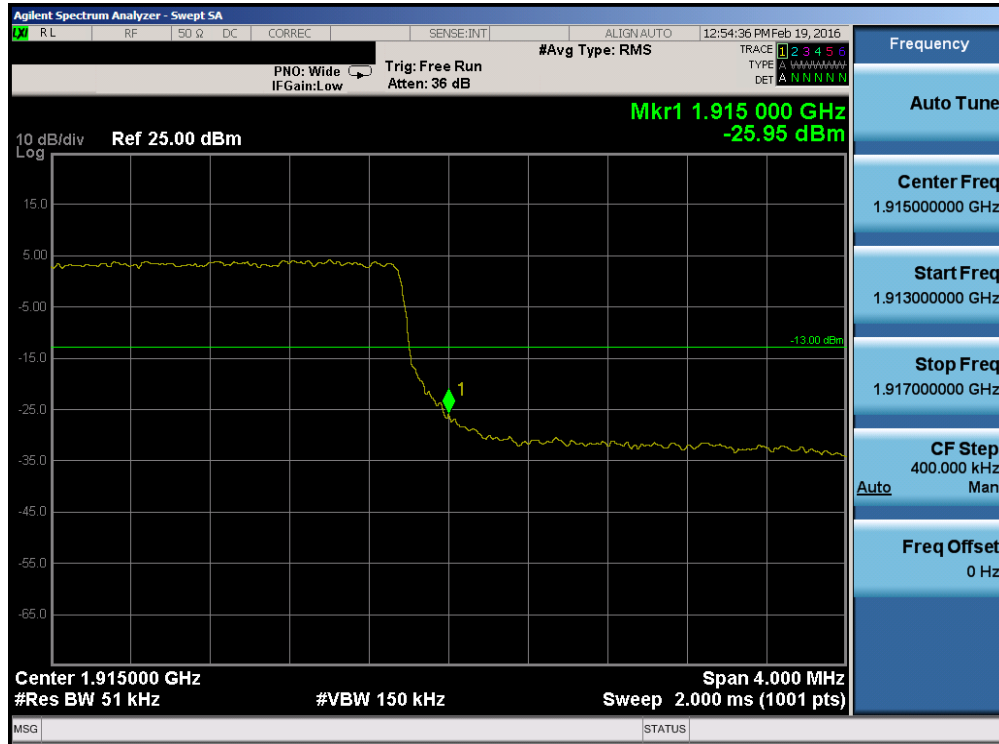


Plot 7-76. Lower Band Edge Plot (Band 25 – 5.0MHz QPSK – RB Size 25)

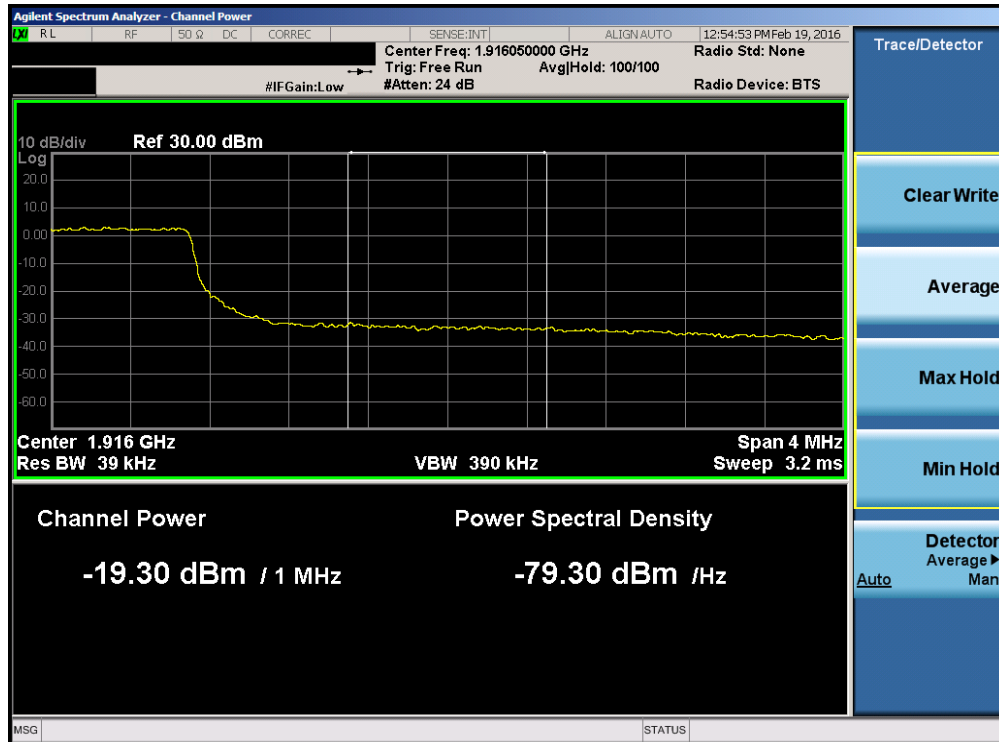


Plot 7-77. Lower Extended Band Edge Plot (Band 25 – 5.0MHz QPSK – RB Size 25)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 55 of 94

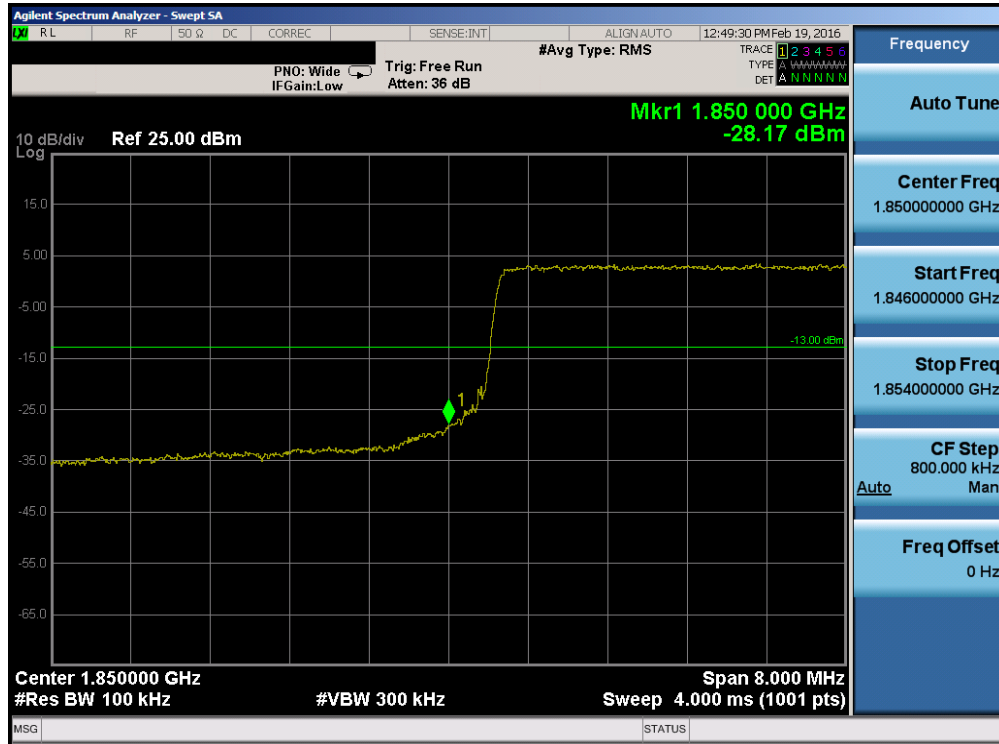


Plot 7-78. Upper Band Edge Plot (Band 25 – 5.0MHz QPSK – RB Size 25)

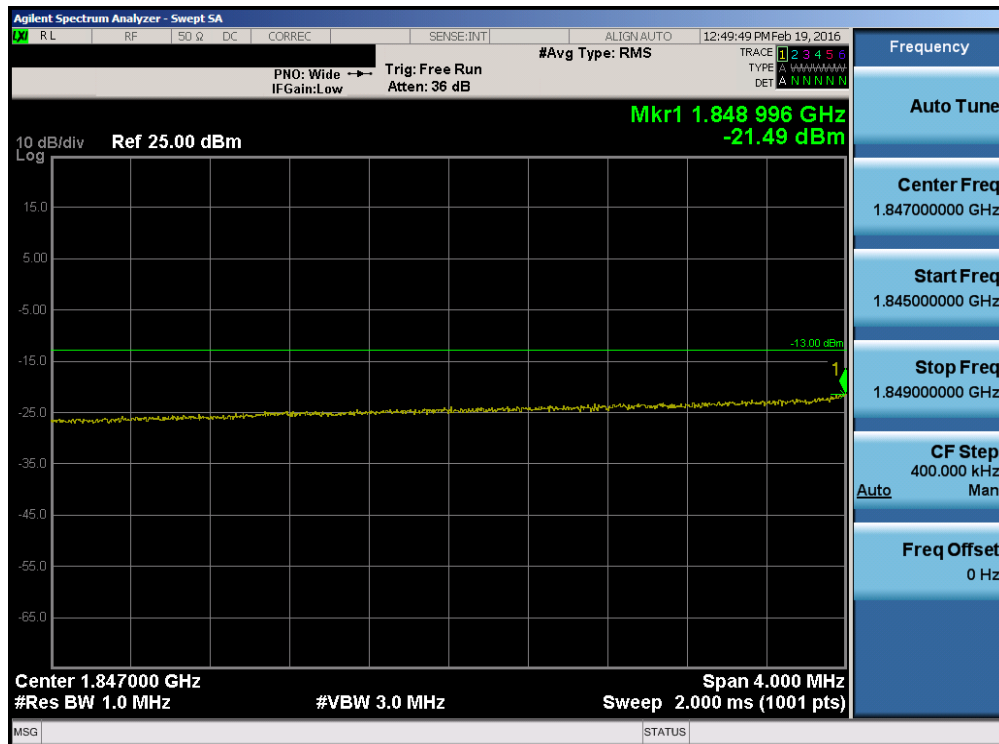


Plot 7-79. Upper Extended Band Edge Plot (Band 25 – 5.0MHz QPSK – RB Size 25)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 56 of 94

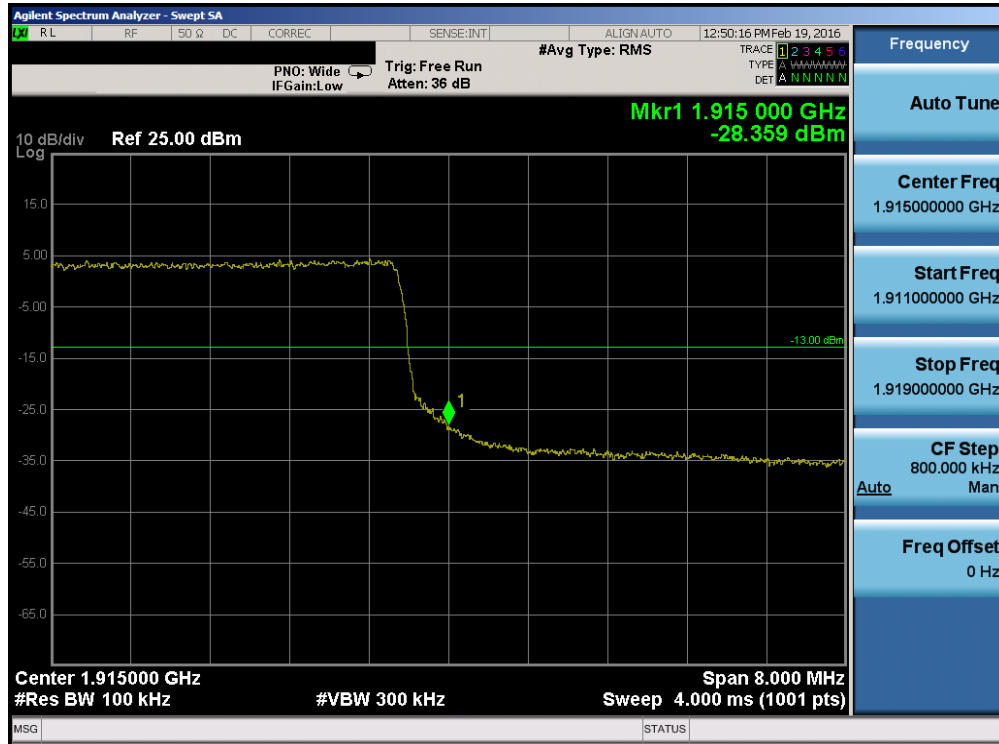


Plot 7-80. Lower Band Edge Plot (Band 25 – 10.0MHz QPSK – RB Size 50)

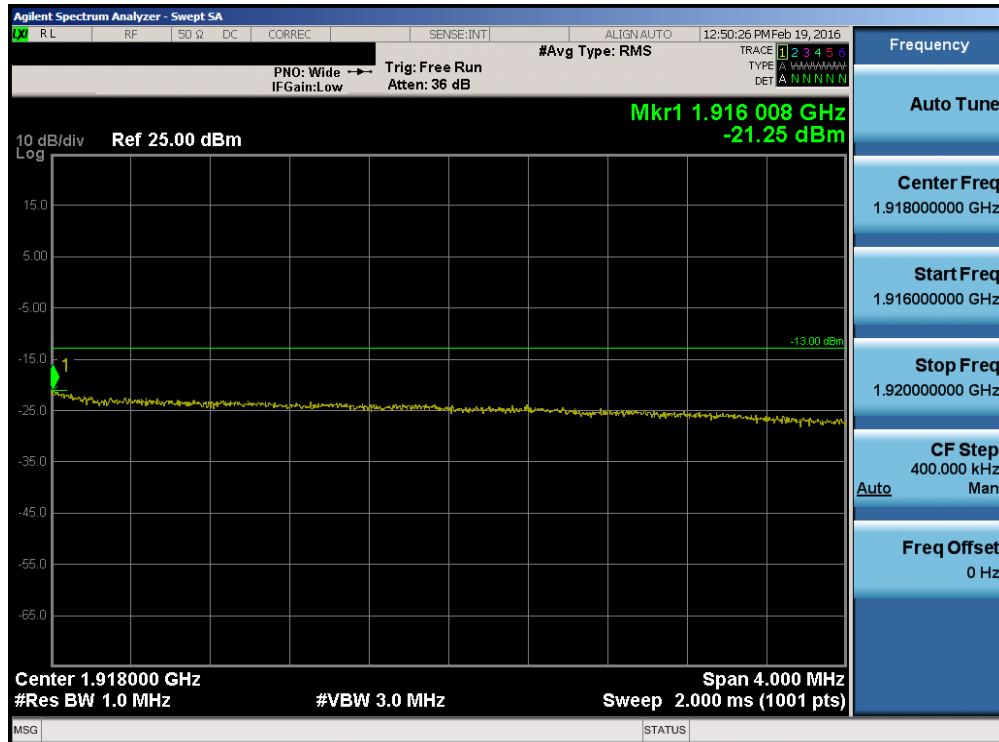


Plot 7-81. Lower Extended Band Edge Plot (Band 25 – 10.0MHz QPSK – RB Size 50)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 57 of 94

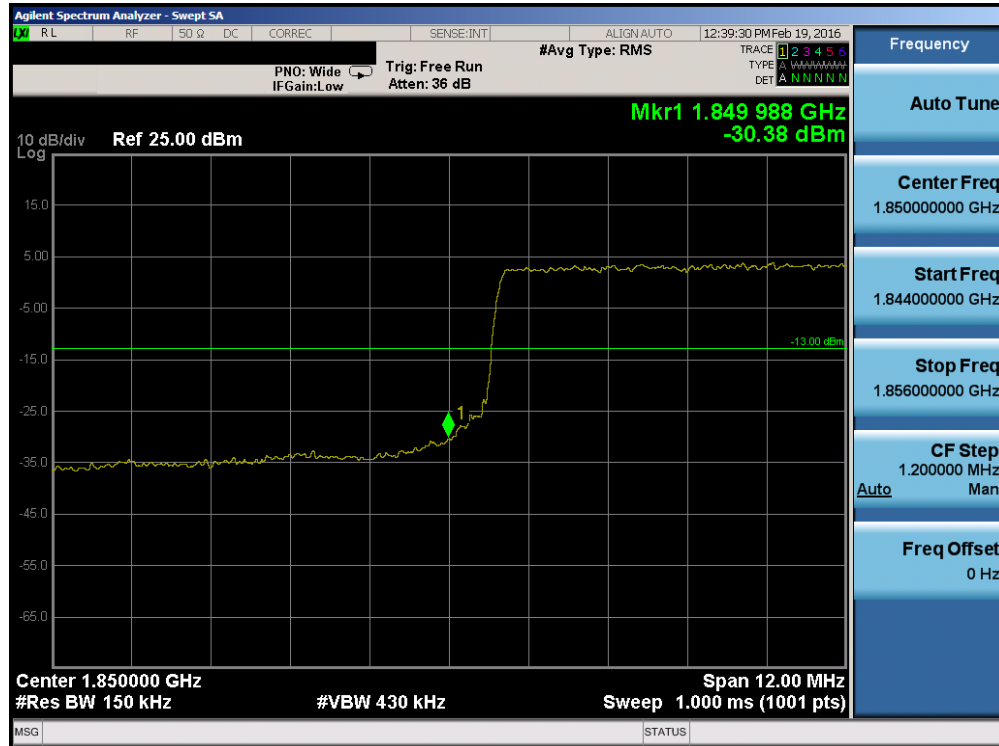


Plot 7-82. Upper Band Edge Plot (Band 25 – 10.0MHz QPSK – RB Size 50)

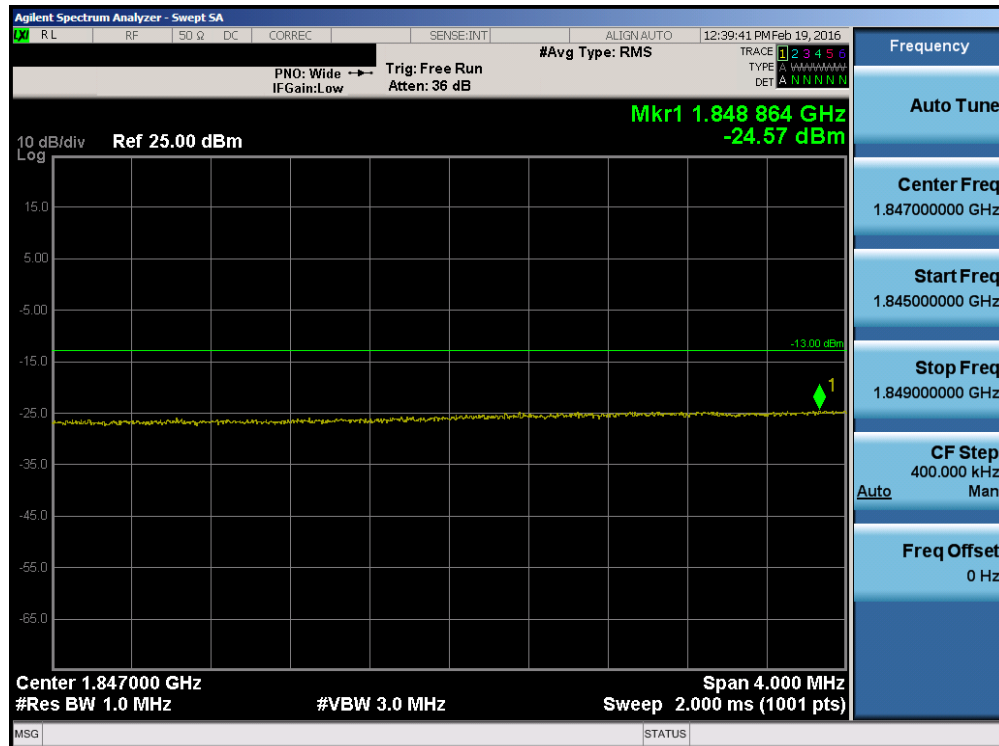


Plot 7-83. Upper Extended Band Edge Plot (Band 25 – 10.0MHz QPSK – RB Size 50)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 58 of 94

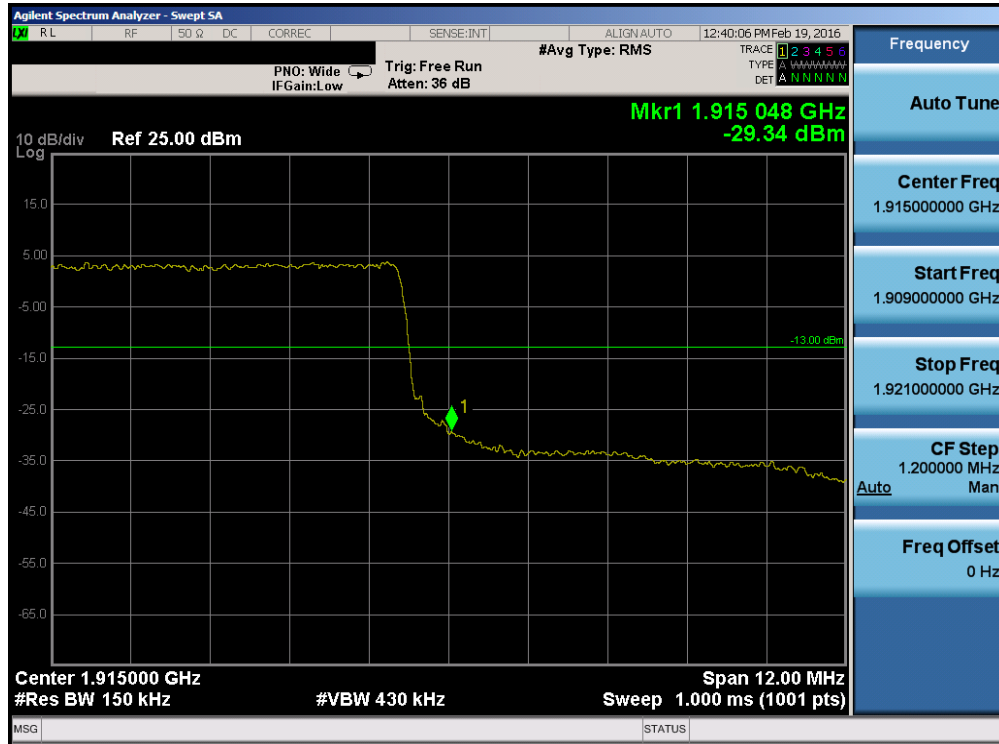


Plot 7-84. Lower Band Edge Plot (Band 25 – 15.0MHz QPSK – RB Size 75)

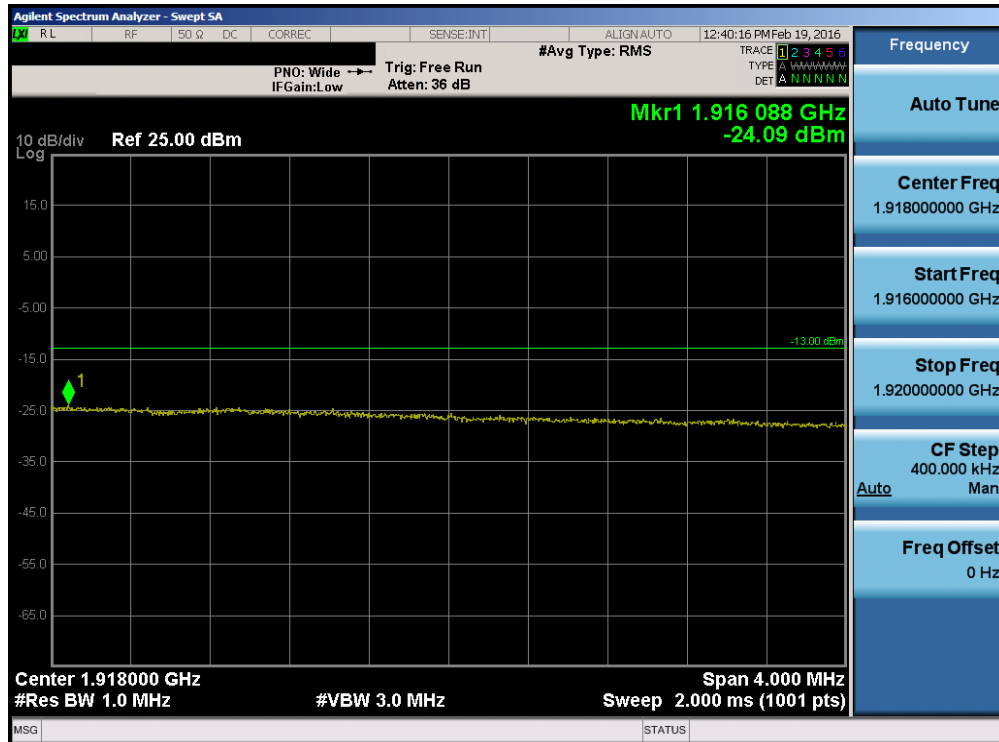


Plot 7-85. Lower Extended Band Edge Plot (Band 25 – 15.0MHz QPSK – RB Size 75)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 59 of 94

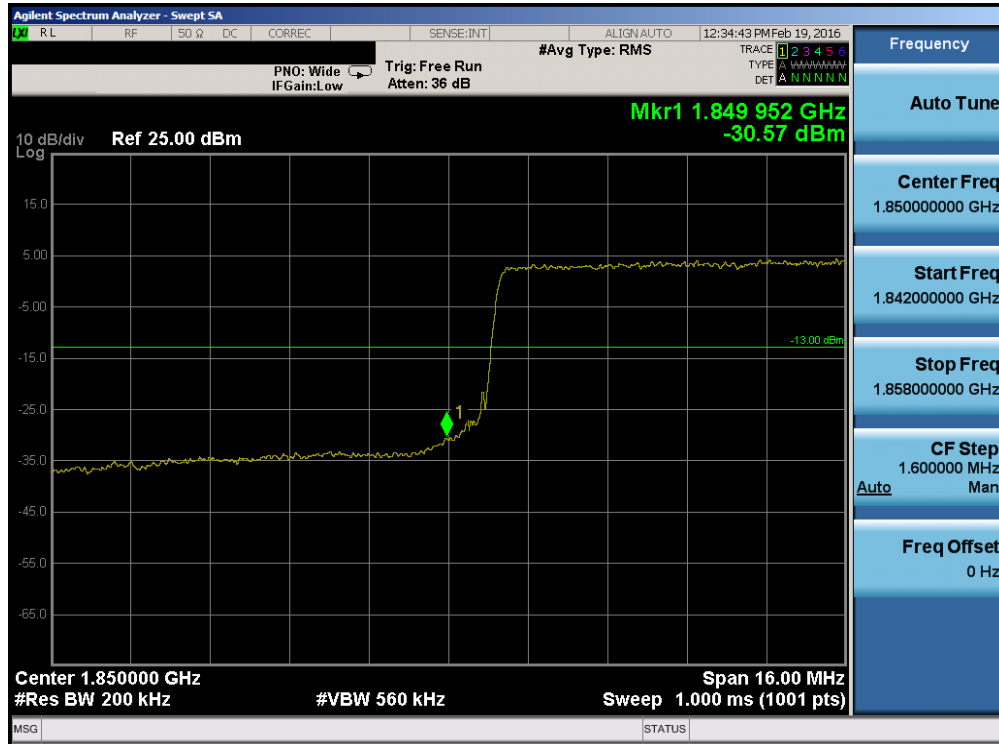


Plot 7-86. Upper Band Edge Plot (Band 25 – 15.0MHz QPSK – RB Size 75)

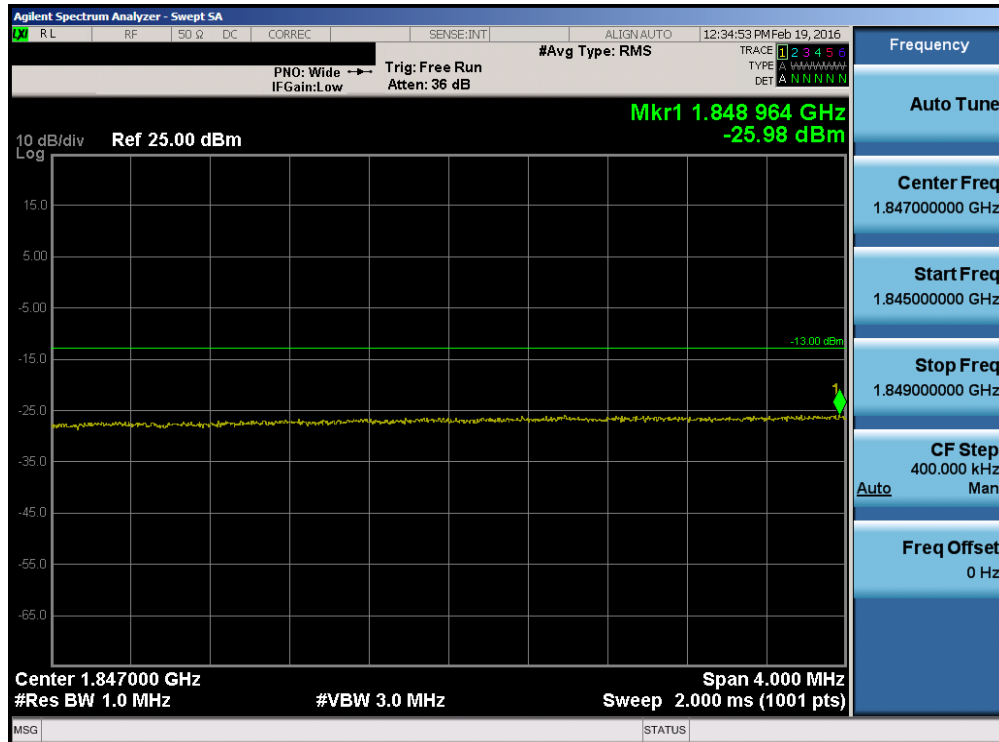


Plot 7-87. Upper Extended Band Edge Plot (Band 25 – 15.0MHz QPSK – RB Size 75)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 60 of 94

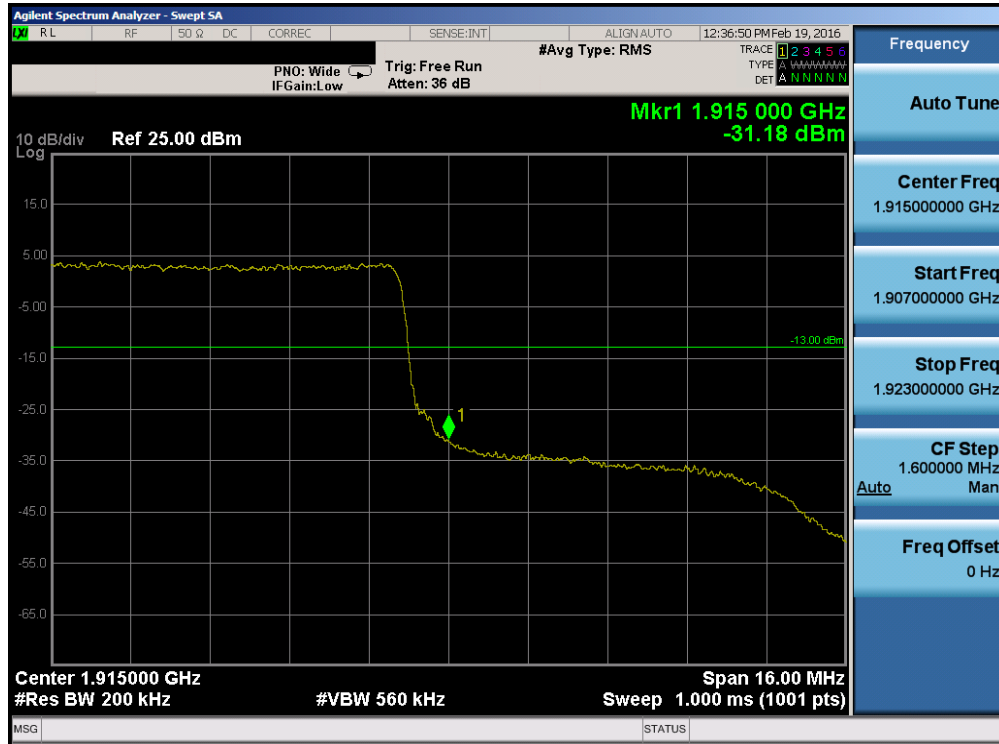


Plot 7-88. Lower Band Edge Plot (Band 25 – 20.0MHz QPSK – RB Size 100)

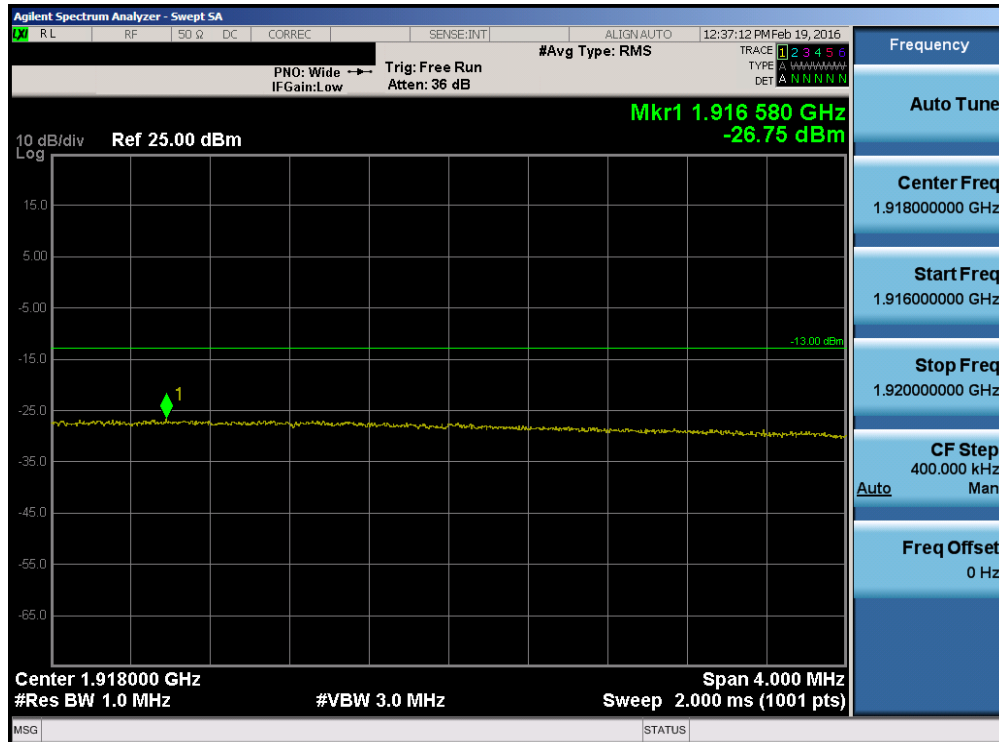


Plot 7-89. Lower Extended Band Edge Plot (Band 25 – 20.0MHz QPSK – RB Size 100)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 61 of 94

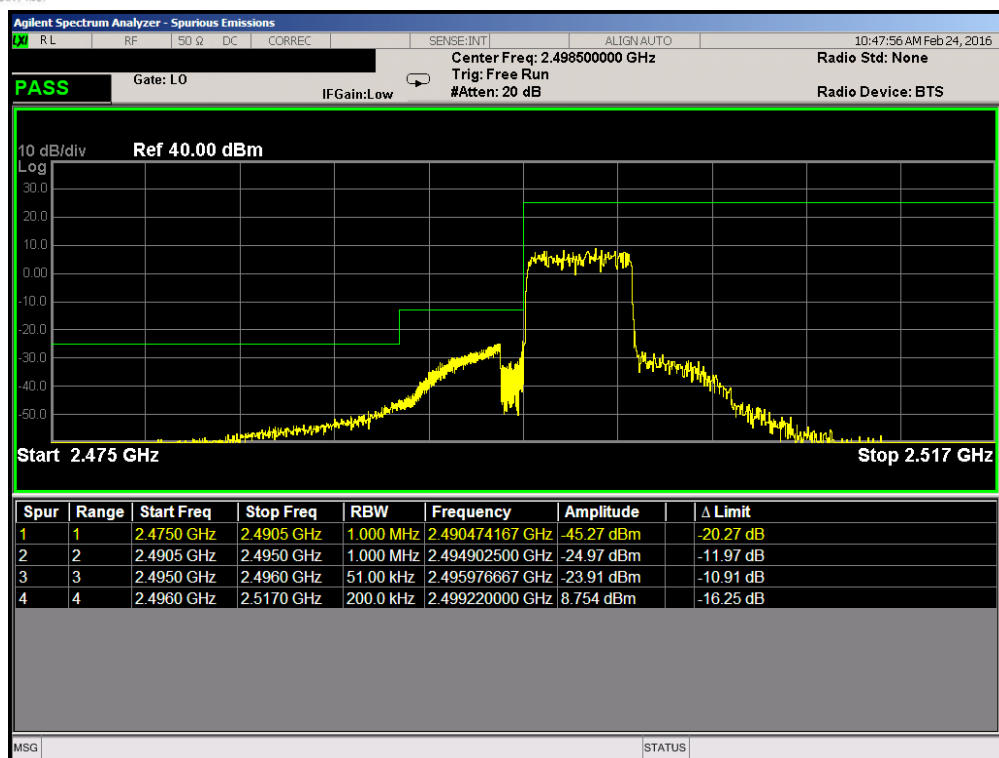


Plot 7-90. Upper Band Edge Plot (Band 25 – 20.0MHz QPSK – RB Size 100)

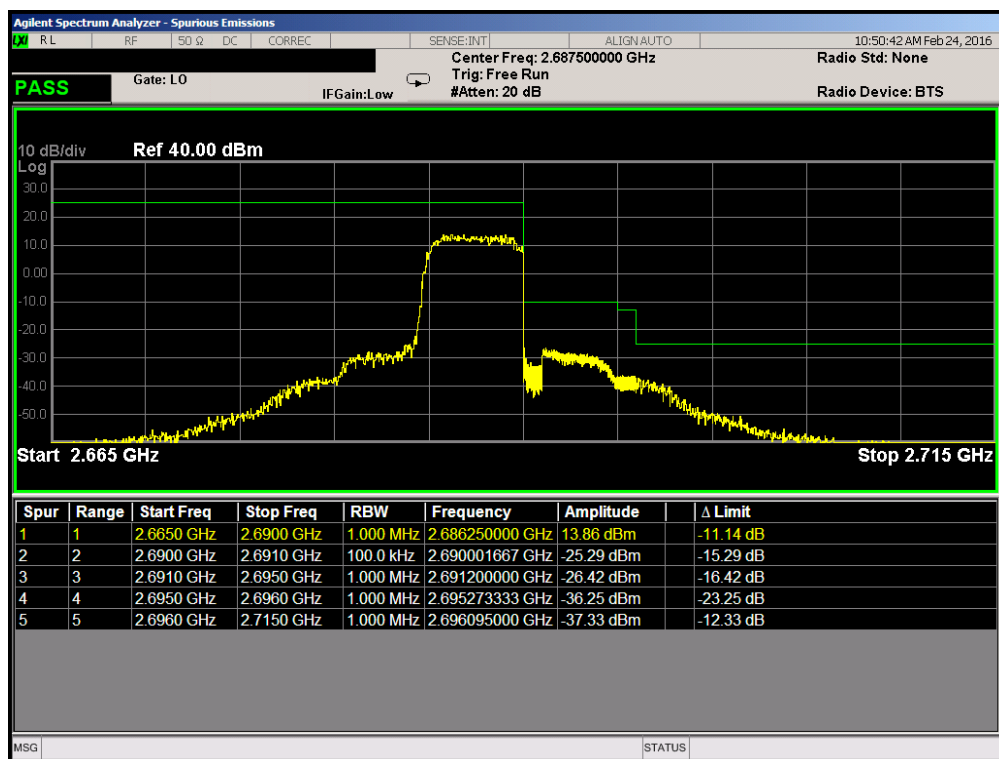


Plot 7-91. Upper Extended Band Edge Plot (Band 25 – 20.0MHz QPSK – RB Size 100)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 62 of 94

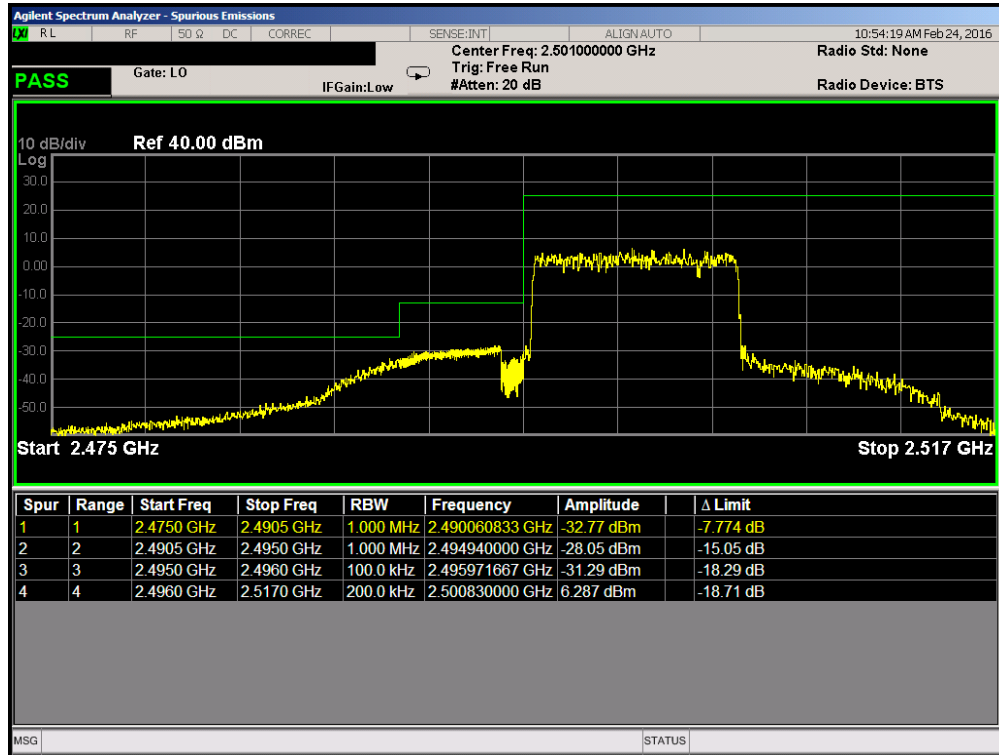


Plot 7-92. Lower ACP Plot (Band 41 – 5.0MHz QPSK – RB Size 25)

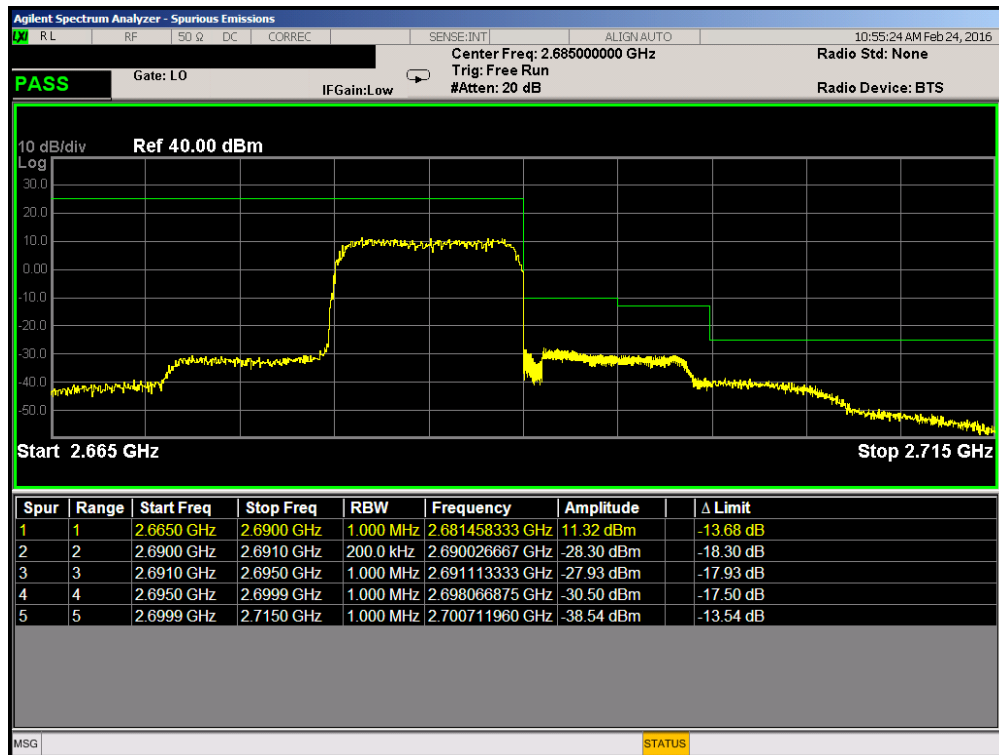


Plot 7-93. Upper ACP Plot (Band 41 – 5.0MHz QPSK – RB Size 25)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 63 of 94

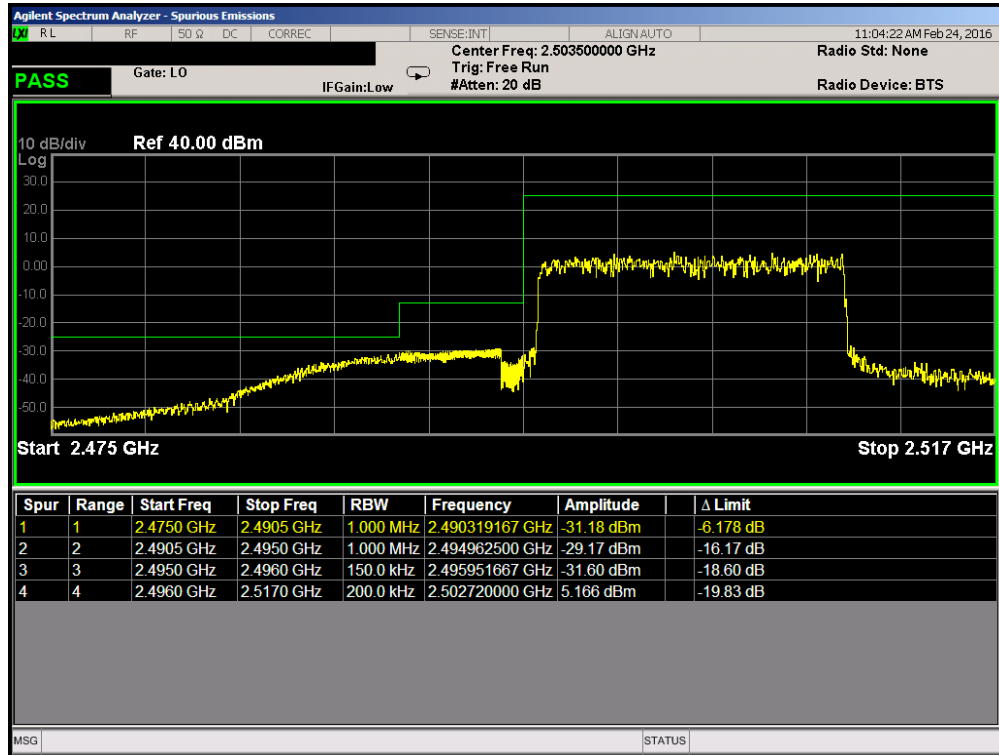


Plot 7-94. Lower ACP Plot (Band 41 – 10.0MHz QPSK – RB Size 50)

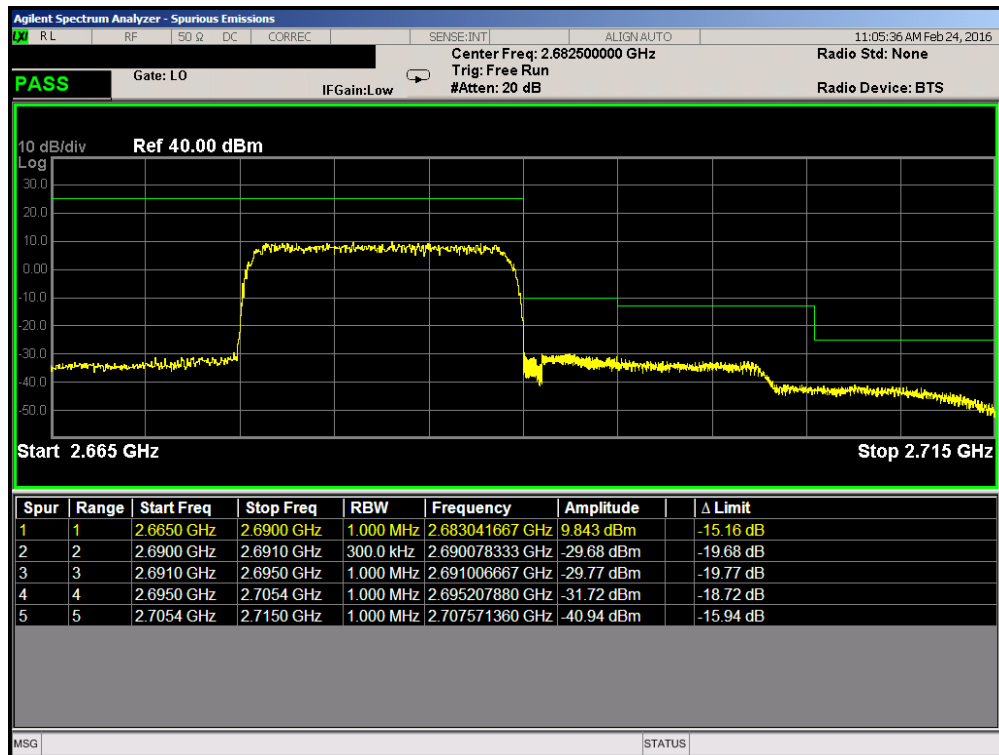


Plot 7-95. Upper ACP Plot (Band 41 – 10.0MHz QPSK – RB Size 50)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 64 of 94

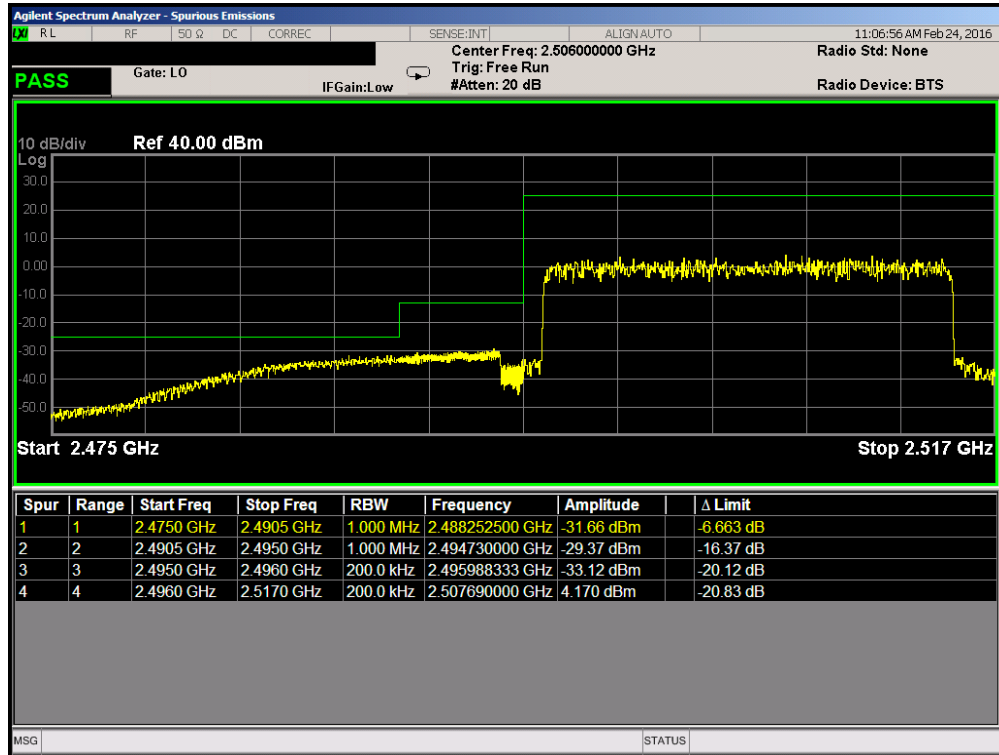


Plot 7-96. Lower ACP Plot (Band 41 – 15.0MHz QPSK – RB Size 75)

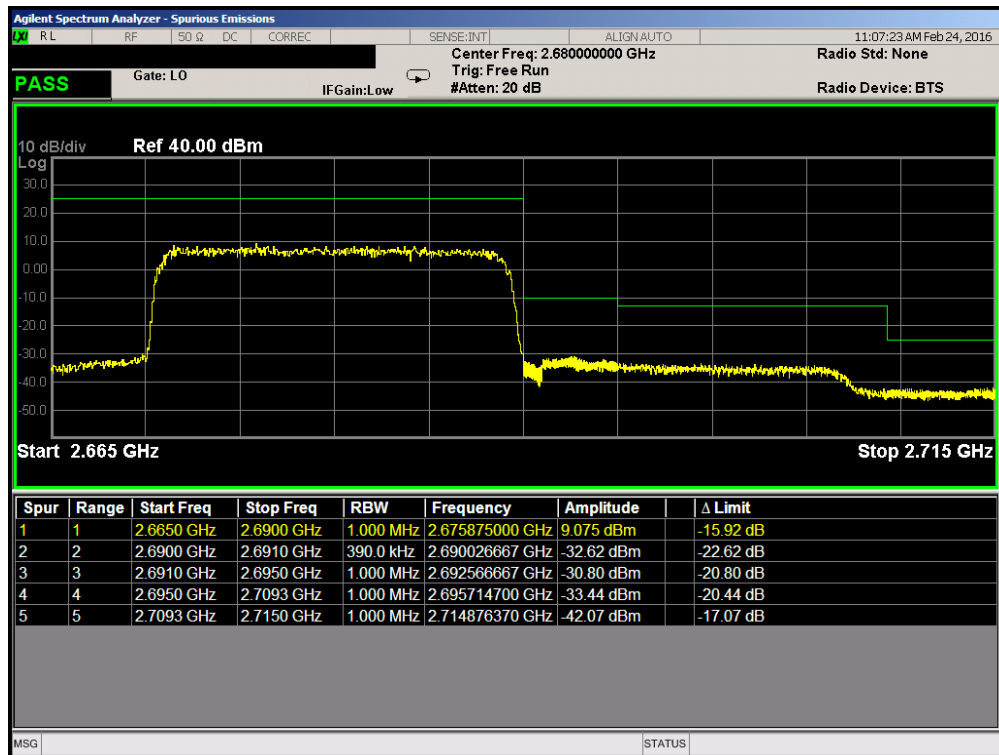


Plot 7-97. Upper ACP Plot (Band 41 – 15.0MHz QPSK – RB Size 75)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 65 of 94



Plot 7-98. Lower ACP Plot (Band 41 – 20.0MHz QPSK – RB Size 100)



Plot 7-99. Upper ACP Plot (Band 41 – 20.0MHz QPSK – RB Size 100)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 66 of 94

7.5 Peak-Average Ratio

§24.232(d)

Test Overview

A peak to average ratio measurement is performed at the conducted port of the EUT. The spectrum analyzers Complementary Cumulative Distribution Function (CCDF) measurement profile is used to determine the largest deviation between the average and the peak power of the EUT in a given bandwidth. The CCDF curve shows how much time the peak waveform spends at or above a given average power level. The percent of time the signal spends at or above the level defines the probability for that particular power level.

Test Procedure Used

KDB 971168 D01 v02r02 – Section 5.7.1

Test Settings

1. The signal analyzer's CCDF measurement profile is enabled
2. Frequency = carrier center frequency
3. Measurement BW > Emission bandwidth of signal
4. The signal analyzer was set to collect one million samples to generate the CCDF curve
5. The measurement interval was set depending on the type of signal analyzed. For continuous signals (>98% duty cycle), the measurement interval was set to 1ms. For burst transmissions, the spectrum analyzer is set to use an internal "RF Burst" trigger that is synced with an incoming pulse and the measurement interval is set to less than the duration of the "on time" of one burst to ensure that energy is only captured during a time in which the transmitter is operating at maximum power

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

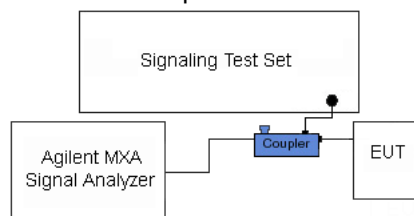
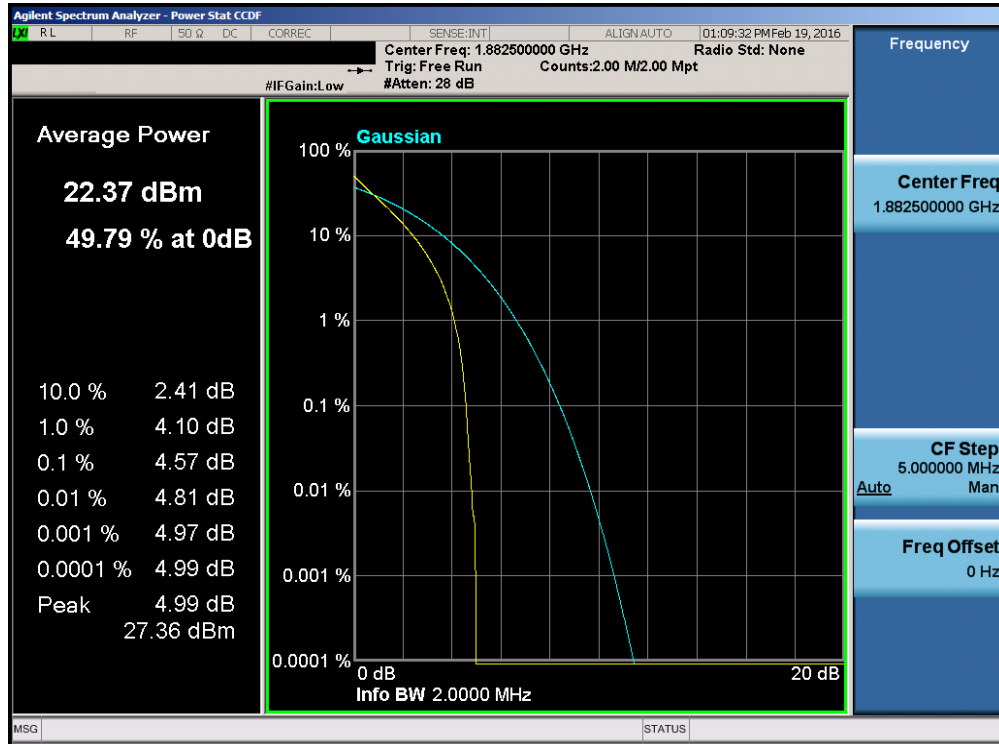


Figure 7-4. Test Instrument & Measurement Setup

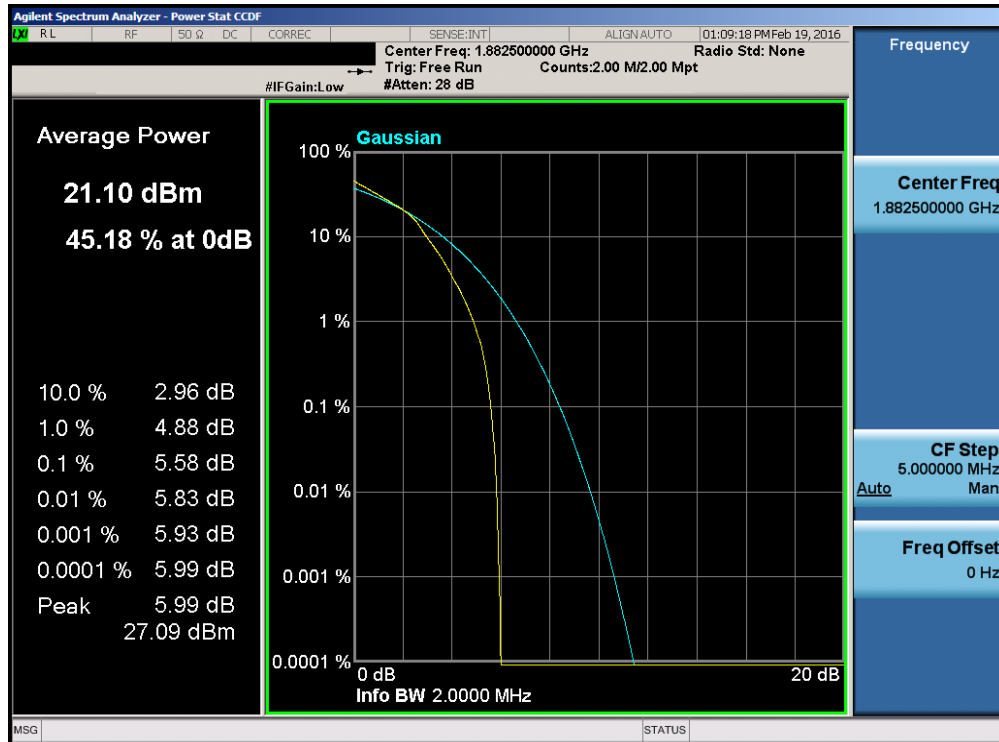
Test Notes

None.

FCC ID: A3LSMJ120P		FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset	Page 67 of 94	

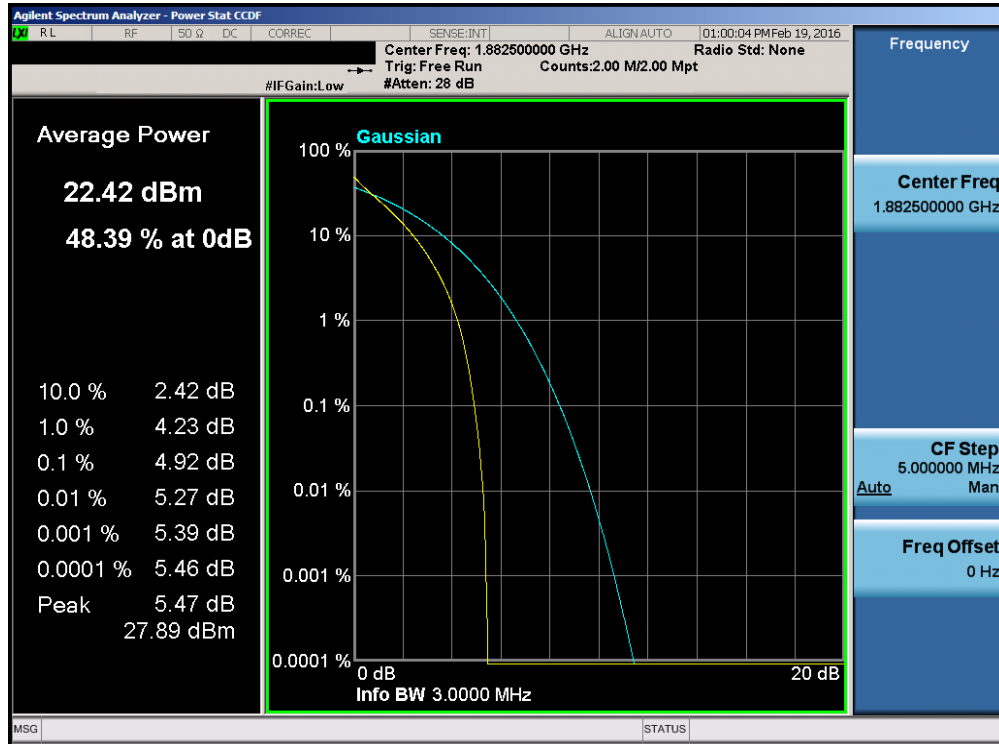


Plot 7-100. PAR Plot (Band 25 – 1.4MHz QPSK – RB Size 6)

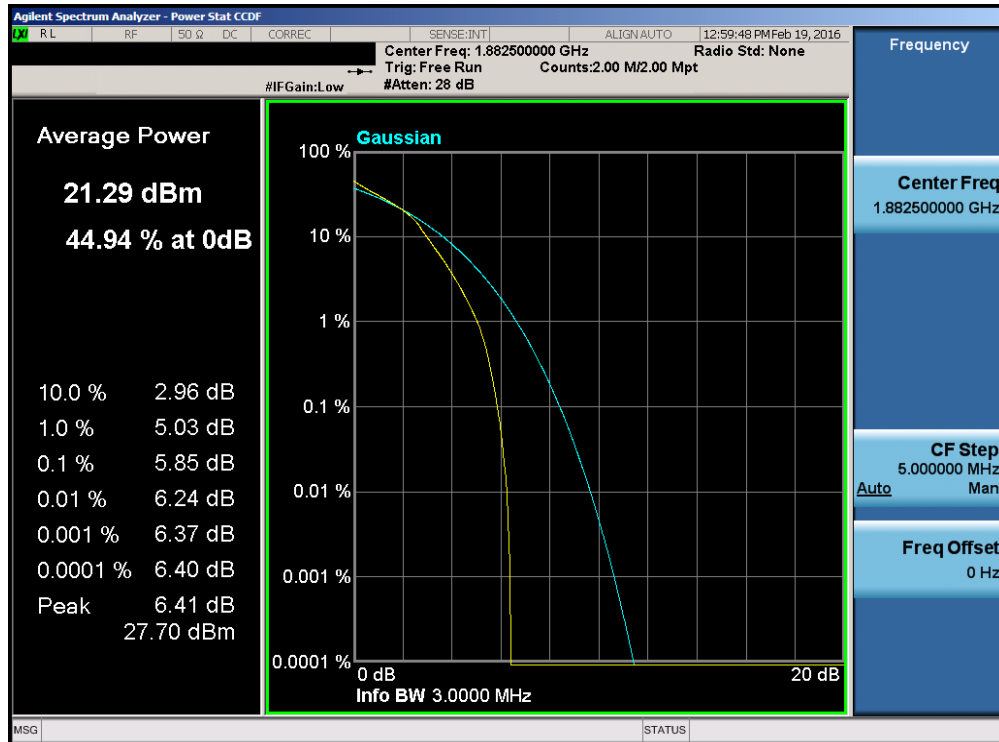


Plot 7-101. PAR Plot (Band 25 – 1.4MHz 16-QAM – RB Size 6)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 68 of 94

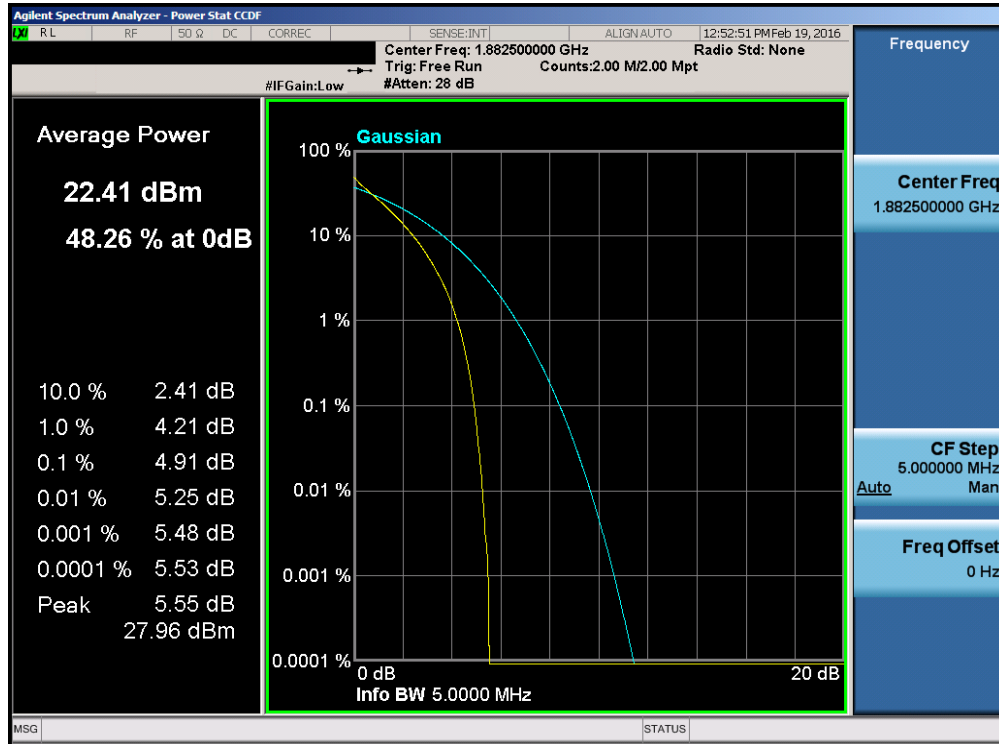


Plot 7-102. PAR Plot (Band 25 – 3.0MHz QPSK – RB Size 15)

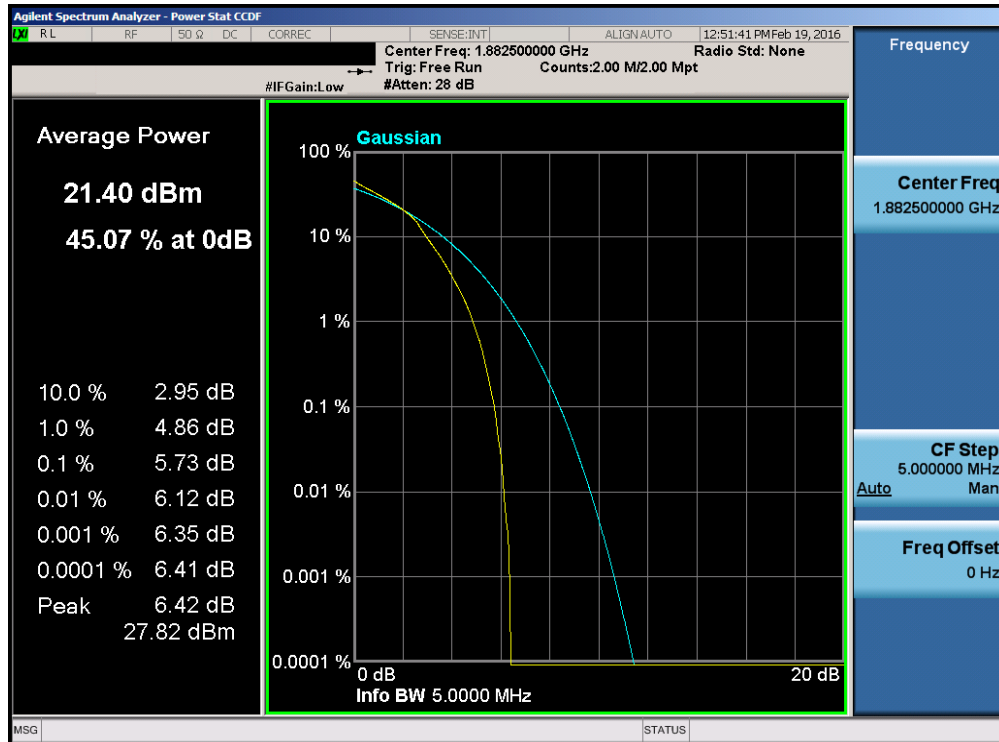


Plot 7-103. PAR Plot (Band 25 – 3.0MHz 16-QAM – RB Size 15)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 69 of 94

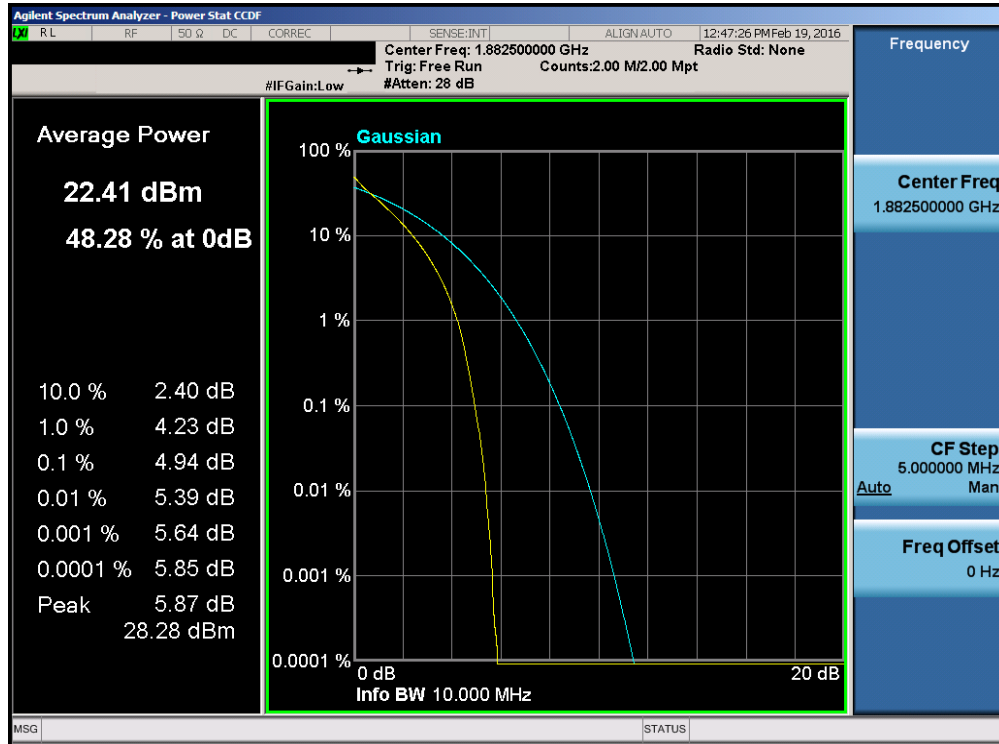


Plot 7-104. PAR Plot (Band 25 – 5.0MHz QPSK – RB Size 25)

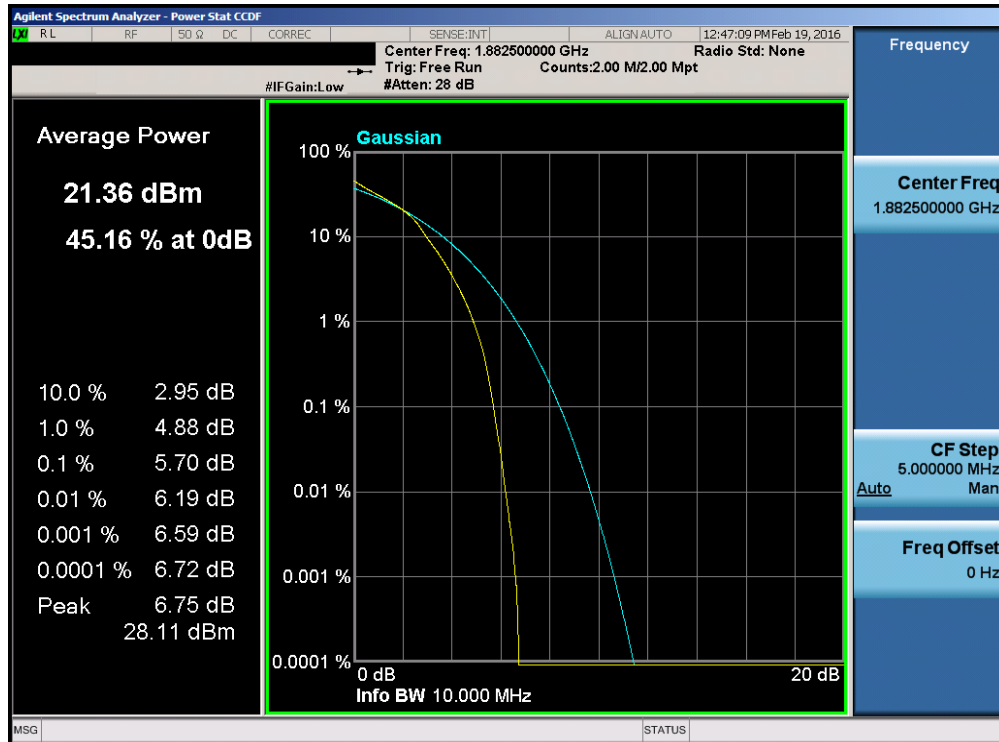


Plot 7-105. PAR Plot (Band 25 – 5.0MHz 16-QAM – RB Size 25)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 70 of 94

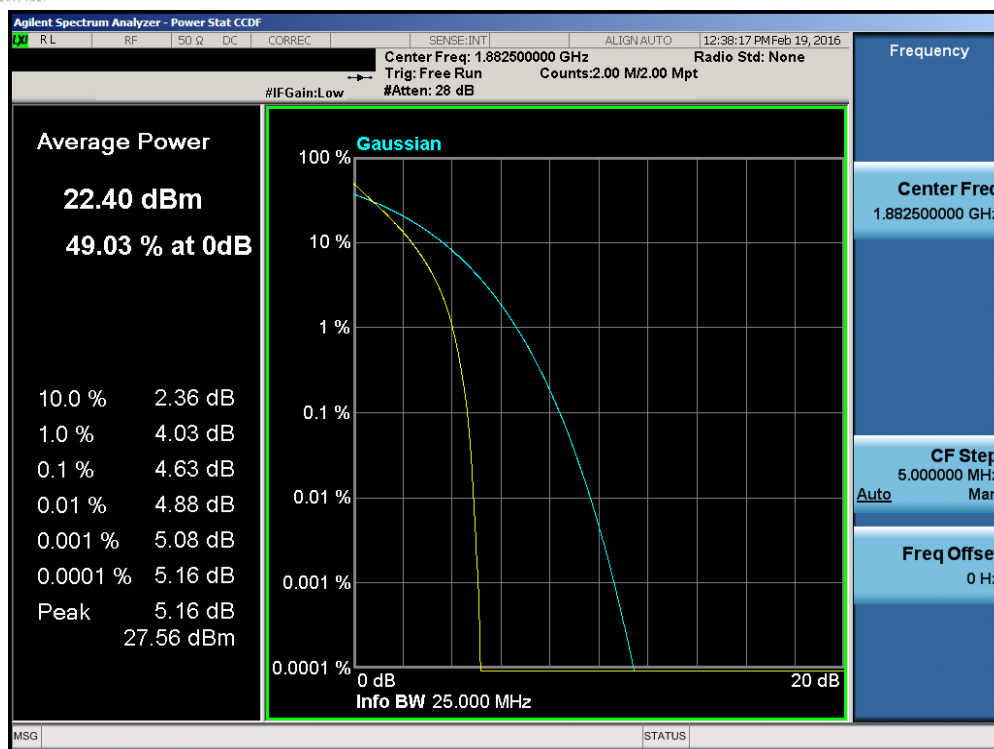


Plot 7-106. PAR Plot (Band 25 – 10.0MHz QPSK – RB Size 50)

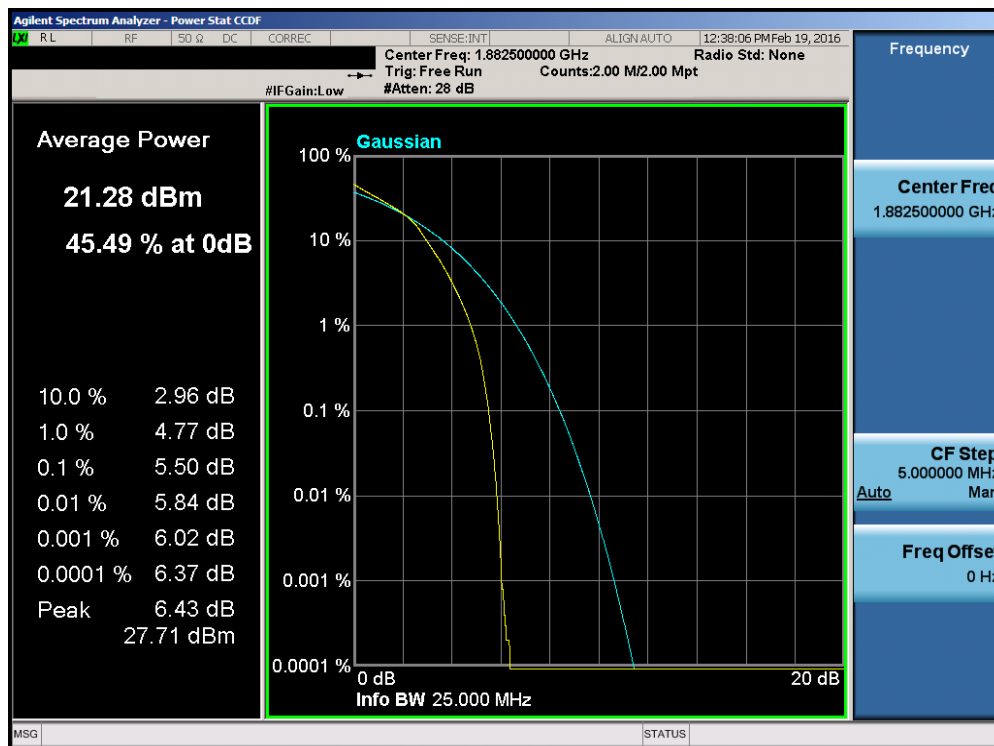


Plot 7-107. PAR Plot (Band 25 – 10.0MHz 16-QAM – RB Size 50)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 71 of 94

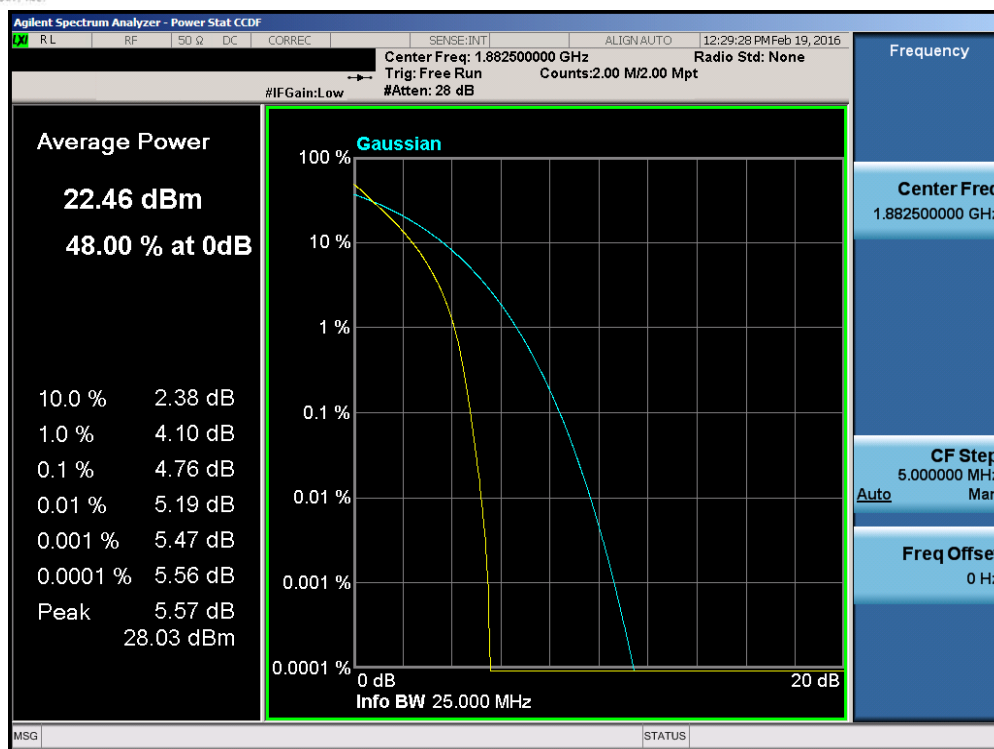


Plot 7-108. PAR Plot (Band 25 – 15.0MHz QPSK – RB Size 75)

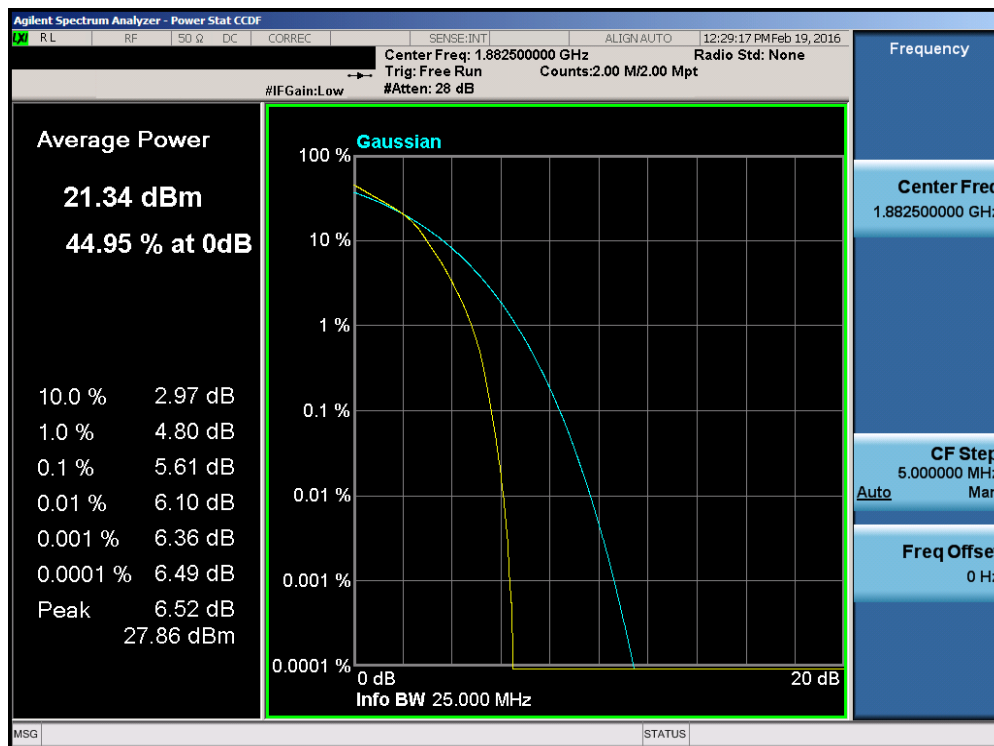


Plot 7-109. PAR Plot (Band 25 – 15.0MHz 16-QAM – RB Size 75)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 72 of 94



Plot 7-110. PAR Plot (Band 25 – 20.0MHz QPSK – RB Size 100)



Plot 7-111. PAR Plot (Band 25 – 20.0MHz 16-QAM – RB Size 100)

FCC ID: A3LSMJ120P	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 73 of 94

7.6 Radiated Power (ERP/EIRP)

§22.913(a.2) §24.232(c.2) §27.50(h.2)

Test Overview

Effective Radiated Power (ERP) and Equivalent Isotropic Radiated Power (EIRP) measurements are performed using the substitution method described in ANSI/TIA-603-C-2004 with the EUT transmitting into an integral antenna. Measurements on signals operating below 1GHz are performed using horizontally and vertically polarized tuned dipole antennas. Measurements on signals operating above 1GHz are performed using horizontally and vertically polarized broadband horn antennas. All measurements are performed as RMS average measurements while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies. The antenna polarization measuring the highest is reported.

Test Procedures Used

KDB 971168 D01 v02r02 – Section 5.2.1

ANSI/TIA-603-C-2004 – Section 2.2.17

Test Settings

1. Radiated power measurements are performed using the signal analyzer's "channel power" measurement capability for signals with continuous operation. For signals with burst transmission, the signal analyzer's "time domain power" measurement capability is used
2. RBW = 1 – 5% of the expected OBW, not to exceed 1MHz
3. VBW $\geq 3 \times$ RBW
4. Span = 1.5 times the OBW
5. No. of sweep points $\geq 2 \times$ span / RBW
6. Detector = RMS
7. Trigger is set to "free run" for signals with continuous operation with the sweep times set to "auto".
Trigger is set to enable triggering only on full power bursts with the sweep time set less than or equal to the transmission burst duration
8. The integration bandwidth was roughly set equal to the measured OBW of the signal for signals with continuous operation. For signals with burst transmission, the "gating" function was enabled to ensure that measurements are performed during times in which the transmitter is operating at its maximum power
9. Trace mode = trace averaging (RMS) over 100 sweeps
10. The trace was allowed to stabilize

FCC ID: A3LSMJ120P		FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 74 of 94

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

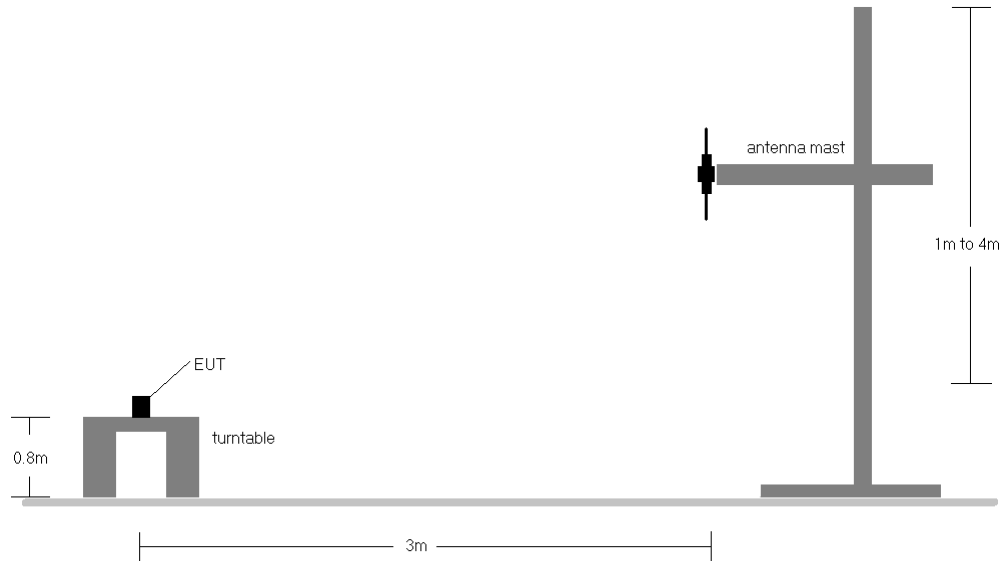


Figure 7-5. Radiated Test Setup <1GHz

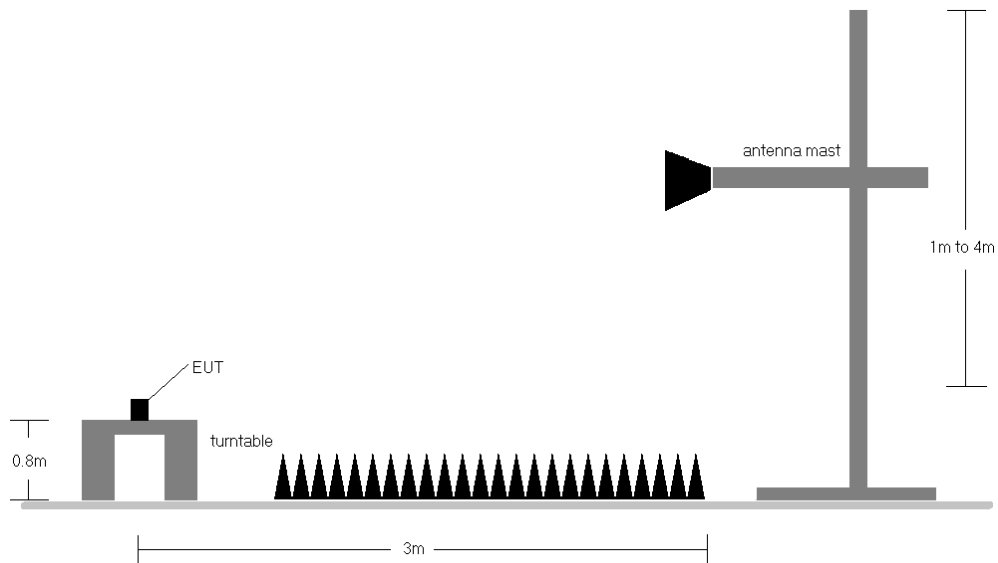


Figure 7-6. Radiated Test Setup >1GHz

Test Notes

- 1) The EUT was tested in three orthogonal planes and in all possible test configurations and positioning. The worst case emissions are reported with the EUT positioning, modulations, RB sizes and offsets, and channel bandwidth configurations shown in the tables below.
- 2) This unit was tested with its standard battery.

FCC ID: A3LSMJ120P		FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 75 of 94

Frequency [MHz]	Channel Bandwidth [MHz]	Mod.	Ant. Pol. [H/V]	Antenna Height [m]	Turntable Azimuth [degree]	RB Size/Offset	Substitute Level [dBm]	Ant. Gain [dBd]	ERP [dBm]	ERP Limit [dBm]	Margin [dB]
824.70	1.4	QPSK	H	3.17	11	1 / 5	18.81	4.95	23.76	38.45	-14.70
836.50	1.4	QPSK	H	3.17	11	1 / 5	19.91	5.00	24.91	38.45	-13.54
848.30	1.4	QPSK	H	3.17	11	1 / 5	19.39	5.05	24.44	38.45	-14.01
824.70	1.4	16-QAM	H	3.17	11	1 / 5	17.88	4.95	22.83	38.45	-15.63
836.50	1.4	16-QAM	H	3.17	11	1 / 5	18.79	5.00	23.79	38.45	-14.66
848.30	1.4	16-QAM	H	3.17	11	1 / 5	18.34	5.05	23.39	38.45	-15.06
825.50	3	QPSK	H	3.14	358	1 / 14	19.53	4.95	24.48	38.45	-13.97
836.50	3	QPSK	H	3.14	358	1 / 14	20.11	5.00	25.11	38.45	-13.34
847.50	3	QPSK	H	3.14	358	1 / 0	19.32	5.05	24.37	38.45	-14.08
825.50	3	16-QAM	H	3.14	358	1 / 14	18.92	4.95	23.87	38.45	-14.58
836.50	3	16-QAM	H	3.14	358	1 / 14	19.34	5.00	24.34	38.45	-14.11
847.50	3	16-QAM	H	3.14	358	1 / 0	18.46	5.05	23.51	38.45	-14.94
826.50	5	QPSK	H	3.17	355	1 / 24	20.11	4.95	25.06	38.45	-13.39
836.50	5	QPSK	H	3.17	355	1 / 24	20.27	5.00	25.27	38.45	-13.18
846.50	5	QPSK	H	3.17	355	1 / 0	20.02	5.04	25.06	38.45	-13.39
826.50	5	16-QAM	H	3.17	355	1 / 24	19.60	4.95	24.55	38.45	-13.90
836.50	5	16-QAM	H	3.17	355	1 / 24	19.24	5.00	24.24	38.45	-14.21
846.50	5	16-QAM	H	3.17	355	1 / 0	18.99	5.04	24.03	38.45	-14.42
829.00	10	QPSK	H	3.17	10	1 / 49	20.06	4.96	25.02	38.45	-13.43
836.50	10	QPSK	H	3.17	10	1 / 49	20.23	5.00	25.23	38.45	-13.22
844.00	10	QPSK	H	3.17	10	1 / 49	20.02	5.03	25.05	38.45	-13.40
829.00	10	16-QAM	H	3.17	10	1 / 49	19.15	4.96	24.11	38.45	-14.34
836.50	10	16-QAM	H	3.17	10	1 / 49	19.35	5.00	24.35	38.45	-14.10
844.00	10	16-QAM	H	3.17	10	1 / 49	19.20	5.03	24.23	38.45	-14.22
831.50	15	QPSK	H	3.11	23	1 / 74	19.63	4.98	24.61	38.45	-13.85
836.50	15	QPSK	H	3.11	23	1 / 0	19.77	5.00	24.77	38.45	-13.68
841.50	15	QPSK	H	3.11	23	1 / 0	19.73	5.02	24.75	38.45	-13.70
831.50	15	16-QAM	H	3.11	23	1 / 74	18.81	4.98	23.79	38.45	-14.67
836.50	15	16-QAM	H	3.11	23	1 / 0	18.74	5.00	23.74	38.45	-14.71
841.50	15	16-QAM	H	3.11	23	1 / 0	18.88	5.02	23.90	38.45	-14.55

Table 7-2. ERP Data (Band 26)

FCC ID: A3LSMJ120P	 FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION) 		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset	Page 76 of 94

Frequency [MHz]	Channel Bandwidth [MHz]	Mod.	Ant. Pol. [H/V]	Antenna Height [m]	Turntable Azimuth [degree]	RB Size/Offset	Substitute Level [dBm]	Ant. Gain [dBi]	EIRP [dBm]	EIRP Limit [dBm]	Margin [dB]
1850.70	1.4	QPSK	H	2.17	52	1 / 5	12.61	9.21	21.82	33.01	-11.19
1882.50	1.4	QPSK	H	2.17	52	1 / 5	13.86	9.28	23.14	33.01	-9.87
1914.30	1.4	QPSK	H	2.17	52	1 / 0	12.23	9.39	21.62	33.01	-11.39
1850.70	1.4	16-QAM	H	2.17	52	1 / 5	11.83	9.21	21.04	33.01	-11.97
1882.50	1.4	16-QAM	H	2.17	52	1 / 5	13.12	9.28	22.40	33.01	-10.61
1914.30	1.4	16-QAM	H	2.17	52	1 / 0	11.32	9.39	20.71	33.01	-12.30
1851.50	3	QPSK	H	2.15	56	1 / 0	13.72	9.21	22.93	33.01	-10.08
1882.50	3	QPSK	H	2.15	56	1 / 0	13.58	9.28	22.86	33.01	-10.15
1913.50	3	QPSK	H	2.15	56	1 / 0	12.01	9.39	21.40	33.01	-11.61
1851.50	3	16-QAM	H	2.15	56	1 / 0	12.97	9.21	22.18	33.01	-10.83
1882.50	3	16-QAM	H	2.15	56	1 / 0	12.80	9.28	22.08	33.01	-10.93
1913.50	3	16-QAM	H	2.15	56	1 / 0	11.35	9.39	20.74	33.01	-12.27
1852.50	5	QPSK	H	2.17	59	1 / 0	12.61	9.22	21.83	33.01	-11.18
1882.50	5	QPSK	H	2.17	59	1 / 24	14.42	9.28	23.70	33.01	-9.31
1912.50	5	QPSK	H	2.17	59	1 / 24	12.77	9.38	22.15	33.01	-10.86
1852.50	5	16-QAM	H	2.17	59	1 / 0	11.87	9.22	21.09	33.01	-11.92
1882.50	5	16-QAM	H	2.17	59	1 / 24	13.56	9.28	22.84	33.01	-10.17
1912.50	5	16-QAM	H	2.17	59	1 / 24	11.68	9.38	21.06	33.01	-11.95
1855.00	10	QPSK	H	2.16	57	1 / 49	12.46	9.22	21.68	33.01	-11.33
1882.50	10	QPSK	H	2.16	57	1 / 49	14.28	9.28	23.56	33.01	-9.45
1910.00	10	QPSK	H	2.16	57	1 / 0	13.54	9.37	22.91	33.01	-10.10
1855.00	10	16-QAM	H	2.16	57	1 / 49	11.86	9.22	21.08	33.01	-11.93
1882.50	10	16-QAM	H	2.16	57	1 / 49	13.62	9.28	22.90	33.01	-10.11
1910.00	10	16-QAM	H	2.16	57	1 / 0	12.82	9.37	22.19	33.01	-10.82
1857.50	15	QPSK	H	2.19	58	1 / 0	13.66	9.23	22.89	33.01	-10.12
1882.50	15	QPSK	H	2.19	58	1 / 74	14.08	9.28	23.36	33.01	-9.65
1907.50	15	QPSK	H	2.19	58	1 / 0	14.02	9.35	23.37	33.01	-9.64
1857.50	15	16-QAM	H	2.19	58	1 / 0	12.78	9.23	22.01	33.01	-11.00
1882.50	15	16-QAM	H	2.19	58	1 / 74	13.26	9.28	22.54	33.01	-10.47
1907.50	15	16-QAM	H	2.19	58	1 / 0	13.06	9.35	22.41	33.01	-10.60
1860.00	20	QPSK	H	2.17	54	1 / 99	13.20	9.23	22.43	33.01	-10.58
1882.50	20	QPSK	H	2.17	54	1 / 99	13.37	9.28	22.65	33.01	-10.36
1905.00	20	QPSK	H	2.17	54	1 / 0	14.38	9.34	23.72	33.01	-9.29
1860.00	20	16-QAM	H	2.17	54	1 / 99	12.26	9.23	21.49	33.01	-11.52
1882.50	20	16-QAM	H	2.17	54	1 / 99	12.59	9.28	21.87	33.01	-11.14
1905.00	20	16-QAM	H	2.17	54	1 / 0	13.36	9.34	22.70	33.01	-10.31

Table 7-3. EIRP Data (Band 25)

FCC ID: A3LSMJ120P	 FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION) 			Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 77 of 94

Frequency [MHz]	Channel Bandwidth [MHz]	Mod.	Ant. Pol. [H/V]	Antenna Height [m]	Turntable Azimuth [degree]	RB Size/Offset	Substitute Level [dBm]	Ant. Gain [dBi]	EIRP [dBm]	EIRP Limit [dBm]	Margin [dB]
2498.50	5	QPSK	H	1.08	27	1 / 0	13.36	8.51	21.87	33.01	-11.14
2593.00	5	QPSK	H	1.08	27	1 / 24	14.77	8.78	23.55	33.01	-9.46
2687.50	5	QPSK	H	1.08	27	1 / 24	14.92	8.93	23.85	33.01	-9.16
2498.50	5	16-QAM	H	1.08	27	1 / 0	12.58	8.51	21.09	33.01	-11.92
2593.00	5	16-QAM	H	1.08	27	1 / 24	13.95	8.78	22.73	33.01	-10.28
2687.50	5	16-QAM	H	1.08	27	1 / 24	14.36	8.93	23.29	33.01	-9.72
2501.00	10	QPSK	H	1.11	24	1 / 49	13.95	8.50	22.45	33.01	-10.56
2593.00	10	QPSK	H	1.11	24	1 / 0	16.15	8.78	24.93	33.01	-8.08
2685.00	10	QPSK	H	1.11	24	1 / 0	14.24	8.93	23.17	33.01	-9.84
2501.00	10	16-QAM	H	1.11	24	1 / 49	13.84	8.50	22.34	33.01	-10.67
2593.00	10	16-QAM	H	1.11	24	1 / 0	15.28	8.78	24.06	33.01	-8.95
2685.00	10	16-QAM	H	1.11	24	1 / 0	13.94	8.93	22.87	33.01	-10.14
2503.50	15	QPSK	H	1.07	31	1 / 74	15.02	8.51	23.53	33.01	-9.48
2593.00	15	QPSK	H	1.07	31	1 / 74	16.26	8.78	25.04	33.01	-7.97
2682.50	15	QPSK	H	1.07	31	1 / 0	15.16	8.92	24.08	33.01	-8.93
2503.50	15	16-QAM	H	1.07	31	1 / 74	14.05	8.51	22.56	33.01	-10.45
2593.00	15	16-QAM	H	1.07	31	1 / 74	15.26	8.78	24.04	33.01	-8.97
2682.50	15	16-QAM	H	1.07	31	1 / 0	14.01	8.92	22.93	33.01	-10.08
2506.00	20	QPSK	H	1.10	25	1 / 99	15.15	8.52	23.67	33.01	-9.34
2593.00	20	QPSK	H	1.10	25	1 / 99	16.17	8.78	24.95	33.01	-8.06
2680.00	20	QPSK	H	1.10	25	1 / 99	15.21	8.92	24.13	33.01	-8.88
2506.00	20	16-QAM	H	1.10	25	1 / 99	14.41	8.52	22.93	33.01	-10.08
2593.00	20	16-QAM	H	1.10	25	1 / 99	15.34	8.78	24.12	33.01	-8.89
2680.00	20	16-QAM	H	1.10	25	1 / 99	16.40	8.92	25.32	33.01	-7.69

Table 7-4. EIRP Data (Band 41)

FCC ID: A3LSMJ120P		FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 78 of 94

7.7 Radiated Spurious Emissions Measurements

\$2.1053 \$22.917(a) \$24.238(a) \$27.53(m)

Test Overview

Radiated spurious emissions measurements are performed using the substitution method described in ANSI/TIA-603-C-2004 with the EUT transmitting into an integral antenna. Measurements on signals operating below 1GHz are performed using vertically and horizontally polarized tuned dipole antennas. Measurements on signals operating above 1GHz are performed using vertically and horizontally polarized broadband horn antennas. All measurements are performed as peak measurements while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies. The antenna polarization measuring the highest is reported.

Test Procedures Used

KDB 971168 D01 v02r02 – Section 5.8

ANSI/TIA-603-C-2004 – Section 2.2.12

Test Settings

1. RBW = 100kHz for emissions below 1GHz and 1MHz for emissions above 1GHz
2. VBW $\geq 3 \times$ RBW
3. Span = 1.5 times the OBW
4. No. of sweep points $\geq 2 \times$ span / RBW
5. Detector = Peak
6. Trace mode = max hold
7. The trace was allowed to stabilize

FCC ID: A3LSMJ120P		FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 79 of 94

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

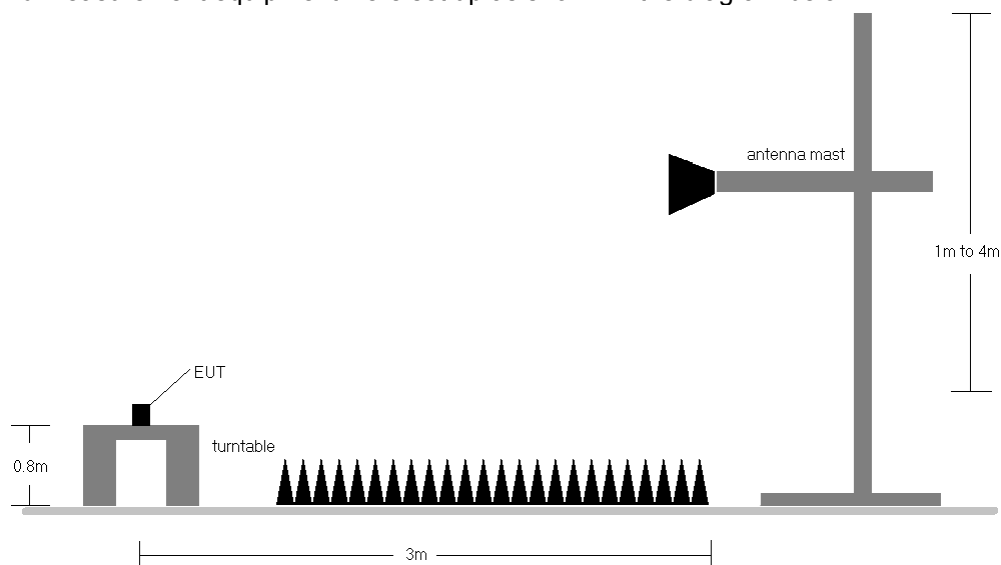


Figure 7-7. Test Instrument & Measurement Setup

Test Notes

- 1) The EUT was tested in three orthogonal planes and in all possible test configurations and positioning. The worst case emissions are reported with the EUT positioning, modulations, RB sizes and offsets, and channel bandwidth configurations shown in the tables below.
- 2) This unit was tested with its standard battery.
- 3) The spectrum is measured from 9kHz to the 10th harmonic of the fundamental frequency of the transmitter. The worst-case emissions are reported.
- 4) Emissions below 18GHz were measured at a 3 meter test distance while emissions above 18GHz were measured at a 1 meter test distance with the application of a distance correction factor.
- 5) The "-" shown in the following RSE tables are used to denote a noise floor measurement.

FCC ID: A3LSMJ120P		FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 80 of 94

OPERATING FREQUENCY: 826.50 MHz
 CHANNEL: 26815
 MEASURED OUTPUT POWER: 25.06 dBm = 0.321 W
 MODULATION SIGNAL: QPSK
 BANDWIDTH: 5.0 MHz
 DISTANCE: 3 meters
 LIMIT: $43 + 10 \log_{10} (W) =$ 38.06 dBc

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [m]	Turntable Azimuth [degree]	Level at Antenna Terminals [dBm]	Substitute Antenna Gain [dBi]	Spurious Emission Level [dBm]	[dBc]
1653.00	H	1.00	245	-52.29	3.60	-48.69	73.8
2479.50	H	1.11	300	-57.97	3.57	-54.40	79.5
3306.00	H	-	-	-58.11	5.68	-52.42	77.5

Table 7-5. Radiated Spurious Data (Band 26 – Low Channel)

OPERATING FREQUENCY: 836.50 MHz
 CHANNEL: 26915
 MEASURED OUTPUT POWER: 25.27 dBm = 0.336 W
 MODULATION SIGNAL: QPSK
 BANDWIDTH: 5.0 MHz
 DISTANCE: 3 meters
 LIMIT: $43 + 10 \log_{10} (W) =$ 38.27 dBc

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [m]	Turntable Azimuth [degree]	Level at Antenna Terminals [dBm]	Substitute Antenna Gain [dBd]	Spurious Emission Level [dBm]	[dBc]
1673.00	H	1.00	200	-54.88	3.53	-51.36	76.6
2509.50	H	1.15	150	-58.09	3.57	-54.52	79.8
3346.00	H	-	-	-59.57	5.78	-53.78	79.1

Table 7-6. Radiated Spurious Data (Band 26 – Mid Channel)

FCC ID: A3LSMJ120P		FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 81 of 94

OPERATING FREQUENCY: 846.50 MHz
 CHANNEL: 27015
 MEASURED OUTPUT POWER: 25.06 dBm = 0.321 W
 MODULATION SIGNAL: QPSK
 BANDWIDTH: 5.0 MHz
 DISTANCE: 3 meters
 LIMIT: $43 + 10 \log_{10} (W) =$ 38.06 dBc

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [m]	Turntable Azimuth [degree]	Level at Antenna Terminals [dBm]	Substitute Antenna Gain [dBd]	Spurious Emission Level [dBm]	[dBc]
1693.00	H	1.45	199	-55.14	3.46	-51.68	76.7
2539.50	H	1.60	310	-57.98	3.63	-54.35	79.4
3386.00	H	-	-	-58.96	5.89	-53.07	78.1

Table 7-7. Radiated Spurious Data (Band 26 – High Channel)

FCC ID: A3LSMJ120P		FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 82 of 94

OPERATING FREQUENCY: 1860.00 MHz
 CHANNEL: 26140
 MEASURED OUTPUT POWER: 22.43 dBm = 0.175 W
 MODULATION SIGNAL: QPSK
 BANDWIDTH: 20.0 MHz
 DISTANCE: 3 meters
 LIMIT: $43 + 10 \log_{10} (W) =$ 35.43 dBc

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [m]	Turntable Azimuth [degree]	Level at Antenna Terminals [dBm]	Substitute Antenna Gain [dBi]	Spurious Emission Level [dBm]	[dBc]
3720.00	H	1.00	245	-50.55	9.39	-41.16	63.6
5580.00	H	1.11	200	-40.79	10.85	-29.94	52.4
7440.00	H	1.00	200	-36.32	10.79	-25.53	48.0
9300.00	H	-	-	-47.29	11.60	-35.70	58.1

Table 7-8. Radiated Spurious Data (Band 25 – Low Channel)

OPERATING FREQUENCY: 1882.50 MHz
 CHANNEL: 26365
 MEASURED OUTPUT POWER: 22.65 dBm = 0.184 W
 MODULATION SIGNAL: QPSK
 BANDWIDTH: 20.0 MHz
 DISTANCE: 3 meters
 LIMIT: $43 + 10 \log_{10} (W) =$ 35.65 dBc

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [m]	Turntable Azimuth [degree]	Level at Antenna Terminals [dBm]	Substitute Antenna Gain [dBi]	Spurious Emission Level [dBm]	[dBc]
3765.00	H	1.35	250	-49.09	9.27	-39.82	62.5
5647.50	H	1.45	260	-45.06	11.06	-34.00	56.7
7530.00	H	1	260	-43.45	10.99	-32.45	55.1
9412.50	H	-	-	-44.47	11.55	-32.92	55.6

Table 7-9. Radiated Spurious Data (Band 25 – Mid Channel)

FCC ID: A3LSMJ120P		FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 83 of 94

OPERATING FREQUENCY: 1905.00 MHz
 CHANNEL: 26590
 MEASURED OUTPUT POWER: 23.72 dBm = 0.236 W
 MODULATION SIGNAL: QPSK
 BANDWIDTH: 20.0 MHz
 DISTANCE: 3 meters
 LIMIT: $43 + 10 \log_{10} (W) =$ 36.72 dBc

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [m]	Turntable Azimuth [degree]	Level at Antenna Terminals [dBm]	Substitute Antenna Gain [dBi]	Spurious Emission Level [dBm]	[dBc]
3810.00	H	1.25	245	-49.06	9.19	-39.88	63.6
5715.00	H	1.35	260	-46.15	11.26	-34.89	58.6
7620.00	H	1.00	125	-47.39	11.16	-36.23	59.9
9525.00	H	-	-	-42.86	11.76	-31.10	54.8

Table 7-10. Radiated Spurious Data (Band 25 – High Channel)

FCC ID: A3LSMJ120P		FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 84 of 94

OPERATING FREQUENCY: 2506.00 MHz
 CHANNEL: 39750
 MEASURED OUTPUT POWER: 22.93 dBm = 0.196 W
 MODULATION SIGNAL: 16-QAM
 BANDWIDTH: 20.0 MHz
 DISTANCE: 3 meters
 LIMIT: $55 + 10 \log_{10}(W)$ 47.93 dBc

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [m]	Turntable Azimuth [degree]	Level at Antenna Terminals [dBm]	Substitute Antenna Gain [dBi]	Spurious Emission Level [dBm]	[dBc]
5012.00	H	1.00	210	-41.57	10.15	-31.42	54.4
7518.00	H	1.00	259	-42.41	12.10	-30.30	53.2
10024.00	H	1.11	300	-44.39	13.26	-31.13	54.1
12530.00	H	1.16	211	-44.99	13.19	-31.80	54.7
15036.00	H	1.07	145	-44.84	14.09	-30.75	53.7
17542.00	H	-	-	-41.95	13.88	-28.07	51.0

Table 7-11. Radiated Spurious Data (Band 41 – Low Channel)

OPERATING FREQUENCY: 2593.00 MHz
 CHANNEL: 40620
 MEASURED OUTPUT POWER: 24.12 dBm = 0.258 W
 MODULATION SIGNAL: 16-QAM
 BANDWIDTH: 20.0 MHz
 DISTANCE: 3 meters
 LIMIT: $55 + 10 \log_{10}(W)$ 49.12 dBc

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [m]	Turntable Azimuth [degree]	Level at Antenna Terminals [dBm]	Substitute Antenna Gain [dBi]	Spurious Emission Level [dBm]	[dBc]
5186.00	H	1.45	210	-38.55	10.33	-28.22	52.3
7779.00	H	1.00	123	-44.70	12.32	-32.38	56.5
10372.00	H	1.23	145	-47.36	13.18	-34.18	58.3
12965.00	H	1.50	200	-45.51	13.43	-32.08	56.2
15558.00	H	-	-	-43.28	13.75	-29.53	53.6

Table 7-12. Radiated Spurious Data (Band 41 – Mid Channel)

FCC ID: A3LSMJ120P		FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 85 of 94

OPERATING FREQUENCY: 2680.00 MHz
 CHANNEL: 41490
 MEASURED OUTPUT POWER: 25.32 dBm = 0.340 W
 MODULATION SIGNAL: 16-QAM
 BANDWIDTH: 20.0 MHz
 DISTANCE: 3 meters
 LIMIT: $55 + 10 \log_{10}(W)$ 50.32 dBc

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [m]	Turntable Azimuth [degree]	Level at Antenna Terminals [dBm]	Substitute Antenna Gain [dBi]	Spurious Emission Level [dBm]	[dBc]
5360.00	H	1.20	150	-50.12	10.37	-39.76	65.1
8040.00	H	1.45	165	-46.20	12.58	-33.62	58.9
10720.00	H	1.60	145	-57.24	12.92	-44.32	69.6
13400.00	H	-	-	-57.08	13.62	-43.46	68.8

Table 7-13. Radiated Spurious Data (Band 41 – High Channel)

FCC ID: A3LSMJ120P		FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 86 of 94

7.8 Frequency Stability / Temperature Variation

\$2.1055 \$22.355 \$24.235 \$27.54

Test Overview and Limit

Frequency stability testing is performed in accordance with the guidelines of ANSI/TIA-603-C-2004. The frequency stability of the transmitter is measured by:

- a.) **Temperature:** The temperature is varied from -30°C to +50°C in 10°C increments using an environmental chamber.
- b.) **Primary Supply Voltage:** The primary supply voltage is varied from 85% to 115% of the nominal value for non hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacturer.

For Part 22, the frequency stability of the transmitter shall be maintained within $\pm 0.00025\%$ (± 2.5 ppm) of the center frequency. For Part 24 and Part 27, the frequency stability shall be sufficient to ensure that the fundamental emission stays within the authorized frequency block.

Test Procedure Used

ANSI/TIA-603-C-2004

Test Settings

1. The carrier frequency of the transmitter is measured at room temperature (20°C to provide a reference).
2. The equipment is turned on in a "standby" condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
3. Frequency measurements are made at 10°C intervals ranging from -30°C to +50°C. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

Test Setup

The EUT was connected via an RF cable to a spectrum analyzer with the EUT placed inside an environmental chamber.

Test Notes

None

FCC ID: A3LSMJ120P		FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 87 of 94

Band 26 Frequency Stability Measurements

§2.1055 §22.355

OPERATING FREQUENCY: 831,500,000 Hz

CHANNEL: 26865

REFERENCE VOLTAGE: 3.80 VDC

DEVIATION LIMIT: ± 0.00025 % or 2.5 ppm

VOLTAGE (%)	POWER (VDC)	TEMP (°C)	FREQUENCY (Hz)	Freq. Dev. (Hz)	Deviation (%)
100 %	3.80	+ 20 (Ref)	831,500,153	153	0.0000184
100 %		- 30	831,500,055	55	0.0000066
100 %		- 20	831,500,151	151	0.0000182
100 %		- 10	831,500,043	43	0.0000052
100 %		0	831,499,867	-133	-0.0000160
100 %		+ 10	831,499,933	-67	-0.0000081
100 %		+ 20	831,499,899	-101	-0.0000121
100 %		+ 30	831,499,974	-26	-0.0000031
100 %		+ 40	831,500,258	258	0.0000310
100 %		+ 50	831,500,028	28	0.0000034
BATT. ENDPOINT	3.40	+ 20	831,499,712	-288	-0.0000346

Table 7-14. Frequency Stability Data (Band 26)

Band 26 Frequency Stability Measurements

§2.1055 §22.355

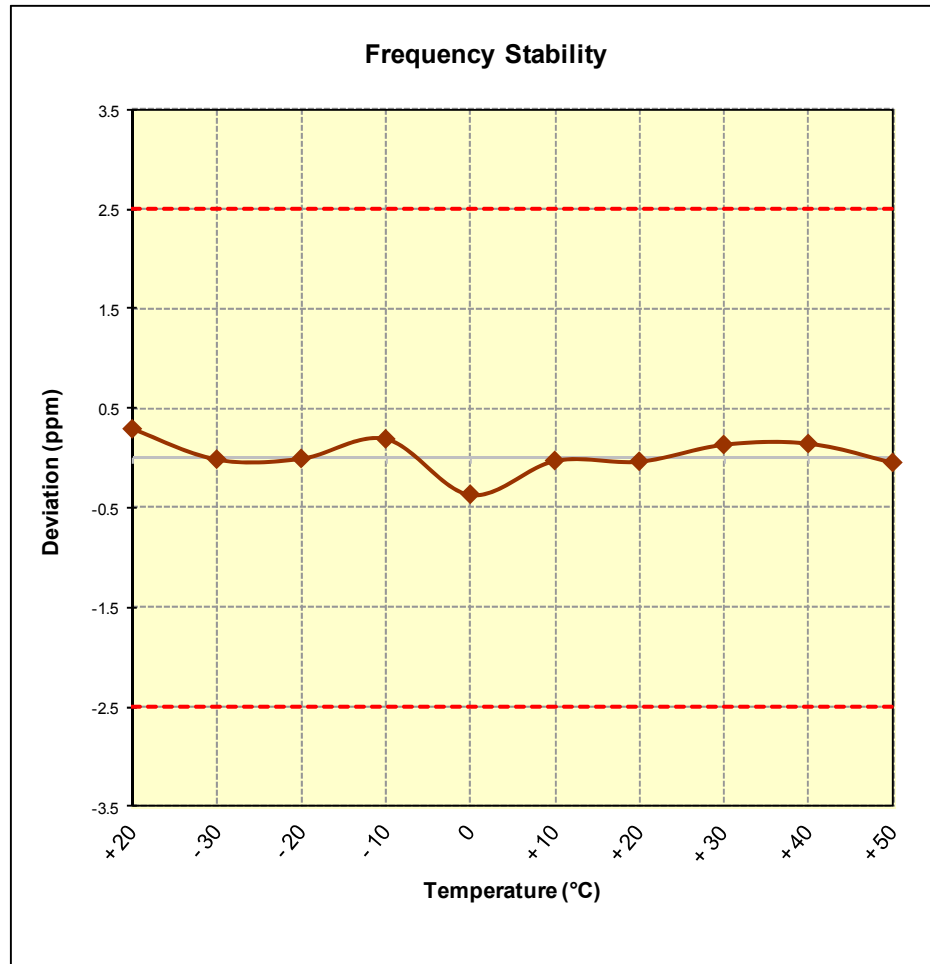


Figure 7-8. Frequency Stability Graph (Band 26)

FCC ID: A3LSMJ120P		FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset		Page 89 of 94

Band 25 Frequency Stability Measurements

§2.1055 §24.235

OPERATING FREQUENCY: 1,882,500,000 Hz
 CHANNEL: 26365
 REFERENCE VOLTAGE: 3.80 VDC

VOLTAGE (%)	POWER (VDC)	TEMP (°C)	FREQUENCY (Hz)	Freq. Dev. (Hz)	Deviation (%)
100 %	3.80	+ 20 (Ref)	1,882,499,813	-187	-0.0000099
100 %		- 30	1,882,500,174	174	0.0000092
100 %		- 20	1,882,500,103	103	0.0000055
100 %		- 10	1,882,499,794	-206	-0.0000109
100 %		0	1,882,499,772	-228	-0.0000121
100 %		+ 10	1,882,499,886	-114	-0.0000061
100 %		+ 20	1,882,499,945	-55	-0.0000029
100 %		+ 30	1,882,499,831	-169	-0.0000090
100 %		+ 40	1,882,500,210	210	0.0000112
100 %		+ 50	1,882,499,873	-127	-0.0000067
BATT. ENDPOINT	3.40	+ 20	1,882,499,987	-13	-0.0000007

Table 7-15. Frequency Stability Data (Band 25)

Note:

Based on the results of the frequency stability test at the center channel the frequency deviation results measured are very small. As such it is determined that the channels at the band edge would remain in-band when the maximum measured frequency deviation noted during the frequency stability tests is applied. Therefore the device is determined to remain operating in band over the temperature and voltage range as tested.

FCC ID: A3LSMJ120P	 FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION) 		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset	Page 90 of 94

Band 25 Frequency Stability Measurements

§2.1055 §24.235

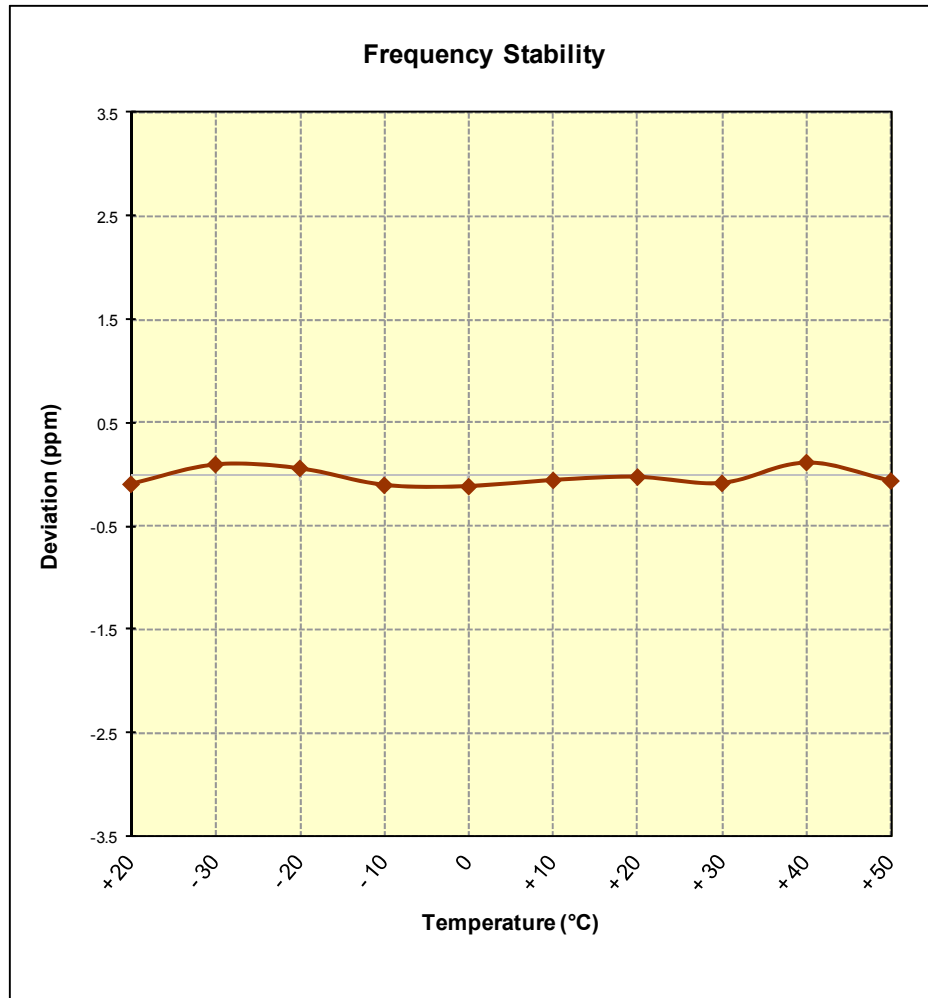


Figure 7-9. Frequency Stability Graph (Band 25)

FCC ID: A3LSMJ120P	 FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		 Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset	Page 91 of 94

Band 41 Frequency Stability Measurements

\$2.1055 \$27.54

OPERATING FREQUENCY: 2,593,000,000 Hz
 CHANNEL: 40620
 REFERENCE VOLTAGE: 3.80 VDC

VOLTAGE (%)	POWER (VDC)	TEMP (°C)	FREQUENCY (Hz)	Freq. Dev. (Hz)	Deviation (%)
100 %	3.80	+ 20 (Ref)	2,592,999,989	-11	-0.0000004
100 %		- 30	2,593,000,402	402	0.0000155
100 %		- 20	2,592,999,979	-21	-0.0000008
100 %		- 10	2,593,000,011	11	0.0000004
100 %		0	2,592,999,977	-23	-0.0000009
100 %		+ 10	2,593,000,301	301	0.0000116
100 %		+ 20	2,592,999,869	-131	-0.0000051
100 %		+ 30	2,592,999,930	-70	-0.0000027
100 %		+ 40	2,592,999,619	-381	-0.0000147
100 %		+ 50	2,593,000,434	434	0.0000167
BATT. ENDPOINT	3.40	+ 20	2,592,999,887	-113	-0.0000044

Table 7-16. Frequency Stability Data (Band 41)

Note:

Based on the results of the frequency stability test at the center channel the frequency deviation results measured are very small. As such it is determined that the channels at the band edge would remain in-band when the maximum measured frequency deviation noted during the frequency stability tests is applied. Therefore the device is determined to remain operating in band over the temperature and voltage range as tested.

FCC ID: A3LSMJ120P	 FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION) 		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset	Page 92 of 94

Band 41 Frequency Stability Measurements

\$2.1055 \$27.54

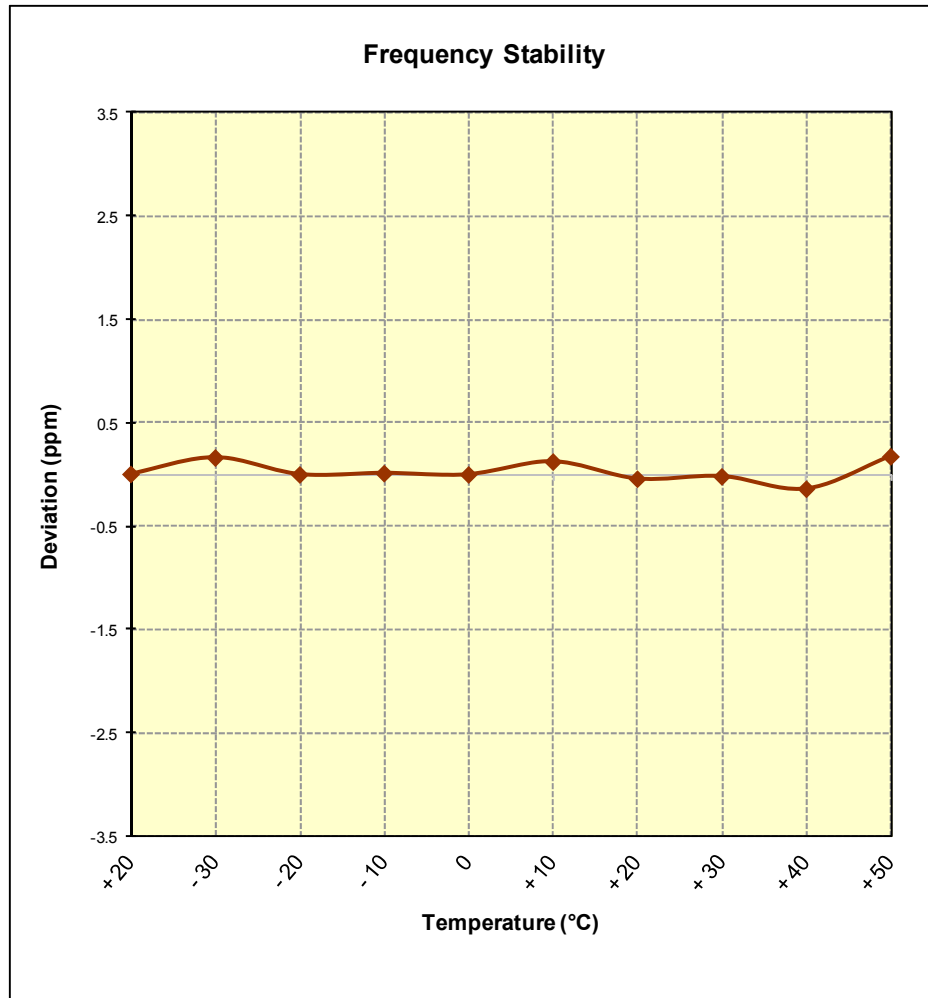


Figure 7-10. Frequency Stability Graph (Band 41)

FCC ID: A3LSMJ120P	 FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		 Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset	Page 93 of 94

8.0 CONCLUSION

The data collected relate only to the item(s) tested and show that the **Samsung Portable Handset FCC ID: A3LSMJ120P** complies with all the requirements of Parts 22, 24, & 27 of the FCC rules for LTE operation only.

FCC ID: A3LSMJ120P		FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1602150336.A3L	Test Dates: 2/15 - 2/26/2016	EUT Type: Portable Handset	Page 94 of 94	